

User Manual DA1458x/DA1468x Production Line Tool

UM-B-041

Abstract

This document describes the DA1458x/DA1468x Production Line Tool (PLT). The various software applications, as well as the PLT hardware are explained in detail. The purpose of this document is to help users to become familiar with the tool and help them use it in a short amount of time.



DA1458x/DA1468x Production Line Tool

Contents

Ab	Abstract1				
Co	ntents	;			
Fig	-igures5				
Tal	bles			7	
1	Term	s and De	finitions	10	
2					
3			eatures		
4	Introd	duction			
5	Hard				
	5.1		e Block Diagram		
	5.2		Circuit Board Layout		
	5.3	PLT Pov	ver Supply		
	5.4		nnector		
	5.5	Data Str	eaming		
	5.6	Golden l	Unit		
		5.6.1	GU Reset		
	5.7	Current I	Measurements		
	5.8	Jumper	Settings	21	
		5.8.1	J26 - Current Measurements		
		5.8.2	J42 - DA1458x OTP Burning Voltage		
		5.8.3	J47, J46 - GU Reset		
		5.8.4	J37 - GU Programming		
	5.9	PLT Fun	ictional Blocks		
6	Softw	/are			
	6.1	Introduct	tion		
	6.2	DA1510	0/1 support		
	6.3		Package Contents		
	6.4		isites		
	6.5	•	Requirements		
	6.6	•	ns		
	6.7		the Code		
	6.8	-	g the Applications		
	6.9		quence		
	0.3	6.9.1	DA1458x Test Sequence		
		6.9.2			
	6 10		DA1468x Test Sequence		
	0.10		eset Signals Operation		
		6.10.1	VBAT Only		
			VBAT On with Reset		
		6.10.3	VBAT as Reset		
	6.11		Memory Data		
		6.11.1	Homekit Hash Setup Code		
		6.11.2	Custom data CSV file format		
	6.12 Golden Unit Scan Test				
	6.13	Creating	Firmware Files under "binaries" Folder		
Us	er Mar	nual	Revision 4.3	03-Feb-2022	

7	Appl	ications.			. 55	
	7.1	Introduction				
	7.2	CFG PLT Application				
		7.2.1	I XML and XSD Files			
		7.2.2	Hardware	Setup	. 58	
			7.2.2.1	Station Identification	. 59	
			7.2.2.2	Device IC	. 59	
			7.2.2.3	Active DUTs	. 59	
			7.2.2.4	DUT COM Ports	. 60	
			7.2.2.5	Golden Unit Port Selection	. 60	
			7.2.2.6	VBAT/Reset Mode	. 61	
		7.2.3 General			. 61	
			7.2.3.1	Statistics	. 61	
			7.2.3.2	Test Options	. 62	
		7.2.4	BD Addres	SSes	. 63	
			7.2.4.1	BD Address Assignment	. 63	
		7.2.5	UART (DA	\1458x)		
			7.2.5.1	UART Boot Pins Setup		
			7.2.5.2	UART Baud Rate	. 66	
			7.2.5.3	UART Programming GPIOs Setup	. 66	
		7.2.6	Test Settir	ngs (DA1458x)	. 67	
			7.2.6.1	XTAL Trim		
			7.2.6.2	RF Tests		
			7.2.6.3	Current Measurement Test		
			7.2.6.4	GPIO/LED Test		
			7.2.6.5	Audio Test	. 76	
			7.2.6.6	Sensor Test		
			7.2.6.7	Custom Test		
			7.2.6.8	Temperature Measurement Test		
			7.2.6.9	Scan Test		
		7.2.7	-	unctions (DA1458x)		
			7.2.7.1	OTP Memory		
			7.2.7.2	SPI Flash Memory		
			7.2.7.3	I2C EEPROM Memory		
			7.2.7.4	Memory read		
		7.2.8	-	leader (DA1458x)		
			7.2.8.1	General		
			7.2.8.2	BD Address		
			7.2.8.3	Custom Memory Data		
		7.2.9	· ·	A1468x)		
			7.2.9.1	UART Boot Pins Setup		
			7.2.9.2	UART Baud Rate		
		7.2.10		ngs (DA1468x)		
			7.2.10.1	XTAL Trim		
			7.2.10.2	RF Tests		
			7.2.10.3	Current Measurement Test		
			7.2.10.4	GPIO/LED Test	. 99	

1.1.4.4.4.4.4	N 4
User	Manual



		7.2.10.5	Sensor Test	. 100
		7.2.10.6	ADC Calibration (DA14681-00 AD only)	. 101
		7.2.10.7	Custom Test	. 102
		7.2.10.8	Temperature Measurement Test	. 102
		7.2.10.9	Scan Test	. 103
	7.2.11	Memory Fu	nctions (DA1468x)	. 104
		7.2.11.1	OTP Memory	. 104
		7.2.11.2	QSPI Flash Memory	. 105
		7.2.11.3	Memory read	. 106
	7.2.12	Memory He	ader (DA1468x)	. 106
		7.2.12.1	OTP Header	. 107
		7.2.12.2	OTP Header - BD Address	. 108
		7.2.12.3	OTP Header - XTAL Trim	. 109
		7.2.12.4	QSPI Header - BD Address	. 110
		7.2.12.5	QSPI Header - XTAL Trim	. 110
		7.2.12.6	Custom Memory Data	. 111
	7.2.13	Debug Setti	ngs	. 112
	7.2.14	Security		. 113
7.3	GUI PLT	Application.		. 113
	7.3.1	GUI PLT Se	ettings	. 116
	7.3.2	Barcode Sc	anner Mode	. 117
		7.3.2.1	Homekit setup code scan example	. 119
	7.3.3	-	e GUI PLT and Executing Tests	
	7.3.4	Debug Con	sole	. 126
	7.3.5	DUT Log Fi	le	. 127
	7.3.6			
7.4		• •		
	7.4.1		ction	
	7.4.2		ands	
	7.4.3	-	CLI and Executing Tests	
	7.4.4	Using CLI C	Commands as Arguments	. 134
8 Exam	nple Usag	е		. 135
Appendi	х А Тор-v	iew of PLT	PCB Version D	. 142
Appendi	x B Electr	ical Schem	atics	. 143
Appendi	x C Hardv	vare Modific	ations PLT Version D	. 147
Appendi	x D Sugge	estions abo	ut Hardware and Cabling	. 149
Appendi	x E Hex2E	Bin		. 152
Appendi	x F Bin2lr	nage		. 154
Appendi	x G Autor	natic GU CC	DM Port Find	. 155
Appendi	x H Impro	ving Cablin	g between PLT and DUTs	. 157
Appendi	Appendix I Settings for DA14583 Internal SPI Flash Memory			
Appendi	Appendix J Settings for DA14586 Internal SPI Flash Memory			
Appendi	Appendix K Honeywell Xenon 1900 Barcode Scanner Setup			
Appendix L Program the Golden Unit SPI Flash Memory				



DA1458x/DA1468x Production Line Tool

Appendix M Connecting a Speaker to the Golden Unit for Audio Test	163
Appendix N FTDI Driver Removal and Installation	164
Appendix O DA1458x DK PRO Motherboard Connection	165
Appendix P DA1468x DK PRO Motherboard Connection	166
Appendix Q Connecting DUT with Battery Supply	167
Appendix R DUT Status Codes	168
Appendix S Golden Unit Status Codes	176
Revision History	179

Figures

Figure 1: Production Line Tool Hardware	14
Figure 2: Production Line Tool Hardware Board Block Diagram	
Figure 3: Top View of the PLT Hardware Board (Version C)	. 16
Figure 4: PLT Hardware Power Connections	
Figure 5: Production Line Tool DUT Connections	
Figure 6: CPLD UART Data Streams	
Figure 7: CPLD XTAL Trim Pulse Data Stream	
Figure 8: CPLD UART Loopback Data Stream	
Figure 9: Golden Unit	
Figure 10: GU Reset Circuit	
Figure 11: VBAT DUT Current Measurement Setup	21
Figure 12: Connections for 'Floating Current' Measurements	21
Figure 12: VDD Control Circuit Schemotic	22
Figure 13: VPP Control Circuit Schematic	
Figure 14: Location of the VPP Jumper J42	
Figure 15: Location of J46 Jumper	
Figure 16: Location of J47 Jumper	
Figure 17: J37 - GU Programming Jumper Schematics	
Figure 18: Location of J37 Jumper	
Figure 19: PLT Functional Blocks	
Figure 20: Production Line Tool Software Block Diagram	
Figure 21: DA1458x/DA1468x PLT Software Package Contents	
Figure 22: DA1458x Test Sequence	
Figure 23: DA1468x Test Sequence	
Figure 24: VBAT only	
Figure 25: VBAT On with Reset	
Figure 26: VBAT as Reset	
Figure 27: Custom Memory Data CSV File Example	
Figure 28: Golden Unit Scan Test	. 49
Figure 29: Golden Unit Scan Test Example Parameters	. 50
Figure 30: Binaries	
Figure 31: "fw_files" Folder Contents	
Figure 32: CFG PLT Startup Screen	. 55
Figure 33: CFG PLT with Erroneous Configuration Parameter	
Figure 34: XSD Schema File Example	. 58
Figure 35: Station Identification	
Figure 36: Device IC	
Figure 37: Active DUTs	
Figure 38: DUT COM Ports	
Figure 39: Golden Unit COM Port	
Figure 40: VBAT/Reset Mode Selection	
Figure 41: Statistics	
Figure 42: Test Options	
Figure 43: BD Address Assignment Figure 44: Example for Load from File Mode	64
Tigure 44. Litample for Load from File Wode	04

User Manual

03-Feb-2022

Figure 45: UART Boot Pins Setup - DA1458x	65
Figure 46: UART Baud Rate - DA1458x	
Figure 47: UART Programming GPIOs Setup - DA1458x	
Figure 48: XTAL Trim - DA1458x	67
Figure 49: Golden Unit RF Tests - DA1458x	
Figure 50: BLE Tester General Settings - DA1458x	69
Figure 51: BLE Tester TX Power - DA1458x	
Figure 52: BLE Tester Frequency Offset - DA1458x	
Figure 53: BLE Tester Modulation Index - DA1458x	71
Figure 54: BLE Tester RX Sensitivity - DA1458x	72
Figure 55: Path Losses per DUT - DA1458x	73
Figure 56: Current Measurement Tests - DA1458x	74
Figure 57: GPIO/LED Tests - DA1458x	
Figure 58: Audio Test	
Figure 59: Sensor Test - DA1458x	
Figure 60: Custom Test - DA1458x	
Figure 61: Temperature Measurement Test - DA1458x	
Figure 62: Scan Test - DA1458x	
Figure 63: OTP Memory - DA1458x	
Figure 64: Different Image per DUT Folder Example	
Figure 65: SPI Flash Memory - DA1458x	
Figure 66: I2C EEPROM Memory - DA1458x	
Figure 67: Memory Read Test - DA1458x	
Figure 68: OTP Header - DA1458x	
Figure 69: BD Address - DA1458x	
Figure 70: Custom Memory Data - DA1458x	88
Figure 71: UART Boot Pins Setup - DA1468x	89
Figure 72: UART Baud Rate - DA1468x	
Figure 73: XTAL Trim - DA1468x	
Figure 74: Golden Unit RF Tests - DA1468x	
Figure 75: BLE Tester General Settings - DA1468x	
Figure 76: BLE Tester TX Power - DA1468x	93
Figure 77: BLE Tester Frequency Offset - DA1468x	94
Figure 78: BLE Tester Modulation Index - DA1468x	
Figure 79: BLE Tester RX Sensitivity - DA1468x	
Figure 80: Path Losses per DUT - DA1468x	
Figure 81: Current Measurement Tests - DA1468x	. 97
Figure 82: GPIO/LED Tests - DA1468x	
Figure 83: Sensor Test - DA1468x	
Figure 84: ADC Calibration - DA14681-00 (AD)	100
Figure 85: Custom Test - DA1468x	
Figure 86: Temperature Measurement Test - DA1468x	
Figure 87: Scan Test - DA1468x	
Figure 88: OTP Memory - DA1468x	
Figure 89: QSPI Flash - DA1468x	
Figure 90: Memory Read Test - DA1468x	
Figure 91: OTP Header - DA1468x	107
Figure 92: OTP Header BD Address - DA1468x	
Figure 93: OTP Header XTAL Trim - DA1468x	
Figure 94: QSPI Header BD Address - DA1468x	
Figure 95: QSPI Header XTAL Trim - DA14681-00 only	
Figure 96: Custom Memory Data - DA1468x	
Figure 97: Debug Settings	112
Figure 98: Security	
Figure 99: GUI PLT Main Screen	
Figure 100: GUI PLT Settings	116
Figure 101: Barcode Scan Option in GUI PLT	118
Figure 102: Barcode Scanner Controls	118
Figure 103: Barcode Scan - BD Address Assignment	118



DA1458x/DA1468x Production Line Tool

Figure 104: GUI PLT during Testing (1 of 2)	124
Figure 105: GUI PLT During Testing (2 of 2)	125
Figure 106: GUI PLT Tests Finished	
Figure 107: GUI PLT Retry Failed DUTs Message	126
Figure 108: Debug Console	
Figure 109: DUT Log File	
Figure 110: CSV File	128
Figure 111: CLI Software Start Screen	129
Figure 112: CLI PLT Print Settings (x Command)	131
Figure 113: CLI PLT DUT COM Port Enumeration ('p' Command)	132
Figure 114: CLI PLT Read and Compare BD Address in QSPI ('v' Command)	133
Figure 115: CLI PLT During Testing	133
Figure 116: CLI PLT Testing Finished	133
Figure 117: CLI with Commands as Arguments	
Figure 118: Top-view of PLT PCB Version D	
Figure 119: VBAT and VPP Control from CPLD	
Figure 120: CPLD DUT UART Connections	
Figure 121: CPLD FTDI and GU Control Connections	144
Figure 122: FTDI Chip for USB UART to DUTs 1, 2, 3 and 4	144
Figure 123: Quad USB HUB	145
Figure 124: Golden Unit - Dedicated USB Port and FTDI Chip	145
Figure 125: Golden Unit - GU LED and SPI Flash Memory	146
Figure 126: VBAT_DUT and VDDIO Supplies	
Figure 127: GU Supply and VPP Generation	146
Figure 128: DA14580_RD_tester Version D	
Figure 129: Jumper J47 Added Next to Golden Unit Socket	147
Figure 130: R365 (10 kΩ) Added Next to Reset Button	147
Figure 131: R365, J47 and RESET Shown in Electrical Schematic	148
Figure 132: Possible Solution of Antenna on Cable and Fixed Radius of DUTs to Antenna	149
Figure 133: Possible Solution of Antenna on Cable and DUTs Put in Line	
Figure 134: Example Locations and RSSI Readouts of Horizontal Antenna	150
Figure 135: Hex2Bin Example Directory with Files	152
Figure 136: Hex2Bin.exe Example	
Figure 137: Bin2Image Example Directory with Files	
Figure 138: Bin2Image Example	154
Figure 139: Example of Twisted Pair Cable with 4 Pairs and Ferrite	157
Figure 140: Location of Pull-Down Resistors	
Figure 141: Anti-Ringing Solution	
Figure 142: Pin Assignment of DA14583 - QFN40	159
Figure 143: Pin Assignment of DA14586 - QFN40	
Figure 144: Speaker Connection for Audio Test.	163

Tables

Table 1: DA1458x_DA1468x_PLT_v4.2 added features Table 2: Power Supply Requirements Table 3: PLT Connections to Applications	. 17 . 17
Table 4: Jumpers	
Table 5: PLT User Interface Application Executables	
Table 6: Executables Folder Description	
Table 7: Production Line Tool Prerequisites	
Table 8: Minimum System Requirements	
Table 9: Opening the PLT Visual Studio 2015 Express Source Code Solution	. 31
Table 10: DA1458x_DA1468x_CFG_PLT.exe Application Execution	. 32
Table 11: DA1458x_DA1468x_GUI_PLT.exe Application Execution	. 35
Table 12: DA1458x_DA1468x_CLI_PLT.exe Application Execution	. 36
Table 13: DA1458x Test Sequence	
Table 14: DA1468x Test Sequence	

User Manual

03-Feb-2022



DA1458x/DA1468x Production Line Tool

Table 15: Custom Memory Data Input Modes	10
Table 16: Homekit Setup Code Format	47
Table 17: Homekit Setup Code Checksum Algorithm	47
Table 18: CFG PLT Main Menu Options	56
Table 19: CFG PLT Bottom Strip Options	
Table 20: XML File Parts	
Table 21: Station Identification	
Table 22: Device IC	
Table 23: Active DUTs.	
Table 24: DUT COM Ports	
Table 25: Golden Unit COM Port	
Table 26: VBAT/Reset Mode	61
Table 27: Statistics	61
Table 28: Test Options	62
Table 29: BD Address Assignment - Standard Mode	64
Table 30: BD Address Assignment Options - Range Mode	
Table 31: BD Address Assignment Options - Load from File Mode	
Table 32: BD Address Assignment Options - Scan Mode	
Table 33: UART TX-RX Pins - DA1458x	
Table 34: UART Baud Rate - DA1458x	
Table 35: UART Programming GPIOs Setup - DA1458x	67
Table 36: XTAL Trim - DA1458x	
Table 37: Golden Unit RF Tests - DA1458x	68
Table 38: BLE Tester General Settings - DA1458x	
Table 39: BLE Tester TX Power - DA1458x	
Table 40: BLE Tester Frequency Offset - DA1458x	
Table 41: BLE Tester Modulation Index - DA1458x	
Table 42: BLE Tester RX Sensitivity - DA1458x	72
Table 43: Path Losses per DUT from RF Tests DA1458x Options	73
Table 44: Current Measurement Tests - DA1458x	74
Table 45: Current Measurement for each Sleep State	75
Table 46: GPIO/LED Tests - DA1458x	
Table 40. GFT0/LED Tests - DA 1430X	76
Table 47: Audio Test	76
Table 47: Audio Test Table 48: Sensor Tests - DA1458x	76 77
Table 47: Audio Test Table 48: Sensor Tests - DA1458x Table 49: Custom Tests - DA1458x	76 77 78
Table 47: Audio Test Table 48: Sensor Tests - DA1458x Table 49: Custom Tests - DA1458x Table 50: Temperature Measurement Test - DA1458x	76 77 78 78
Table 47: Audio TestTable 48: Sensor Tests - DA1458xTable 49: Custom Tests - DA1458xTable 50: Temperature Measurement Test - DA1458xTable 51: Scan Test DA1458x Options	76 77 78 78 79
Table 47: Audio TestTable 48: Sensor Tests - DA1458xTable 49: Custom Tests - DA1458xTable 50: Temperature Measurement Test - DA1458xTable 51: Scan Test DA1458x OptionsTable 52: OTP Memory - DA1458x	76 77 78 78 79 80
Table 47: Audio Test Table 48: Sensor Tests - DA1458x Table 49: Custom Tests - DA1458x Table 50: Temperature Measurement Test - DA1458x Table 51: Scan Test DA1458x Options Table 52: OTP Memory - DA1458x Table 53: SPI Pin Setup - DA1458x	76 77 78 78 79 80 81
Table 47: Audio Test Table 48: Sensor Tests - DA1458x Table 49: Custom Tests - DA1458x Table 50: Temperature Measurement Test - DA1458x Table 51: Scan Test DA1458x Options Table 52: OTP Memory - DA1458x Table 53: SPI Pin Setup - DA1458x	76 77 78 78 79 80 81
Table 47: Audio TestTable 48: Sensor Tests - DA1458xTable 49: Custom Tests - DA1458xTable 50: Temperature Measurement Test - DA1458xTable 51: Scan Test DA1458x OptionsTable 52: OTP Memory - DA1458xTable 53: SPI Pin Setup - DA1458xTable 54: SPI Flash Erase - DA1458x	76 77 78 78 79 80 81 82
Table 47: Audio TestTable 48: Sensor Tests - DA1458xTable 49: Custom Tests - DA1458xTable 50: Temperature Measurement Test - DA1458xTable 51: Scan Test DA1458x OptionsTable 52: OTP Memory - DA1458xTable 53: SPI Pin Setup - DA1458xTable 54: SPI Flash Erase - DA1458xTable 55: SPI Flash Image Write - DA1458x	76 77 78 78 79 80 81 82 82
Table 47: Audio TestTable 48: Sensor Tests - DA1458xTable 49: Custom Tests - DA1458xTable 50: Temperature Measurement Test - DA1458xTable 51: Scan Test DA1458x OptionsTable 52: OTP Memory - DA1458xTable 53: SPI Pin Setup - DA1458xTable 54: SPI Flash Erase - DA1458xTable 55: SPI Flash Image Write - DA1458xTable 56: I2C Pin Setup - DA1458x	76 77 78 78 79 80 81 82 82 82 83
Table 47: Audio TestTable 48: Sensor Tests - DA1458xTable 49: Custom Tests - DA1458xTable 50: Temperature Measurement Test - DA1458xTable 51: Scan Test DA1458x OptionsTable 52: OTP Memory - DA1458xTable 53: SPI Pin Setup - DA1458xTable 54: SPI Flash Erase - DA1458xTable 55: SPI Flash Image Write - DA1458xTable 56: I2C Pin Setup - DA1458xTable 57: I2C EEPROM Image Write - DA1458x	76 77 78 78 79 80 81 82 82 82 83 83
Table 47: Audio TestTable 48: Sensor Tests - DA1458xTable 49: Custom Tests - DA1458xTable 50: Temperature Measurement Test - DA1458xTable 51: Scan Test DA1458x OptionsTable 52: OTP Memory - DA1458xTable 53: SPI Pin Setup - DA1458xTable 54: SPI Flash Erase - DA1458xTable 55: SPI Flash Image Write - DA1458xTable 56: I2C Pin Setup - DA1458xTable 57: I2C EEPROM Image Write - DA1458xTable 58: Memory Read Test - DA1458x	76 77 78 78 79 80 81 82 82 83 83 84
Table 47: Audio TestTable 48: Sensor Tests - DA1458xTable 49: Custom Tests - DA1458xTable 50: Temperature Measurement Test - DA1458xTable 51: Scan Test DA1458x OptionsTable 52: OTP Memory - DA1458xTable 53: SPI Pin Setup - DA1458xTable 54: SPI Flash Erase - DA1458xTable 55: SPI Flash Image Write - DA1458xTable 56: I2C Pin Setup - DA1458xTable 57: I2C EEPROM Image Write - DA1458xTable 58: Memory Read Test - DA1458xTable 59: OTP Header - DA1458x	76 77 78 78 79 80 81 82 82 83 83 84 85
Table 47: Audio TestTable 48: Sensor Tests - DA1458xTable 49: Custom Tests - DA1458xTable 50: Temperature Measurement Test - DA1458xTable 51: Scan Test DA1458x OptionsTable 52: OTP Memory - DA1458xTable 53: SPI Pin Setup - DA1458xTable 54: SPI Flash Erase - DA1458xTable 55: SPI Flash Image Write - DA1458xTable 56: I2C Pin Setup - DA1458xTable 57: I2C EEPROM Image Write - DA1458xTable 58: Memory Read Test - DA1458xTable 59: OTP Header - DA1458xTable 59: OTP Header - DA1458x	76 77 78 78 79 80 81 82 83 83 83 83 84 85 87
Table 47: Audio TestTable 48: Sensor Tests - DA1458xTable 49: Custom Tests - DA1458xTable 50: Temperature Measurement Test - DA1458xTable 51: Scan Test DA1458x OptionsTable 52: OTP Memory - DA1458xTable 53: SPI Pin Setup - DA1458xTable 54: SPI Flash Erase - DA1458xTable 55: SPI Flash Image Write - DA1458xTable 56: I2C Pin Setup - DA1458xTable 57: I2C EEPROM Image Write - DA1458xTable 58: Memory Read Test - DA1458xTable 59: OTP Header - DA1458xTable 60: BD Address - DA1458xTable 61: Custom Memory Data - DA1458x	76 77 78 78 79 80 81 82 82 82 83 83 83 84 85 87 88
Table 47: Audio TestTable 48: Sensor Tests - DA1458xTable 49: Custom Tests - DA1458xTable 50: Temperature Measurement Test - DA1458xTable 51: Scan Test DA1458x OptionsTable 52: OTP Memory - DA1458xTable 53: SPI Pin Setup - DA1458xTable 54: SPI Flash Erase - DA1458xTable 55: SPI Flash Image Write - DA1458xTable 56: I2C Pin Setup - DA1458xTable 57: I2C EEPROM Image Write - DA1458xTable 58: Memory Read Test - DA1458xTable 59: OTP Header - DA1458xTable 59: OTP Header - DA1458xTable 60: BD Address - DA1458xTable 61: Custom Memory Data - DA1458xTable 62: UART TX-RX Pins - DA1468x	76 77 78 79 80 81 82 82 82 83 83 83 84 85 87 88 89
Table 47: Audio TestTable 48: Sensor Tests - DA1458xTable 49: Custom Tests - DA1458xTable 50: Temperature Measurement Test - DA1458xTable 51: Scan Test DA1458x OptionsTable 52: OTP Memory - DA1458xTable 53: SPI Pin Setup - DA1458xTable 54: SPI Flash Erase - DA1458xTable 55: SPI Flash Image Write - DA1458xTable 56: I2C Pin Setup - DA1458xTable 57: I2C EEPROM Image Write - DA1458xTable 58: Memory Read Test - DA1458xTable 59: OTP Header - DA1458xTable 60: BD Address - DA1458xTable 61: Custom Memory Data - DA1458x	76 77 78 79 80 81 82 82 82 83 83 83 84 85 87 88 89
Table 47: Audio TestTable 48: Sensor Tests - DA1458xTable 49: Custom Tests - DA1458xTable 50: Temperature Measurement Test - DA1458xTable 51: Scan Test DA1458x OptionsTable 52: OTP Memory - DA1458xTable 53: SPI Pin Setup - DA1458xTable 54: SPI Flash Erase - DA1458xTable 55: SPI Flash Image Write - DA1458xTable 56: I2C Pin Setup - DA1458xTable 57: I2C EEPROM Image Write - DA1458xTable 58: Memory Read Test - DA1458xTable 59: OTP Header - DA1458xTable 59: OTP Header - DA1458xTable 60: BD Address - DA1458xTable 61: Custom Memory Data - DA1458xTable 62: UART TX-RX Pins - DA1468x	76 77 78 79 80 81 82 82 82 83 83 83 83 84 85 87 88 89 90
Table 47: Audio TestTable 48: Sensor Tests - DA1458xTable 49: Custom Tests - DA1458xTable 50: Temperature Measurement Test - DA1458xTable 51: Scan Test DA1458x OptionsTable 52: OTP Memory - DA1458xTable 53: SPI Pin Setup - DA1458xTable 54: SPI Flash Erase - DA1458xTable 55: SPI Flash Image Write - DA1458xTable 56: I2C Pin Setup - DA1458xTable 57: I2C EEPROM Image Write - DA1458xTable 58: Memory Read Test - DA1458xTable 59: OTP Header - DA1458xTable 59: OTP Header - DA1458xTable 60: BD Address - DA1458xTable 61: Custom Memory Data - DA1458xTable 62: UART TX-RX Pins - DA1468xTable 63: UART Baud Rate - DA1468x	76 77 78 79 80 81 82 82 82 83 83 83 84 85 87 88 89 90 90
Table 47: Audio TestTable 48: Sensor Tests - DA1458xTable 49: Custom Tests - DA1458xTable 50: Temperature Measurement Test - DA1458xTable 51: Scan Test DA1458x OptionsTable 52: OTP Memory - DA1458xTable 53: SPI Pin Setup - DA1458xTable 54: SPI Flash Erase - DA1458xTable 55: SPI Flash Image Write - DA1458xTable 56: I2C Pin Setup - DA1458xTable 57: I2C EEPROM Image Write - DA1458xTable 58: Memory Read Test - DA1458xTable 59: OTP Header - DA1458xTable 60: BD Address - DA1458xTable 61: Custom Memory Data - DA1458xTable 62: UART TX-RX Pins - DA1468xTable 63: UART Baud Rate - DA1468xTable 64: XTAL Trim - DA1468xTable 65: Golden Unit RF Tests - DA1468x	76 77 78 79 80 81 82 82 82 83 83 83 83 84 85 87 88 89 90 90 91
Table 47: Audio TestTable 48: Sensor Tests - DA1458xTable 49: Custom Tests - DA1458xTable 50: Temperature Measurement Test - DA1458xTable 51: Scan Test DA1458x OptionsTable 52: OTP Memory - DA1458xTable 53: SPI Pin Setup - DA1458xTable 54: SPI Flash Erase - DA1458xTable 55: SPI Flash Image Write - DA1458xTable 56: I2C Pin Setup - DA1458xTable 57: I2C EEPROM Image Write - DA1458xTable 58: Memory Read Test - DA1458xTable 59: OTP Header - DA1458xTable 60: BD Address - DA1458xTable 61: Custom Memory Data - DA1458xTable 62: UART TX-RX Pins - DA1468xTable 63: UART Baud Rate - DA1468xTable 64: XTAL Trim - DA1468xTable 65: Golden Unit RF Tests - DA1468xTable 66: BLE Tester General Settings - DA1468x	76 77 78 79 80 81 82 82 82 83 83 83 83 85 87 87 89 90 90 91 92
Table 47: Audio TestTable 48: Sensor Tests - DA1458xTable 49: Custom Tests - DA1458xTable 50: Temperature Measurement Test - DA1458xTable 51: Scan Test DA1458x OptionsTable 52: OTP Memory - DA1458xTable 53: SPI Pin Setup - DA1458xTable 54: SPI Flash Erase - DA1458xTable 55: SPI Flash Image Write - DA1458xTable 56: I2C Pin Setup - DA1458xTable 57: I2C EEPROM Image Write - DA1458xTable 58: Memory Read Test - DA1458xTable 59: OTP Header - DA1458xTable 59: OTP Header - DA1458xTable 60: BD Address - DA1458xTable 61: Custom Memory Data - DA1458xTable 62: UART TX-RX Pins - DA1468xTable 63: UART Baud Rate - DA1468xTable 64: XTAL Trim - DA1468xTable 65: Golden Unit RF Tests - DA1468xTable 65: BLE Tester General Settings - DA1468x	76 77 78 78 79 80 81 82 83 83 83 83 83 83 84 85 87 90 90 90 91 92 93
Table 47: Audio TestTable 48: Sensor Tests - DA1458xTable 49: Custom Tests - DA1458xTable 50: Temperature Measurement Test - DA1458xTable 51: Scan Test DA1458x OptionsTable 52: OTP Memory - DA1458xTable 53: SPI Pin Setup - DA1458xTable 54: SPI Flash Erase - DA1458xTable 55: SPI Flash Image Write - DA1458xTable 56: I2C Pin Setup - DA1458xTable 56: I2C Pin Setup - DA1458xTable 57: I2C EEPROM Image Write - DA1458xTable 58: Memory Read Test - DA1458xTable 59: OTP Header - DA1458xTable 60: BD Address - DA1458xTable 61: Custom Memory Data - DA1458xTable 62: UART TX-RX Pins - DA1468xTable 63: UART Baud Rate - DA1468xTable 64: XTAL Trim - DA1468xTable 65: Golden Unit RF Tests - DA1468xTable 65: BLE Tester TX Power - DA1468xTable 66: BLE Tester Frequency Offset - DA1468x	76 77 78 79 80 81 82 83 83 83 83 83 84 85 87 87 90 90 91 92 93 94
Table 47: Audio Test Table 48: Sensor Tests - DA1458x Table 49: Custom Tests - DA1458x Table 50: Temperature Measurement Test - DA1458x Table 51: Scan Test DA1458x Options Table 51: Scan Test DA1458x Options Table 52: OTP Memory - DA1458x Table 53: SPI Pin Setup - DA1458x Table 54: SPI Flash Erase - DA1458x Table 55: SPI Flash Image Write - DA1458x Table 56: I2C Pin Setup - DA1458x Table 57: I2C EEPROM Image Write - DA1458x Table 58: Memory Read Test - DA1458x Table 59: OTP Header - DA1458x Table 59: OTP Header - DA1458x Table 60: BD Address - DA1458x Table 61: Custom Memory Data - DA1458x Table 61: Custom Memory Data - DA1458x Table 63: UART TX-RX Pins - DA1468x Table 64: XTAL Trim - DA1468x Table 65: Golden Unit RF Tests - DA1468x Table 67: BLE Tester General Settings - DA1468x Table 67: BLE Tester TX Power - DA1468x Table 67: BLE Tester Frequency Offset - DA1468x Table 68: BLE Tester Frequency Offset - DA1468x Table 69: BLE Tester Modulation Index - DA1468x	76 77 78 79 80 81 82 83 83 83 83 83 83 84 85 87 87 90 90 91 92 93 94 95
Table 47: Audio TestTable 48: Sensor Tests - DA1458xTable 49: Custom Tests - DA1458xTable 50: Temperature Measurement Test - DA1458xTable 51: Scan Test DA1458x OptionsTable 52: OTP Memory - DA1458xTable 53: SPI Pin Setup - DA1458xTable 54: SPI Flash Erase - DA1458xTable 55: SPI Flash Image Write - DA1458xTable 56: I2C Pin Setup - DA1458xTable 57: I2C EEPROM Image Write - DA1458xTable 58: Memory Read Test - DA1458xTable 59: OTP Header - DA1458xTable 59: OTP Header - DA1458xTable 60: BD Address - DA1458xTable 61: Custom Memory Data - DA1458xTable 63: UART TX-RX Pins - DA1468xTable 64: XTAL Trim - DA1468xTable 65: Golden Unit RF Tests - DA1468xTable 66: BLE Tester General Settings - DA1468xTable 66: BLE Tester Frequency Offset - DA1468xTable 67: BLE Tester RX Sensitivity - DA1468xTable 68: BLE Tester RX Sensitivity - DA1468x	76 77 78 79 80 81 82 82 83 83 83 83 83 84 85 87 87 90 90 90 91 92 93 94 95 96
Table 47: Audio TestTable 48: Sensor Tests - DA1458xTable 49: Custom Tests - DA1458xTable 50: Temperature Measurement Test - DA1458xTable 51: Scan Test DA1458x OptionsTable 52: OTP Memory - DA1458xTable 53: SPI Pin Setup - DA1458xTable 54: SPI Flash Erase - DA1458xTable 55: SPI Flash Image Write - DA1458xTable 56: I2C Pin Setup - DA1458xTable 56: I2C Pin Setup - DA1458xTable 57: I2C EEPROM Image Write - DA1458xTable 58: Memory Read Test - DA1458xTable 59: OTP Header - DA1458xTable 60: BD Address - DA1458xTable 61: Custom Memory Data - DA1458xTable 62: UART TX-RX Pins - DA1468xTable 63: UART Baud Rate - DA1468xTable 64: XTAL Trim - DA1468xTable 65: Golden Unit RF Tests - DA1468xTable 66: BLE Tester General Settings - DA1468xTable 67: BLE Tester TX Power - DA1468xTable 68: BLE Tester Frequency Offset - DA1468xTable 69: BLE Tester Requency Offset - DA1468xTable 69: BLE Tester Repencer Offset - DA1468xTable 67: BLE Tester Repencer Offset - DA1468xTable 67: BLE Tester Repencer Offset - DA1468xTable 68: BLE Tester Repencer Offset - DA1468xTable 69: BLE Tester Repencer Offset - DA1468xTable 67: BLE Tester Repencer Offset - DA1468xTable 67: BLE Tester Repencer Offset - DA1468xTable 69: BLE Tester Repencer Offset - DA1468xTable 69: BLE Tester RX Sensi	76 77 78 79 80 81 82 82 82 83 83 83 83 84 85 87 87 90 90 90 91 92 93 94 95 97
Table 47: Audio TestTable 48: Sensor Tests - DA1458xTable 49: Custom Tests - DA1458xTable 50: Temperature Measurement Test - DA1458xTable 51: Scan Test DA1458x OptionsTable 52: OTP Memory - DA1458xTable 53: SPI Pin Setup - DA1458xTable 54: SPI Flash Erase - DA1458xTable 55: SPI Flash Image Write - DA1458xTable 56: I2C Pin Setup - DA1458xTable 57: I2C EEPROM Image Write - DA1458xTable 58: Memory Read Test - DA1458xTable 59: OTP Header - DA1458xTable 59: OTP Header - DA1458xTable 60: BD Address - DA1458xTable 61: Custom Memory Data - DA1458xTable 63: UART TX-RX Pins - DA1468xTable 64: XTAL Trim - DA1468xTable 65: Golden Unit RF Tests - DA1468xTable 66: BLE Tester General Settings - DA1468xTable 66: BLE Tester Frequency Offset - DA1468xTable 67: BLE Tester RX Sensitivity - DA1468xTable 68: BLE Tester RX Sensitivity - DA1468x	76 77 78 79 80 81 82 82 82 83 83 83 84 85 87 87 90 90 90 91 92 93 94 95 96 97 98

lleor	Manual
USCI	Manual

Revision 4.3

Table 74: GPIO/LED Tests - DA1468x	99
Table 75: Sensor Tests - DA1468x	100
Table 76: ADC Calibration - DA14681-00 (AD)	101
Table 77: Custom Tests DA1468x Options	
Table 78: Temperature Measurement Test - DA1468x	102
Table 79: Scan Test DA1468x Options	103
Table 80: OTP Memory - DA1468x	104
Table 81: QSPI Flash Erase - DA1468x	
Table 82: QSPI Flash Image Write - DA1468x	105
Table 83: Memory Read Test - DA1468x	106
Table 84: General - OTP Header DA1468x Options	
Table 85: OTP Header BD Address - DA1468x	
Table 86: OTP Header XTAL Trim - DA1468x	
Table 87: QSPI Header BD Address - DA1468x	
Table 88: QSPI Header XTAL Trim - DA14681-00 only	
Table 89: Custom Memory Data - DA1468x	111
Table 90: Debug Settings	
Table 91: Security Options	
Table 92: GUI PLT Main Screen Description	114
Table 93: GUI PLT Settings	
Table 94: Homekit setup code scan example	
Table 95: CLI Commands	
Table 96: DA14580 PLT Example Usage	135
Table 97: RF Test RSSI Results	150
Table 98: FTDI "DialogSemi" Serial Number	
Table 99: DA14583 Internal SPI Flash Connections	
Table 100: DA14586 Internal SPI Flash Connections	160



1 Terms and Definitions

User Manual	Revision 4.3	03-Feb-2022
USB	Universal Serial Bus	
UI	User Interface	
UART	Universal Asynchronous Receiver/Transmitter	
ТХ	Transmit	
SW	Software	
SPI	Serial Peripheral Interface	
SDK	Software Development Kit	
SoC	System on Chip	
SCPI	Standard Commands for Programmable Instruments	
RX	Receive	
RF	Radio Frequency	
RCX	Resistor Crystal Oscillator	
RAM	Random Access Memory	
PLTD	Production Line Tool DLL	
PLT	Production Line Tool	
PCB	Printed circuit board	
PC	Personal Computer	
OTP	One Time Programmable (memory)	
OS	Operating System	
JTAG	Joint Test Action Group	
I2C	Inter-Integrated Circuit	
IDE	Integrated Development Environment	
IC	Integrated Circuit	
HW	hardware	
Hex	Firmware file in ASCII format	
GUI	Graphical User Interface	
GU	Golden Unit	
GPIO	General Purpose Input-Output	
FTDI	Future Technology Devices International Ltd.	
.exe	Electrically Elasable Programmable Read-Only Memory	
EEPROM	Electrically Erasable Programmable Read-Only Memory	
DVM	Digital Voltage Meter	
DUT	Direct Test Mode (as specified by the BLE Core standard) Device Under Test	
DTM	Digital Multimeter Direct Test Mode (as specified by the BLE Core standard)	
DMA	Digital Multimeter	
DLL DMA	Dynamic Link Library Direct Memory Access	
DLL	•	
CPLD CSV	Complex Programmable Logic Device Comma Separated Values	
	Communication port	
CLI	Command Line Interface	
CFG	Configuration	
BLE	Bluetooth low energy	
.bin	Firmware files in binary format	
BD	Bluetooth Device	
API	Application Programming Interface	



- VISA Virtual Instrument Software Architecture
- VPP Programming supply voltage (pin)
- XML Extensible Markup Language
- XTAL Crystal
- XSD XML Schema Definition

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3 New version features

This manual explains the usage of the 16 channel DA1458x/DA1468x Production Line Tool (PLT). It refers to the DA1458x_DA1468x_PLT_v4.2 software release, which compared to DA1458x_DA1468x_PLT_v4.1 has the added features illustrated in Table 1.

Table 1: DA1458x_DA1468x_	PLT_v4.2 added features
---------------------------	-------------------------

#	Features	Description
1	DA14682/3, DA15100/1 are now supported.	Supports the new DA14682/3 and DA15100/1 chipset with all the memory and production tests that the DA1681 (AE) supports (for the DA15100/1 devices only the BLE path is supported).
2	DA14585/586 audio testing.	DA1485/6 devices now support audio testing.
3	Production test firmware faster download time for the DA14681/2/3 and DA15100/1 devices.	DA14681/2/3 and DA15100/1 production test firmware can now be downloaded through the uartboot.bin firmware in 1Mbaud and reduce the total download time.
4	Improved current measurements.	In case of failure, the PLT switches off the devices one by one until the failed DUT is found.



4 Introduction

By using the PLT it is possible to test, calibrate and load firmware for 16 different devices under test (DUTs) in parallel.

The following are deliverable parts of the tool.

- Hardware
 - Main board (Figure 1) together with a DA14580-QFN48 Golden Unit.
 - Electrical schematics of the main board.
 - Gerber files of the main board.
 - Bill of Materials of the main board.
- Software
 - Source code files organized in a Microsoft® Visual Studio Express 2015 solution.
 - Application executables and required DLLs.
- Documents.

An example of a sequence of actions the tool performs is given below. All of the actions are performed in parallel for up to 16 devices.

- 1. Download the production test firmware (e.g. prod test 580.bin).
- 2. Perform automatic crystal (XTAL) trimming.
- 3. Perform RF RSSI test.
- 4. Download and burn the customer firmware (into OTP, SPI flash, QSPI flash or I2C EEPROM)
- 5. Burn the OTP header.
- 6. Perform Scan test. Reset the DUTs and set the GU to scan for the DUT BLE advertisements.

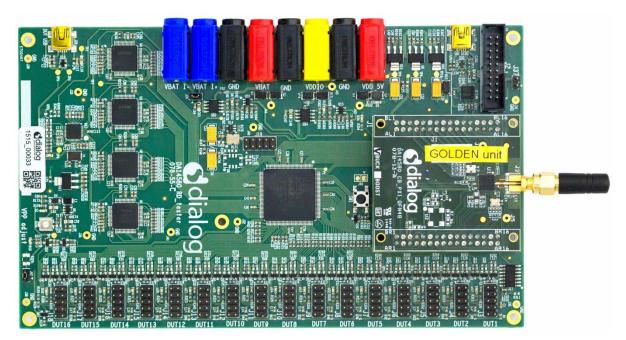


Figure 1: Production Line Tool Hardware



DA1458x/DA1468x Production Line Tool

5 Hardware

5.1 Hardware Block Diagram

The Production Line Tool hardware consists of various blocks, as illustrated in

Figure 2. These blocks are explained below.

- Blue blocks: USB-to-UART interfaces.
 - Four FT4232 FTDI QUAD USB-to-UART interfaces are used for a 16 channel USB-to-UART conversion.
 - The GU is connected to the PC via an FT232 FTDI USB-to-UART interface.
- Red block: A CPLD that has the following purpose.
 - Switch UART signals between the PC USB-UART and DUTs.
 - Switch DUTs VBAT signal
 - Switch DUTs VPP signal (only when VBAT is enabled).
 - Produce Reset signal to the DUTs.
 - Produce 500 ms XTAL calibration pulse.
- Orange block: A Golden Unit (GU) is mounted, which has the following functionality:
 - CPLD control using custom commands.
 - Transceiver for Bluetooth RF signals to and from the DUTs.
 - Produce an audio tone using PWM, used for audio testing.
 - Scan for device BLE advertisements, after the customer firmware has been programmed.
- Purple blocks: Sixteen (16) device connectors.

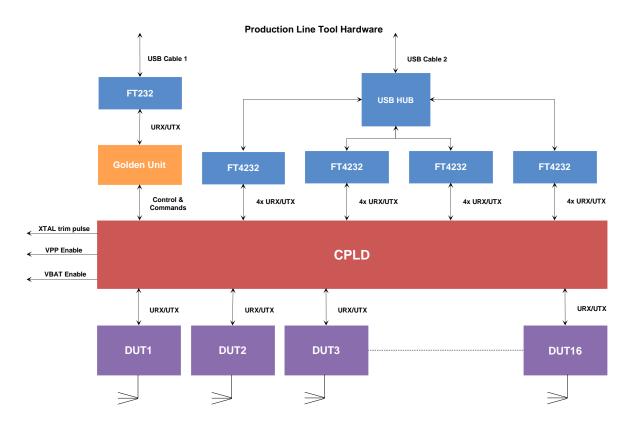


Figure 2: Production Line Tool Hardware Board Block Diagram

User Manual	Revision 4.3	03-Feb-2022
CFR0012	15 of 180	© 2022 Renesas Electronics



5.2 Printed Circuit Board Layout

In Figure 3 the top view of the PLT board is illustrated. The important parts are pointed by the orange boxes. The *VPP jumper* and the *Current jumper* are colored in blue.

The Golden Unit has a DA14580 QFN48-die soldered. Most of the 48 pins are basically used to connect to the CPLD. The CPLD is programmed during the production of the PLT board via the CPLD socket. No need for the users to use the CPLD socket.

The black banana sockets are all connected to the same ground (GND) plane.

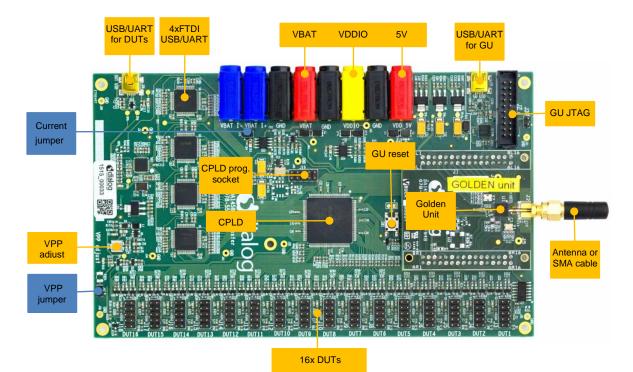


Figure 3: Top View of the PLT Hardware Board (Version C)

5.3 PLT Power Supply

External power supply is needed for the PLT to run. This should be connected to the banana sockets as shown in Figure 4.

Table 2 shows the voltage and current requirements for each power supply. The blue banana sockets can be used for device current measurements.



Figure 4: PLT Hardware Power Connections

Power Supply	Voltage (V)	Current (mA)	
		Buck Mode	Boost Mode
VBAT	2.4 3.3	16 x 20	n.a.
VDDIO	2.4 3.3	70	n.a.
VDD 5V	4.75 5.25	~335	~335
VPP	6.6 6.8	16 x 2	16 x 2

Table 2: Power Supply Requirements

5.4 DUT Connector

The BLE devices are connected to the PLT using the DUT1-16 connectors at the edge of the PLT board. Figure 5 shows the pin-header connections from the Production Line Tool hardware board to the DUTs. Table 3 describes the purpose of each pin.

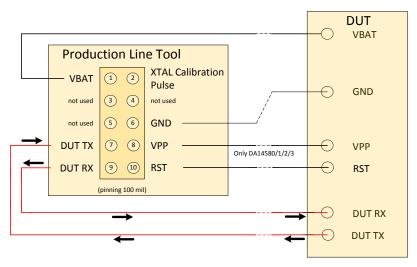


Figure 5: Production Line Tool DUT Connections

Table 3: PLT Connections to Applications

Header Pin	Name	Description
1	VBAT	Depending on the VBAT/Reset Signals Operation mode this can be used as Voltage supply for the DUT or as Reset signal. Due to this connection, no external power supply is needed for the DUTs. This pin must be connected if there is no other power supply (e.g. battery).
2	XTAL Calibration Pulse	This pin can be used as a reference pulse during the automatic crystal calibration. More details are given in 7.2.6.1 for DA1458x devices and in 7.2.10.1 for DA1468x devices. The crystal trim pulse can also be supplied in the UART RX device pin. This is the most common scenario. However, there may be hardware limitations where the UART RX pin cannot be used. In such cases the particular PLT header pin is used.
6	GND	Ground pin. This pin must be connected.
7	DUT TX	This is connected to the device UART TX pin. This pin must be connected.
8	VPP	This pin provides the 6.8V required to program the OTP in the DA14580/1/2/3 devices.
		Note: This option is not available with the VBAT as Reset mode.

User Manual





Header Pin	Name	Description
9	DUT RX	This is connected to the device UART RX pin. This pin can also provide the crystal calibration reference pulse for the automatic crystal (XTAL) trim procedure, as described in 7.2.6.1 for DA1458x devices and in 7.2.10.1 for DA1468x devices. This pin must be connected.
10	RST	The reset signal must be connected if battery powered devices are used.

5.5 Data Streaming

Figure 6, Figure 7 and Figure 8 illustrate the three possible data streams through the CPLD. The CPLD switches S1, S2, S3 and S4 are controlled by the software via the Golden Unit.

Normal Operation (Figure 6):

UART-RxD data is transported via the RED arrows (AA): PC \rightarrow USB \rightarrow USB HUB \rightarrow Quad UART \rightarrow CPLD signal 'AA' \rightarrow DUT RxD (programmed as RxD).

UART-TxD data is transported via the BLUE arrows (BB): PC \leftarrow USB \leftarrow USB HUB \leftarrow Quad UART \leftarrow CPLD signal 'BB' \leftarrow DUT TxD.

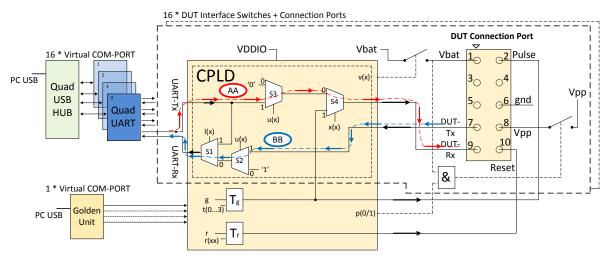


Figure 6: CPLD UART Data Streams

Crystal Trimming (Figure 7):

The XTAL calibration pulse (500 ms) is transported via the PURPLE arrows (CC): CPLD TIMER Tg \rightarrow CPLD S4 \rightarrow DUT RxD (programmed as GPIO).

UART-TxD data is transported via the BLUE arrows (BB): PC ← USB ← USB HUB ← Quad UART ← CPLD signal 'BB' ← DUT TxD.



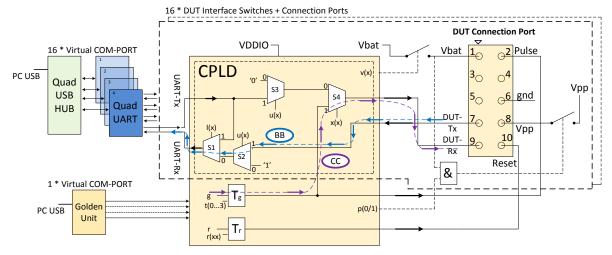


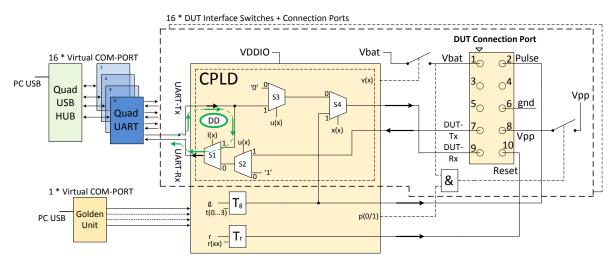
Figure 7: CPLD XTAL Trim Pulse Data Stream

Loopback Operation (Figure 8):

Loopback operation is used during the start of the tests. The PC PLT software uses this feature to automatically find the numbers of the Virtual COM ports in the Windows PC.

The UART loopback data is transported via the GREEN arrows (DD):

PC → USB → USB HUB → Quad UART → CPLD signal 'DD' SW1 → Quad UART → USB HUB → USB → PC.





Note: The CPLD is also used to switch the UART signals between the QUAD FTDIs and the DUTs. When the VBAT is switched off and the UART wires are not disconnected, a 'rest voltage' may be present on the product. This could cause problems with the Power On Reset (POR) and the product might not boot correctly. The CPLD will switch off the UART signals when the VBAT is not present.

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DA1458x/DA1468x Production Line Tool

5.6 Golden Unit



Figure 9: Golden Unit

The Golden Unit (GU) is a 'daughter' board mainly used in the Expert Development Kit [2]. In the PLT, the GU is used for various purposes:

- RF transmitter for the RF RSSI DUT test.
- RF Receiver for the device BLE advertisement scan test.
- Audio tone generator for the audio test.
- Controlling the CPLD.

The GU uses an SPI Flash memory mounted on the PLT board. The SPI Flash is pre-programmed with a specific production test firmware. If required, there are several ways to upgrade the GU firmware, either via the PLT's GU JTAG connector or via the UART. The latest GU firmware can be found inside the latest PLT software release, under the executables\binaries\GU folder. **Note:** PLT v4.1 and onwards requires the latest firmware version of the Golden Unit. If the Golden Unit firmware is not updated then the PLT applications will not run.

Note: The Golden Unit is calibrated during PLT production. It is delivered with a calibration characterization document.

5.6.1 GU Reset

The Golden Unit includes a hardware reset circuit. The GU reset signal is connected to an FTDI FT232 GPIO pin.

Figure 10 illustrates the electrical schematics of the GU reset circuit. Section 5.8.3 illustrates the jumper positions on the PLT PCB.

The red line is the connection between the FTDI IC GPIO pin (DTR) and the GU reset signal on the PLT GU connector header. The PLT software controls this pin via the FTDI DLL driver ftd2xx.dll. Making pin DTR low for a short period of time will reset the GU. Every time the PLT tests start, a hardware reset is issued to the Golden Unit. Jumper J47 should be ON and J46 OFF for this reset method to operate.



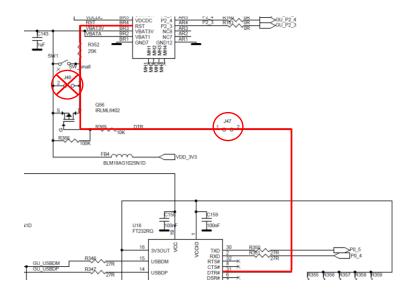


Figure 10: GU Reset Circuit

5.7 Current Measurements

The PLT board provides connections to perform DUT current measurements (see Figure 11). By connecting a current meter to the blue banana sockets the combined VBAT current of all DUTs can be measured. Jumper J26 should be removed when a current meter is connected. If no current meter is used, jumper J26 should be mounted. See also section 5.8.

The connection shown in Figure 11 can only be used with the VBAT Only and VBAT On with Reset (when the VBAT lines are used to power the DUTs) modes. If the DUTs are powered using a single external power supply then the multi-meter should be connected on that power supply in a similar way as described before with the PLT. If the DUTs are powered independently (e.g. each one with its own battery) the current measurement procedure cannot be used.

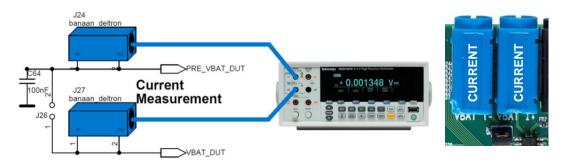


Figure 11: VBAT DUT Current Measurement Setup

5.8 Jumper Settings

This section describes the PLT hardware jumper settings.

Table 4: Jumpers

Jumper	PLT HW version	Description
J26	A, B, C, D	Connects the VBAT line from the PLT power supply to the DUTs. This jumper can be used when there is no multi-meter instrument connected for current measurement.

User Manual



Jumper	PLT HW version	Description
J37	B, C, D	This jumper sets the Golden Unit's SPI Flash chip select (CS) pin to high. This jumper is needed placed when the Golden Unit should NOT boot from the SPI flash.
J42	B, C, D	Feeds the VPP lines of the DUT connectors with VPP voltage used for OTP burning in DA14580/1/2/3 DUTs.
J46	C, D	This jumper can be used to reset the Golden Unit. The two pins on the jumper are the same as the ones in the GU reset switch next to the jumper.
J47	D	This jumper connects the Golden Unit's FTDI DTR line to the Golden Unit's reset pin. With this jumper on the PLT software can reset the Golden Unit on-demand.

5.8.1 J26 - Current Measurements

As shown in Figure 12, jumper J26 should be mounted when no external current meter is attached. Otherwise, when a current meter is connected via the blue banana sockets to measure the device current, the J26 jumper should be removed.



Figure 12: Connections for 'Floating Current' Measurements

5.8.2 J42 - DA1458x OTP Burning Voltage

If DA14580/1/2/3 OTP programming is required, the VPP line should be connected between the PLT DUT connector and the actual DUT (Figure 5). Jumper J42 on the PLT board should also be mounted. Figure 14 shows the jumper position on the PLT hardware board.

Figure 13 illustrates the electrical schematics of the VPP and the location of the J42 jumper.

DA14585/6 and DA1468x devices do not need an external voltage for the OTP to be burned. Therefore, the VPP line from the PLT DUT connector (Figure 5) should not be connected to the DA1468x DUT.

Note: The VPP line feature cannot be used with the VBAT as Reset mode.

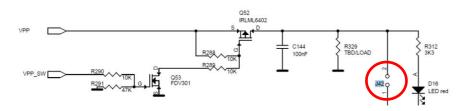


Figure 13: VPP Control Circuit Schematic





Figure 14: Location of the VPP Jumper J42

5.8.3 J47, J46 - GU Reset

For a GU hardware reset, jumper J47 should be mounted and jumper J46 should be removed. These two jumpers are involved in the circuit illustrated in

Figure 10. In this way, the GU hardware reset will be controlled by the PLT software. Figure 15 shows the jumper placement on the actual PCB.



Figure 15: Location of J46 Jumper



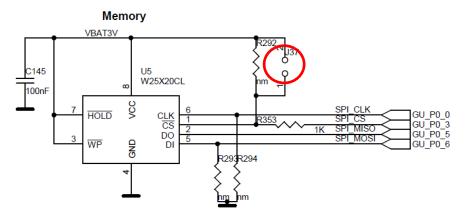
Figure 16: Location of J47 Jumper

5.8.4 J37 - GU Programming

Jumper J37 connects the Chip Select of the GU SPI Flash to a logic high level. This causes the GU not to boot from the already programmed SPI Flash, allowing the GU to load different code into its SysRAM via the JTAG connector or via UART. Figure 17 shows the circuit schematic and Figure 18 shows the location of jumper J37 on the PLT PCB.

lloor	Manual	
USEI	Manual	





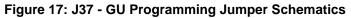




Figure 18: Location of J37 Jumper

5.9 PLT Functional Blocks

Figure 19 shows an overview of the PLT hardware functions. For detailed electrical schematics see Appendix B.

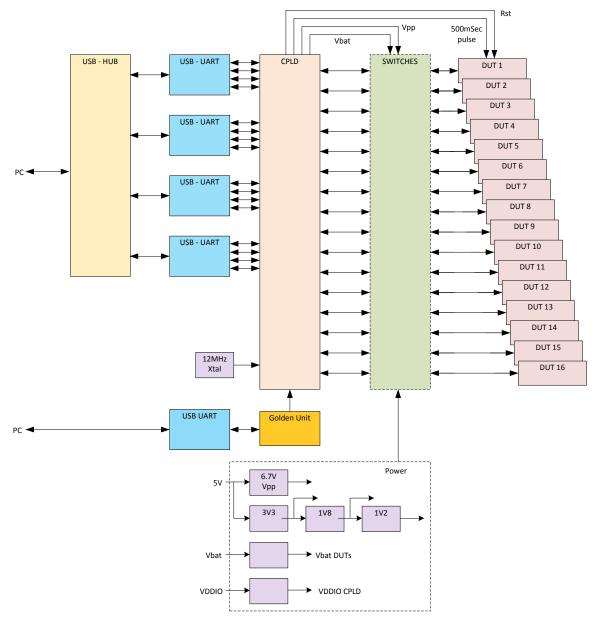


Figure 19: PLT Functional Blocks

lleor	Manual	
USCI	Manual	

6 Software

6.1 Introduction

The Production Line Tool software is a collection of software blocks that interact with each other, as shown in Figure 20. Its main purpose is to communicate with the PLT hardware and the DUTs in order to run the production tests and perform memory operations. The software blocks can be arranged in three main groups:

- Red blocks: User Interface (UI) applications.
- Blue blocks: Core libraries.
- Green blocks: Instrument interface libraries.

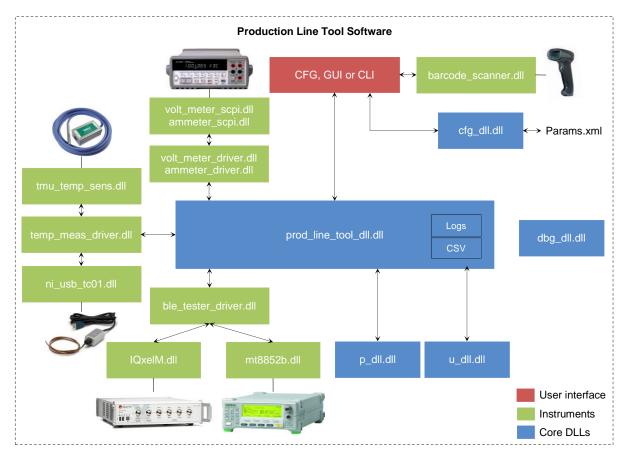


Figure 20: Production Line Tool Software Block Diagram

Core libraries and instrument interface libraries are explained in detail in UM-B-040 [1]. The User Interface applications block consists of three application executables. For details see section 0.

Short Name	File Name	Description
CFG PLT	DA1458x_DA1468x_CFG_PLT.exe	Configuration application. Load, edit and save the test parameters and the memory actions to be performed during device testing.
GUI PLT	DA1458x_DA1468x_GUI_PLT.exe	Graphical User Interface (GUI) application. Performs the actual device validation and memory programming. Provides a visual indication of the test results and access to the result logs.

Table 5: PLT User Interface Application Executables

User Manual





Short Name	File Name	Description
CLI PLT	DA1458x_DA1468x_CLI_PLT.exe	The same as the GUI PLT but console based.

6.2 DA15100/1 support

DA15100/1 devices are supported from the PLT v4.2. Since the DA15100/1 a BB version chipset similar to the DA14683 the same tests are supported, shown in Table 14. Thus in this user manual the DA15100/1 chips are treated as DA14682/3, meaning that a generic reference of the DA1468x chip includes the DA15100/1 chips.

6.3 Software Package Contents

The PLT software release package comes in a compressed folder DA1458x_DA1468x_PLT_v_X.zip, where 'X' represents the version number of the current PLT release.

Figure 21 illustrates the main folders of the PLT software package. Folder executables holds all the executables and libraries needed for the PLT to run on a Windows 7/8/8.1/10 machine. Folder source contains the entire source code of the PLT, organized in a Visual Studio Express 2015 solution.

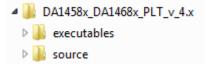


Figure 21: DA1458x/DA1468x PLT Software Package Contents

Table 6 gives a short description of the files and folders contained in the executables directories.

Table 6:	Executables	Folder	Description
----------	-------------	--------	-------------

File or Folder	Description
ammeter_instr_plugins/	Contains the current measurement instrument DLLs, used during the current measurement tests.
ammeter_instr_plugins/ni6009.dll	This is the DLL for the NI-6009 DAQ [14] that could be used in the current measurements. The usage of this instrument for measuring the current requires an external shunt resistor and things complicate when the measurement switches from many DUTs to one DUT. We only recommend using this instrument if one DUT per run is tested.
ammeter_instr_plugins/ammeter_scpi.dll	This is the DLL for taking current measurements using a DMM that supports the standard SCPI commands. NI-VISA is also used for this purpose. Example DMM instruments are the Keysight 34401A [6], the Keithely 2000 [7] or the Keysight 34461A [15]. The PLT has been tested with all three instruments.
binaries/	Contains the necessary firmware binaries. These are described in detail in <i>UM-B-040</i> [1]. Additionally, the SetupCode_Generator_680.exe application used in homekit products to create a specific hash key is included.
binaries/GU/prod_test_GU.bin	Contains the Golden Unit latest firmware binary. Users should better upgrade their PLT hardware with the GU firmware contained in this folder.
ble_tester_instr_plugins/	Contains the BLE tester instrument DLLs.
ble_tester_instr_plugins/mt8852b.dll	This is the DLL that performs the Direct Test Mode RF tests using the Anritsu MT8852B instrument [5].

User Manual



File or Folder	Description
ble_tester_instr_plugins/IQxelM.dll	This is the DLL that performs the Direct Test Mode RF tests using the Litepoint IQxeIM instrument [13].
icons/	Contains pictures used by the PLT applications.
IQmeasure_3.1.2/	Contains specific Litepoint IQxelM DLLs as released by Litepoint.
params/	Contains the configuration params.xml file, the XML schema params.xsd and a sample of BD address file named bd_address.ini.
params/custom_mem_data.csv	A sample CSV file to be used in the custom memory burn action. Users could edit this file and add their own specific memory data to be burned by the PLT. The PLT will match the entries in the CSV file using the BD addresses. The format of the file is explained later.
scripts/	Contains sample batch script files. User can select batch script files to be executed by the PLT before and after each test.
scripts/run_before_tests.cmd	An example script that copies and renames binaries from a directory to a folder required by the PLT when 'Different image per DUT' is selected. This folder is accessed by the PLT to read and burn different binary per DUT.
scripts/run_after_tests.cmd	An example script that moves all logs files, except the ones with the current date, to a specific folder.
temp_meas_instr_plugins/	Contains the temperature measurement instrument DLLs.
temp_meas_instr_plugins/ni_usb_tc01.dll	The ni_usb_tc01.dll is the DLL used to interface a NI USB TC01 [9] temperature sensor for temperature measurements.
temp_meas_instr_plugins/tmu_temp_sens.dll	The tmu_temp_sens.dll is the DLL used to interface a Papouch TMU sensor [7] for temperature measurements.
volt_meter_instr_plugins/	Contains the voltage meter instrument DLLs. These are used only in DA14681-00 silicon for ADC calibration purposes.
volt_meter_instr_plugins /volt_meter_scpi.dll	The volt_meter_scpi.dll is a DLL that implements basic interface with a DVM using SCPI commands through NI-VISA libraries and GPIB interface. Has been tested with Keithley 2000 [7] and Keysight 34401A [6].
DA1458x_DA1468x_CFG_PLT.exe	This is the configuration application. It is a graphical user interface application used to edit the PLT test configuration parameters, saved in an XML file, params.xml.
DA1458x_DA1468x_CLI_PLT.exe	This is the command line interface tool. It performs the production tests and memory programming through a console.
DA1458x_DA1468x_GUI_PLT.exe	This is the graphical user interface tool. It performs the production tests and memory programming through a graphical user interface.
ammeter_driver.dll/.lib	This is the DLL that loads and accesses all DMM instrument DLLs from inside the ammeter_instr_plugins. It acts as an intermediate layer between the prod_line_tool_dll and the instrument DLLs.
barcode_scanner.dll/.lib	This is the DLL that receives BD addresses from a barcode scanner with USB to serial interface. Has been tested with Honeywell Xenon 1900 and the Motorola LS2208 barcode scan readers [10] [11].
ble_tester_driver.dll/.lib	This is the DLL that loads and accesses all BLE tester instrument DLLs from inside ble_tester_instr_plugins folder.
User Manual	Revision 4.3 03-Feb-2022



File or Folder	Description
cfg_dll.dll/.lib	This is the configuration parameter handling DLL. It can validate, load and save parameters from a given XML file.
dbg_dll.dll/.lib	The dbg_dll.dll file is a DLL used to print debug messages to a file or to a debug console.
ftd2xx.dll	This is the FTDI DLL. Used to hard reset the Golden Unit from the application whenever needed through an FTDI GPIO pin.
p_dll.dll/.lib	This is the production test DLL that performs device functional tests.
prod_line_tool_dll.dll/.lib	This is the core DLL. The heart of the system that performs the state machines for all tests and memory actions to be executed. It is responsible to log the results and notify the user interfaces about the current device test status.
temp_meas_driver.dll/.lib	This is the temperature measurement driver DLL. It loads and accesses all temperature measurement DLLs from inside the temp_meas_instr_plugins folder.
u_dll.dll/.lib	This is the DLL that performs the memory actions, like the memory programming, erasing, etc.
vc_redist.x86.exe/vc_redist.x64.exe	These are the Visual Studio 2015 Express redistributable packages for 32 and 64bit machines. For installing these, users should agree to the license requirements described during the installation of any of these packages and also found here: https://www.visualstudio.com/license- terms/mt171551/.
volt_meter_driver.dll/.lib	This is the voltage meter driver DLL. It loads and accesses all voltage meter DLLs from inside the volt_meter_instr_plugins folder.

6.4 **Prerequisites**

Before building and running the code, the packages indicated in Table 7 should be installed on the PC. Some are required and others are optional depending on the tests or actions needed.

Item	Optional	Description
Visual Studio 2015 Express	Yes	The IDE used to edit and debug the Production Line Tool. This is only required if users would like to edit the software.
vc_redist.x86.exe/vc_redist.x64.exe	No	Already described in Table 6. Users should agree to the license requirements described during the installation of any of these packages and also found here: https://www.visualstudio.com/license-terms/mt171551/.
MSXML6	No	Installed by default in Win 7/8/8.1/10.
.NET framework 4	No	Needed for the graphical user interface applications.
Latest FTDI drivers	No	Tested with FTDI v2.12.24, v2.12.26 and v2.12.28 drivers.
Honeywell Xenon 1900 drivers	Yes	Needed if the barcode scanner is going to be used for scanning the devices BD addresses and/or custom memory data. Other types of barcode scanners could also be used.
Motorola LS2208 drivers	Yes	Used if a barcode scanner is going to be used for scanning the device BD addresses and/or custom memory data.
NI-VISA 15.5	Yes	Used for optional instrument control, like BLE tester and voltage meter.

Table 7: Production Line Tool Prerequisites

User Manual

Revision 4.3



Item	Optional	Description
NI-488.2 15.5	Yes	Used for optional instrument control, like BLE tester and voltage meter.
NI_DAQmx	Yes	Used for optional instrument control like temperature measurements using the NI USB TC01 sensor.

6.5 System Requirements

 Table 8 contains the minimum system requirements for the PLT to operate.

Item	Minimum Requirements	
Operating system	Windows 7/8/8.1/10	
CPU	Dual Core CPU	
Memory	1 GB RAM or larger. Each device log can	reach up to 40 kB.
Hard drive	For 100000 devices at least 4 GB of available hard disk is required.	
Monitor resolution	1280 x 768 or higher	
Monitor DPI	Smaller - 100% = 96 DPI	Supported
	Medium - 125% = 120 DPI	Supported
	Larger - 150% = 144 DPI	Not supported

Table 8: Minimum System Requirements

6.6 Limitations

Parallel control of multiple PLT hardware boards on the same PC is not supported.

However, by correctly setting up the system, two or more PLT hardware boards could be connected and controlled by multiple GUI PLT application instances on the same PC, but the tests should only be executed **sequentially**. The main reasons for this limitation are indicated below:

- The GU FT232 FTDI IC is programmed to have a special serial string, "DialogSemi" (see Table 98). This is used in the 'GU COM port find' PLT operation. This operation searches all PC connected FTDIs to find the serial string "DialogSemi". When found, it saves it as the GU COM port number to be used by the PLT. The 'GU COM port find' operation will open and lock, for a short period of time, all Windows COM ports, one by one, even the ones used by the other PLT hardware. If the second GUI PLT application instance is performing test operations at the same time and wants to open its DUT COM ports, the operation may fail.
- When the GUI PLT application starts the test operations, it performs a DUT COM port enumeration. During this process the GU sets the CPLD in UART loopback mode. It opens all PC COM ports one by one and sends a specific word, while trying to see if it receives it back. During this process, other PLTs may need to work with 'their' DUT COM ports, which may happen to be currently used by the 'DUT COM port enumeration' process of the first PLT.
- GU hardware reset. In every PLT test run a GU HW reset is issued from the PLT software using a specific GU FTDI GPIO pin. In order to access the GU FTDI the FTDI API is used from ftd2xx.dll. To access the FTDI hardware and read the serial number through the FTDI ftd2xx.dll the FT_Open API is used on all PC COM ports, one by one. Since FT_Open is used in all PC COM ports, conflicts could arise if other PLTs would also like to use these COM ports.
- BD addresses handling. Usually, the PLT automatically sets the DUT BD addresses by increasing them one by one. Special care should be taken to work with multiple PLT hardware and software. Most probably, two different BD address files should be used for each different PLT hardware.



6.7 Building the Code

The PLT software release package contains not only application executables for directly performing the tests out of the box, but also the entire source code of the tools. This is organized in a Visual Studio 2015 Express solution.

To open the Visual Studio 2015 Express PLT source code solution the following steps should be executed (see Table 9).

Table 9: Opening the PLT Visual Studio 2015 Express Source Code Solution

Step	Description
1	Download the latest PLT software package (e.g. DA1458x_DA1468x_PLT_v_4.x.zip)
2	Extract the software package. The following two folders should exist. DA1458x_DA1468x_PLT_v_4.x Name Rame executables source
3	Go to folder 'source\production_line_tool'. The following files and folders should exist. DA1458x_DA1468x_PLT_v_4.x > source > production_line_tool > Name Core_dlls Debug Fw_files Fw_files Fhelp Files F





2015 Express application will start and the PLT Solution Explorer should be shown. Image: Solution intervent Visual Studio Express File Edit View Project Build Debug Team Image: Solution Explorer (Clift) Image: Solution Explorer (C	Step	Description
4 > is prod_line_tool_dll > is missionents > is mineters > is mineters > is mineter_scpi > is mineter_scpi > is barcode_scanner > is blactede_scanner > is blactede_scanner > is coll_peinter	Step	Double click the production_line_tool.sln Visual Studio 2015 Express solution file. The Visual Studio 2015 Express application will start and the PLT Solution Explorer should be shown. production_line_tool - Microsoft Visual Studio Express File Edit View Project Build Debug Team Solution Explorer Solution Explorer Search Solution Explorer (Ctrl+:) Search Solution Ime_tool' (20 projects) Solution ime_tool' (20 projects) Solution ime_tool' (20 projects) Solution ime_tool' (20 projects) Solution ime_tool' (20 projects)
▷ INS GUI_pit To build the code follow the process described in the UM-B-040 document [1].	4	 i Sp. p.dll i Sp. prod.line_tool_dll i Sp. moter_stored i Sp. ammeters i Sp. ammeter_driver i Sp. ammeter_scpi i Sp. ammeter_scpi i Sp. amode_scanner i Sp. baccode_scanner i Sp. totmet_driver i Sp. itusb_tC01 i Sp. itusb_tC01 i Sp. itusb_tC01 i Sp. itusb_tC01 i Sp. volt_meter_driver i Sp. volt_meter_scpi i Sp. volt_meter_scpi i Sp. volt_meter_scpi i Sp. volt_meter_scpi
5 Note: Some Visual Studio projects may need to be unloaded prior to building the code, as they req external libraries to be installed. Please read UM-B-040 [1] for details.	5	To build the code follow the process described in the <i>UM-B-040</i> document [1]. Note: Some Visual Studio projects may need to be unloaded prior to building the code, as they require

6.8 Executing the Applications

To execute the Production Line Tool applications the process described in the following tables should be followed.

Step	Description				
1	Download the latest PLT software package (e.g. DA1458x_DA1468x_PLT_v_4.x.zip).				
2	Extract the software package. The following two folders should exist.				



Step	Description					
	Go to folder 'executables'. This folder should contain the following files and sub-folders.					
3	Image: Second					
4	volt_meter_instr_plugins Image: ftd2x.dll Double click the DA1458x_DA1468x_CFG_PLT.exe application executable. Most probably the following warning will be shown. Warning!!! Failed to load TabPage: {Hardware Setup} settings. ERROR: Value of [gu_com_port] is not valid.					



Step	Description						
	The application will start and the initial <i>Hardware Setup</i> screen will be shown.						
	File Run						
	Hardware Setup General BD addresses UART Test Settings Memory Functions Memory Header Debug Settings Security						
	▲ Station Identification						
	Station ID Test_station_1						
	Device IC						
	Device IC DA14580						
	Active DUTs						
	DUT 1 DUT 5 DUT 9 DUT 13						
	DUT 2 DUT 6 DUT 10 DUT 14 DUT 3 DUT 7 DUT 11 DUT 15						
5	DUT 4 DUT 8 DUT 12 DUT 16						
0	DUT COM Ports						
	DUT 1 0 DUT 9 0 DUT 13 0						
	DUT 2 0 DUT 6 0 DUT 10 0 DUT 14 0 DUT 3 0 DUT 7 0 DUT 11 0 DUT 15 0						
	DUT 4 0 DUT 8 0 DUT 12 0 DUT 16 0						
	Enum Reset						
	Golden Unit COM Port						
	Set the GU COM port Auto Refresh COM1 -						
	C:\DA1458x_DA1468x_PLT_v4x\params\params.xml						
	DA14580 Some values are not correct						
	Connect the PLT HW to the PC. Connect the GU and the DUT USB cables to the PC. Check the						
	Windows Device Manager that 17 new COM ports were found, 16 for the DUTs and 1 for the GU. The						
	Ports (COM & LPT) Communications Port (COM1)						
	- Trinter Port (LPT1)						
	- T USB Serial Port (COM111)						
6	- 🖓 USB Serial Port (COM113)						
0	- T USB Serial Port (COM115)						
	- 🖓 USB Serial Port (COM117)						
	- T USB Serial Port (COM119) ≡						
	그렇 USB Serial Port (COM121)						
	- 🖓 USB Serial Port (COM123)						
	- 🖓 USB Serial Port (COM125)						
6	Connect the PLT HW to the PC. Connect the GU and the DUT USB cables to the PC. Check the Windows Device Manager that 17 new COM ports were found, 16 for the DUTs and 1 for the GU. The following picture is an example of a Device Manager COM ports for a PC that has the PLT connected.						





Step	Description
7	On the DA1458x_DA1468x_CFG_PLT.exe Hardware Setup initial screen press Auto to automatically find the GU COM port among the 17 Windows enumerated COM ports. The Auto button will turn green if successful. Press Save* to save the new GU COM port in the params.xml file.
	Set the GU COM port Auto Refresh COM14 • C:\DA1458x_DA1468x_PLT_v4 x\params\params.xml Save*

Table 11: DA1458x_DA1468x_GUI_PLT.exe Application Execution

Step	Description							
1	To successfully start the DA1458x_DA1468x_GUI_PLT.exe application, the DA1458x_DA1468x_CFG_PLT.exe should be executed first in order to set up the system and perform the required tests. See Table 10.							
2	DA1458x_DA1468x_PL ammeter_instr_plu binaries	a DA1458x_DA	A1468x_CFG_PLT.exe A1468x_CLI_PLT.exe	ii6009.c		館 cfg_dll.lib 聞 dbg_dll.lib	S. ▼ 49	
2	ble_tester_instr_plugins icons IQmeasure_3.1.2 params scripts cfg_dll.dll temp_meas_instr_plugins volt_meter_instr_plugins ftd2xx.dll		anner.dll	temp_meas_driver.dll		Image: microson in the second seco	ver.lib	
3	Appear. File Edit Run Start BD address 00:00:00:00:00:00:01 Next BD address 00:00:00:00:00:00:01 End BD address 00:00:00:00:00:00:00 Statistics Pass: 0 Fail: 0 Total: 0 Left: 0 IC IC	DA1458x_DA1468x_G		Temp	executable. Star Ammeter	lus	initial sci	Result
	DA14580 COM Enum GU Check VBAT/UART UART check UART check C:\DA1458x_DA1468x_PLT_v4.xpr	arams'uarams.xml		STA	R T	Retest failed: Disa	abled Test Tir	ne: 00:00:000
4	By clicking the keyboard spacebar, the START button will be pressed and the preconfigured tests and memory actions will start to be executed.							





Table 12: DA1458x_DA1468x_CLI_PLT.exe Application Execution

Step	Description					
1	To successfully start the DA1458x_DA1468x_CLI_PLT.exe application, the DA1458x_DA1468x_CFG_PLT.exe should be executed first, in order to set up the system and perform the required tests. See Table 10.					
	Go to folder 'executables'. This folder should contain the following files and sub-folders.					
2	 ammeter_instr_plugins binaries ble_tester_instr_plugins icons IQmeasure_3.1.2 params scripts temp_meas_instr_plugins volt_meter_instr_plugins 	Image: Straight of the straight	 ni6009.dll p_dll.dll prod_line_tool_dll.dll temp_meas_driver.dll u_dll.dll volt_meter_driver.dll ammeter_driver.lib barcode_scanner.lib ble_tester_driver.lib 	日間 cfg_dll.lib 日前 dbg_dll.lib 日前 ni6009.lib 日前 p_dll.lib 日前 prod_line_tool_dll.lib 日前 temp_meas_driver.lib 日前 u_dll.lib 日前 volt_meter_driver.lib		
3	Double click the DA1458x_DA1468x_CLI_PLT.exe application executable. The following initial screen will appear. DA1458x/DA1468x Production Line Tool v=4.x.8.x Command list: t <580/581/502/583/585/586/681-00/681-01> Select the IC for device under test. i <configuration file="" path=""> Import new configuration settings. All DLLs will be reinitialized with the new para meters. x < TPFP-00000> Bitwise DUT activation. h <<pre>(x < Configuration file path> Buddress to be used in the first active DUT of the next PLT test run. c <ft>-> DUT BD address read. y <=> DUT COM port find t> GU COM port find; is LED. m <if comport="" find;="" is="" led.<br="">m <if comport="" file="" y=""> Findle Error and Info prints. Printed on file or in the console. d <console file="">> Kaale Error and Info prints. Printed on file of in the console. d <console file="">> Command used only for tool evaluation. Runs multiple tests, one after the other, without st y <-> Start the tests> Command used only for tool evaluation. Runs multiple tests, one after the other, without st y <> Print this help. e> Exit. ></console></console></if></if></ft></pre></configuration>					
4	Type 's' and then press Enter. The preconfigured tests and memory actions will start to be executed.					

6.9 Test Sequence

This section describes the sequence of steps involved in the DA1458x and DA1468x device testing. It will outline all the steps the PLT follows to successfully test a device.

6.9.1 DA1458x Test Sequence

 Table 13 describes each step the PLT undertakes for DA1458x devices. Some of the steps are optional and will only be executed if the equivalent actions are enabled in the configuration parameters. Additionally, some of the steps are supported only for specific DA1458x IC versions.

The entire test sequence for the DA1458x DUTs is shown in Figure 22.

Step	Device	Action	Opt	Description
1	DA1458x	Statistics update	No	Update the total tests executed.
2	DA1458x	BD addresses	No	Update the BD addresses for all DUTs.

Table 13: DA1458x Test Sequence

User Manual



DA1458x/DA1468x Production Line Tool

Step	Device	Action	Opt	Description
3	DA1458x	Configuration parameters	No	Configuration parameters are passed from the CLI or GUI to the prod_line_tool_dll. If any of the parameters is not valid an error will occur.
4	DA1458x	Reset GU	No	Golden Unit hardware reset by controlling an FT232 pin.
5	DA1458x	Initialize CPLD	No	Set the CPLD to an initial known state.
6	DA1458x	Check temperature sensor instrument	Yes	Check whether the temperature measurement instrument is online, only if the temperature measurement test is active.
7	DA1458x	Check BLE tester instrument	Yes	Check whether the BLE tester instrument is online, only if any of the BLE tester test operations is active.
8	DA1458x	Check ammeter instrument	Yes	Check whether the ammeter instrument is online, only if any of the current measurement tests is active.
9	DA1458x	Toggle GU LED	No	Toggle the GU red LED on the PLT hardware to indicate that the GU is alive.
10	DA1458x	Check DUT COM ports	No	Check whether the PLT has identified the DUT COM ports and if not run the automatic DUT COM port identification.
11	DA1458x	Temperature measure	Yes	If the temperature measurement test is active, take a measurement and log it to all DUT logs and in the CSV file.
12	DA1458x	Download prod_test_58x.bin	Yes	If any of the production tests is active (e.g. RF tests, XTAL trim, etc.) download the prod_test_58x.bin to the devices.
13	DA1458x	Open the devices COM ports and get the prod_test_58x.bin firmware version.	Yes	After prod_test_58x.bin has been downloaded to the DUTs, test commands can be sent to it. First the Windows DUTs COM ports are opened. Then a command to get the prod_test_58x.bin firmware version is sent to the devices. If there is a problem in the firmware or in the device, then this is the first failure to happen. The FW version get action will fail.
14	DA1458x	Current measure	Yes	Perform the Idle current measurement.
15	DA1458x	XTAL trim	Yes	Perform the XTAL trim procedure, if this is active.
16	DA1458x	XTAL trim OTP burn	Yes	If the 'Burn to OTP' option is selected in the CFG PLT, then the calculated XTAL trim value will be burned to the OTP Header.
17	DA1468x	UART resync	Yes	If the XTAL trim procedure was performed in the UART RX pin, then a special UART resync procedure takes place to resynchronize the device's UART RX path, as it may have entered into a baud rate error state due to the 500 ms received XTAL trim pulse.
18	DA1458x	BLE tester TX power	Yes	If the BLE tester TX Power test is active then perform the test using the external BLE tester instrument.
19	DA1458x	BLE tester TX carrier offset	Yes	If the BLE tester TX carrier offset test is active then perform the test using the external BLE tester instrument.
20	DA1458x	BLE tester TX modulation index	Yes	If the BLE tester TX modulation index test is active then perform the test using the external BLE tester instrument.
21	DA1458x	BLE tester RSSI	Yes	If the BLE tester RSSI test is active then perform the test using the external BLE tester instrument.
22	DA1458x	GU RSSI test	Yes	If the RSSI test using the GU as transmitter is active, then perform the test.
23	DA1458x	GPIO/LED	Yes	Perform the GPIO/LED test, if the test is active.
24	DA14582 only	Audio test	Yes	Perform the audio test, only for DA145482 and DA14585/6 devices and only if the particular test is enabled.

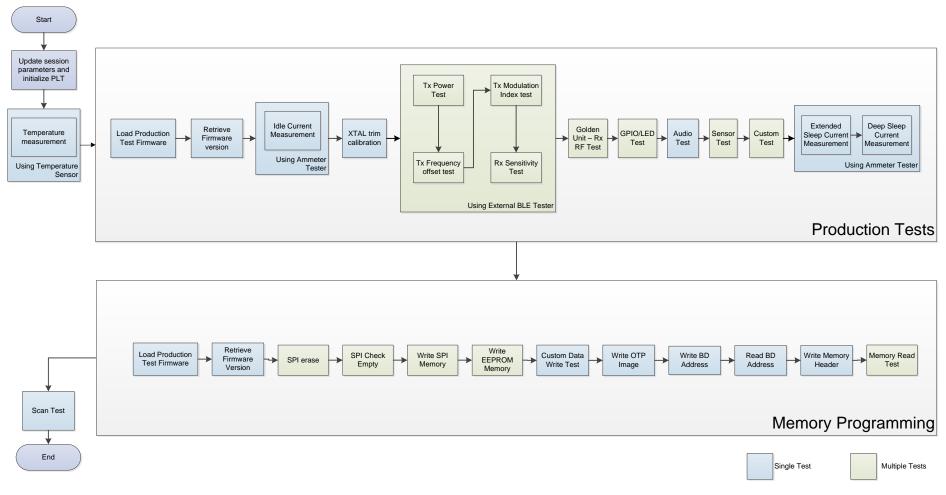
User Manual

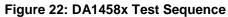


DA1458x/DA1468x Production Line Tool

Step	Device	Action	Opt	Description
25	DA1458x	Sensor test	Yes	Perform the sensor tests only if these are enabled.
26	DA1458x	Custom test	Yes	Perform any active custom test.
27	DA1458x	Current measure	Yes	Perform the Extended sleep current measurement.
28	DA1458x	Current measure	Yes	Perform the Deep sleep current measurement.
29	DA1458x	Firmware download	Yes	If any memory action is active (e.g. SPI Flash burn, erase etc.) download the flash_programmer.bin to the devices.
30	DA1458x	Open COM port and get the flash_programmer.bin version.	Yes	After flash_programmer.bin has been downloaded, commands can be sent. A command to get the flash_programmer.bin firmware version is sent to the devices.
31	DA1458x	SPI erase	Yes	Erase the SPI Flash, either entirely or part of it depending on the configuration.
32	DA1458x	SPI check empty	Yes	Depending on the configuration, check whether the SPI Flash is empty to verify the Flash erase procedure.
33	DA1458x	SPI image write	Yes	If enabled, write the SPI Flash with the customer image. If verify is enabled, the contents of the Flash will be read back and compared to the original image downloaded.
34	DA1458x	I2C EEPROM write	Yes	Write the I2C EEPROM with the customer image. If verify is enabled, the contents of the EEPROM will be read back and compared to the original image downloaded.
35	DA1458x	Custom memory data	Yes	Write custom memory data, taken from a barcode scanner, entered manually or through a CVS file.
36	DA1458x	OTP image write	Yes	Write the OTP image with the customer image. If verify is enabled, the contents of the OTP memory will be read back and compared to the original image downloaded.
37	DA1458x	OTP BD address write	Yes	If enabled, write the BD address into the OTP memory. If verify is enabled, the OTP BD address will be read back and compared to the original.
38	DA1458x	OTP BD address read	Yes	If enabled, the BD address from the OTP will be read. The BD address will be printed in GUI or CLI application. An additional test can be enabled to compare the read BD address with the one supplied by the tool.
39	DA1458x	OTP image write	Yes	Write the OTP image with the customer image. If verify is enabled, the contents of the OTP memory will be read back and compared to the original image downloaded.
40	DA1458x	OTP header write	Yes	If enabled, the OTP header fields will be burned.
41	DA1458x	Memory read	Yes	Up to ten memory read tests can be performed with up to 256 bytes in length.
42	DA1458x	Scan test	Yes	If enabled, the GU will scan for device BLE advertisements. For the DUTs to be scanned a valid firmware has to be burned into the OTP, SPI Flash or EEPROM that sends BLE advertisements after power up. Additionally, the BD address should be burned into the OTP by the PLT. The PLT expects to find devices in the air with the BD addresses programmed by the same tool, so it can match the BD addresses returned by the GU.







User Manual	Revision 4.3	03-Feb-2022
CFR0012	39 of 180	© 2022 Renesas Electronics

6.9.2 DA1468x Test Sequence

Table 14 describes each step that the PLT undertakes to validate and program DA1468x based devices. Some of the steps are optional and will only be executed if the equivalent actions are enabled in the configuration parameters. Additionally, some of the steps are supported only for specific DA1468x IC versions.

The entire test sequence for the DA1468x DUTs is shown in Figure 23.

Step	Device	Action	Opt	Description
1	DA1468x	Statistics update	No	Update the total tests executed.
2	DA1468x	BD addresses	No	Update the BD addresses for all DUTs.
3	DA1468x	Configuration parameters	No	Configuration parameters are passed from the CLI or GUI to the prod_line_tool_dll. If any of the parameters is not valid an error will occur.
4	DA1468x	Reset GU	No	GU hardware reset by controlling an FT232 pin.
5	DA1468x	Initialize CPLD	No	The GU will set the CPLD to an initial known state.
6	DA1468x	Check temperature sensor instrument	Yes	Check whether the temperature measurement instrument is online, only if the temperature measurement test is active.
7	DA1468x	Check BLE tester instrument	Yes	Check whether the BLE tester instrument is online, only if any of the BLE tester test operations is active.
8	DA14681- 00 only	Check voltage meter instrument	Yes	Check whether the voltage meter is online, only if the ADC gain calibration is active and only for DA14681-00 devices.
9	DA1468x	Check ammeter instrument	Yes	Check whether the ammeter instrument is online, only if any of the current measurement tests is active.
10	DA1468x	Toggle GU LED	No	Toggle the GU red LED on the PLT hardware to indicate that the GU is alive.
11	DA1468x	Check DUT COM ports	No	Check whether the PLT has identified the DUT COM ports and if not run the automatic DUT COM port identification.
12	DA1468x	Temperature measure	Yes	If the temperature measurement test is active, take a measurement and log it to all DUT logs and in the CSV file.
13	DA1468x	Download prod_test_681_xx.bin	Yes	If any of the production tests is active (e.g. RF tests, XTAL trim, etc.) download the prod_test_68x_xx.bin to the devices.
14	DA1468x	Open the devices COM ports and get the prod_test_681_xx.bin firmware version	Yes	After prod_test_68x_xx.bin has been downloaded, commands can be sent to it. First, the Windows DUTs COM ports are opened. Then, a command to get the prod_test_68x_xx.bin firmware version is send to the devices. If there is a problem in the firmware or in the device, then this is the first failure to happen. The FW version get action will fail.
15	DA1468x	Current measure	Yes	Perform the Idle current measurement.
16	DA1468x- 00 only	ADC gain calibration	Yes	If this option is enabled and if the device is based on a DA14681-00 IC, then the ADC gain calibration procedure takes place using an external voltage meter instrument.
17	DA1468x	XTAL trim	Yes	Perform the XTAL trim procedure, if this is active.

Table 14: DA1468x Test Sequence

User Manual



DA1458x/DA1468x Production Line Tool

Step	Device	Action	Opt	Description
18	DA1468x	UART resync	Yes	If the XTAL trim procedure was performed in the UART RX pin, then a special UART resync procedure takes place to resynchronize the device's UART RX path as it may have entered in a baud rate error state due to the 500ms received XTAL trim pulse.
19	DA1468x	BLE tester TX power	Yes	If the BLE tester TX Power test is active then perform the test using the external BLE tester instrument.
20	DA1468x	BLE tester TX carrier offset	Yes	If the BLE tester TX carrier offset test is active then perform the test using the external BLE tester instrument.
21	DA1468x	BLE tester TX modulation index	Yes	If the BLE tester TX modulation index test is active then perform the test using the external BLE tester instrument.
22	DA1468x	BLE tester RSSI	Yes	If the BLE tester RSSI test is active then perform the test using the external BLE tester instrument.
23	DA1468x	GU RSSI test	Yes	If the RSSI test using the GU as transmitter is active, then perform the test.
24	DA1468x	GPIO/LED	Yes	Perform the GPIO/LED test, if the test is active.
25	DA1468x	Sensor test	Yes	Perform the sensor tests only if these are enabled.
26	DA1468x	Custom test	Yes	Perform any active custom test.
27	DA1468x	Current measure	Yes	Perform the Extended sleep current measurement.
28	DA1468x	Current measure	Yes	Perform the Deep sleep current measurement.
29	DA1468x	Download uartboot.bin	Yes	If any of the memory actions is active (e.g. QSPI burn, QSPI erase, etc.) download the uartboot.bin to the devices.
30	DA1468x	Open COM port and get the uartboot.bin version.	Yes	After uartboot.bin has been downloaded, commands can be sent to it. A command to get the uartboot.bin firmware version is send to the devices.
31	DA1468x	QSPI erase	Yes	Erase the QSPI, either the entire or part of it depending on the configuration.
32	DA1468x	QSPI check empty	Yes	Depending on the configuration, check whether the QSPI is empty to verify the QSPI erase procedure.
33	DA1468x	QSPI image write	Yes	If enabled, write the QSPI with the customer image. If verify is enabled, the contents of the QSPI will be read back and compared to the original image downloaded.
34	DA1468x	QSPI BD address write	Yes	If enabled, the device BD address is programmed to a specific QSPI flash address.
35	DA1468x	QSPI BD address read	Yes	If enabled, the PLT will read the BD address field from the QSPI. This will be printed in the GUI, CLI screen and in the device logs. An additional test can be enabled to compare the read BD address to the one supplied by the tool.
36	DA1468x	QSPI XTAL trim write	Yes	If enabled, the XTAL trim value calculated during the XTAL trim calibration procedure will be burned into the QSPI flash.
37	DA1468x- 00 only	QSPI ADC gain calibration write	Yes	If enabled, the ADC gain calibration value calculated during the calibration procedure will be burned into the QSPI flash.

User Manual

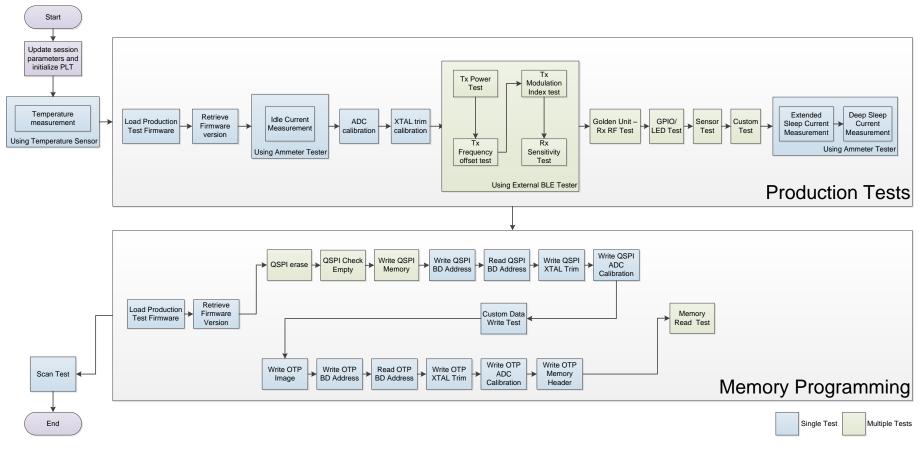


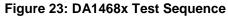
DA1458x/DA1468x Production Line Tool

Step	Device	Action	Opt	Description
38	DA1468x	Custom memory data	Yes	Write custom memory data, taken from a barcode scanner, entered manually or through a CVS file.
39	DA1468x	OTP image write	Yes	Write the OTP image with the customer image. If verify is enabled, the contents of the OTP memory will be read back and compared to the original image downloaded.
40	DA1468x	OTP BD address write	Yes	If enabled, write the BD address into the OTP memory. If verify is enabled, the OTP BD address will be read back and compared to the original.
41	DA1468x	OTP BD address read	Yes	If enabled, the PLT will read the BD address field from the OTP. This will be printed in the GUI, CLI screen and in the device logs. An additional test can be enabled to compare the read BD address to the one supplied by the tool.
42	DA1468x	OTP XTAL trim write	Yes	If enabled, the XTAL trim value calculated during the XTAL trim calibration procedure will be burned into the OTP TCS header.
43	DA1468x- 00 only	OTP ADC gain calibration write	Yes	If enabled, the ADC gain calibration value calculated during the calibration procedure will be burned into the OTP TCS header.
44	DA1468x	OTP header write	Yes	If enabled, the OTP header fields will be burned.
45	DA1468x	Memory read	Yes	Up to 10 memory read tests can be performed with up to 256 bytes in length.
46	DA1468x	Scan test	Yes	If enabled, the GU will scan for device BLE advertisements. For the DUTs to be scanned a valid firmware has to be burned into the OTP or QSPI flash that sends BLE advertisements after power up. Additionally, the BD address should be burned into the OTP or the QSPI by the PLT. The PLT expects to find devices in the air with the BD addresses programmed by the same tool, so it can match the BD addresses returned by the GU.



DA1458x/DA1468x Production Line Tool





6.10 VBAT/Reset Signals Operation

The following chapter describes the PLT hardware VBAT and Reset signal operation during the DUT Test Sequence.

There are three different modes available to power and reset the DUTs using a combination of the PLT VBAT and Reset lines. These are described next.

6.10.1 VBAT Only

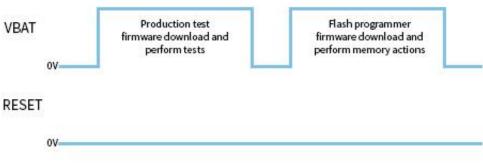


Figure 24: VBAT only

In this mode only the VBAT line is used as shown in Figure 24. Only the VBAT signal from the PLT hardware board to the DUT should be connected. The Reset signal is not driven. The DUTs are powered independently from their VBAT lines connected to the PLT HW and when reset is needed the PLT software toggles the VBAT line low in order to perform a POR to each device.

Battery powered DUTs or DUTs with an external power supply are not supported in this mode. PLT to DUT VBAT line connection is mandatory. PLT Reset line connection is not required.

Firmware download

When the firmware download procedure begins, the PLT VBAT line will power the DUTs and the UART connections will open, which will result to a POR for all active devices. This POR will activate the DUTs UART booting procedure and the PLT software will be able to download a test firmware.

If there are devices that failed the test firmware download procedure, the PLT will perform a VBAT POR to retry the firmware download procedure only for those that failed. During the extra attempts to download firmware to the failed devices, the VBAT lines of the devices that succeeded will remain active. After three retry attempts the PLT VBAT lines will remain active only for the devices that have succeeded.

When the production testing has finished the above procedure will be repeated for the memory programming as a different firmware needs to be downloaded to the DUTs.

Current measurement

Since the DUTs will be powered through the PLT HW, using the VBAT line, then the Current Measurement Test for the DA14580/1/2/3/5/6 and the Current Measurement Test for the DA14681/2/3 are supported using an external multi meter as described in Current Measurements.



6.10.2 VBAT On with Reset

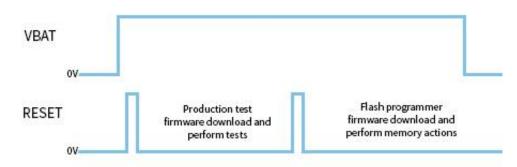


Figure 25: VBAT On with Reset

In this mode the reset of the DUTs will be performed by the PLT Reset line as shown in Figure 25. During this mode the PLT VBAT line continuously provides power to the DUTs and the DUTs are reset using the PLT Reset line.

Power supply can be provided to the DUTs if the PLT VBAT line is connected to the DUTs. However, for battery powered DUTs or for DUTs with an external power supply VBAT should not be connected. For such devices, only the connection to the PLT Reset line is mandatory.

Firmware download

When the firmware download procedure begins, the PLT will reset the DUTs using the PLT Reset line. The VBAT line is already active and remains active for the entire PLT test and memory programming procedure. If there are devices that failed to download firmware, the PLT will reset all the DUTs again and retry to download firmware to all of them even if these have succeeded. This is different approach from the VBAT Only procedure, since the Reset line is a single hardware line that cannot be differently controlled for each DUT, as opposed to the VBAT lines.

When the production testing has finished, the above procedure will be repeated for the memory programming as a different firmware needs to be downloaded to the DUTs.

Current measurement

If the DUTs are powered through the PLT HW, using the VBAT line, or if they are powered using a single common line from an external power supply, then the Current Measurement Test for the DA14580/1/2/3/5/6 and the Current Measurement Test for the DA14681/2/3 are supported using an external multi meter as described in Current Measurements. If the DUTs are powered independently or have their own power supply (e.g. battery) then the Current measurement tests are not supported.

6.10.3 VBAT as Reset

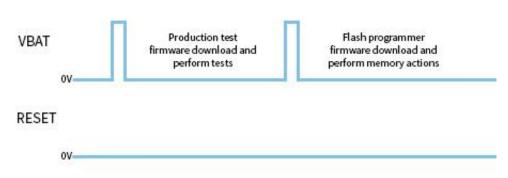


Figure 26: VBAT as Reset

In this mode the reset of the DUTs will be performed using the PLT VBAT line as shown in Figure 26. Each DUT can be reset independently using the VBAT lines. This mode has advantage over VBAT On with Reset since VBAT lines can independently be controlled as opposed to the PLT Reset line.

User Manual	Revision 4.3	03-Feb-2022

DA1458x/DA1468x Production Line Tool

This mode supports only devices that are battery powered or have an external power supply and are already powered on. PLT VBAT line connection is mandatory and it must be connected to the DUT reset pin. The PLT Reset line connection is not used.

Note: When using this mode the PLT VPP signal used for programming the OTP memory (OTP header and burning the XTAL Trim to OTP during production testing for the DA14580/1/2/3 devices) is not supported. An external VPP supply (as described in Table 2) should be provided when using this mode.

Firmware download

When the firmware download procedure begins, the UART connections will open and the PLT VBAT lines will be used to reset the DUTs.

If there are devices that failed the firmware download procedure, the PLT will perform a reset (using the VBAT line of each DUT) to retry for those DUTs that failed. After three attempts the UART connections will remain on only for the devices that have firmware loaded.

When the production testing has finished, the above procedure will be repeated for the memory programming as a different firmware needs to be downloaded to the DUTs.

Current measurement

If the DUTs are powered using a single common line from an external power supply, then the Current Measurement Test for the DA14580/1/2/3/5/6 and the Current Measurement Test for the DA14681/2/3 are supported using an external multi meter as described in Current Measurements. If the DUTs are powered independently or have their own power supply (e.g. battery) then the Current measurement tests are not supported.

6.11 Custom Memory Data

The following chapter describes the PLT 'Custom Memory Data' configuration and programming procedure.

The PLT supports programming custom user data of any size up to 256 bytes, to any memory and from any start address. Custom data can be entered to the PLT by the three input methods described in Table 15.

Input Modes	Description
Barcode scanner	Prior of starting the PLT tests, before pressing the START button in the PLT GUI, users can use a barcode scanner to enter custom memory data, different for each DUT. A new GUI screen can be used to scan DUT barcodes and save the barcode scanned data to the PLT. The PLT will then burn these data to the user specified memory and address. Duplicate scan data protection can be enabled to protect scanning same data for different DUTs in the same test.
CSV file	Users can provide a path to a CSV file that will contain the custom memory data for each DUT. The format of the CSV file is specific and is provided in Custom data CSV file format.
Manual	Users can manually edit the custom memory data prior of each PLT test run. The edit can be done in the PLT GUI or in the params.xml file using an external application or script. If different data per DUT is required then the update of the custom memory data should be done before every PLT test run.

Chapter Custom Memory Data explains in detail the various configuration parameters of the 'Custom Memory Data' programming PLT feature.

6.11.1 Homekit Hash Setup Code

The PLT supports the hashing and programming of homekit setup codes. This feature is only supported for the DA14681/2/3 DUTs and can be enabled in the Custom Memory Data test using the

lleor	Manual	
USCI	wanuai	



Homekit binary generator option. For this to work users should input to the PLT a specific format of the setup code and device serial number. The format should be as described in Table 16.

Homekit Setup Code format	Description
XXXXXXXXZZZZZZY	XXXXXXXX is an exact 8 digit homekit setup code without the dashes.
	ZZZZZZZ is the serial number with a maximum length of 64 characters.
	Y is the checksum of the previous characters.
	Example: Consider a device with setup code 123-45-678 and serial number DIAG97969594. The input to the PLT should be given as 12345678DIAG97969594P
	The final character 'P' is the checksum of the previous characters. The algorithm of the checksum is given in Table 17.

The homekit setup code characters can be taken from either input mode described in Table 15. The PLT will read the input and will apply it as input argument to the SetupCode_Generator_680.exe application found under the binaries folder. The SetupCode_Generator_680.exe application will create, in the same binaries folder, a binary image with the name <code>xxxxxxxxzzzzzz....Y.bin</code>. The PLT will burn this file to the memory and start address that the user has configured.

Table 17: Homekit Setup Code Checksum Algorithm

```
Homekit Setup Code Checksum Algorithm
const char checkCharList[] = "0123456789ABCDEFGHIJKLMNOPQRSTUVWXYZ";
/**
*
 * @brief Homekit specific setup code and serial number checksum check function.
 * This checksum algorithm is similar to EAN, ILN and NVE but with alphanumeric instead of numbers
 * @param[in] *inString
                                            The string to check its checksum.
 * @param[in] *inLength
                                            The length of the string.
 * @return The checksum character.
 **/
char hmkt setupcode chksm(const char *inString, int inLength)
{
    char check = 0;
    int index = 0;
    unsigned int sum = 0;
    const char *characters = inString;
    for (index=0; index<inLength && characters[index]!=0; index++) {</pre>
       if ((index % 2) == 0)
           sum += characters[index];
       else sum += characters[index] * 3;
    }
    sum = sum % 36;
    if (sum != 0)
       sum = 36 - sum;
    check = checkCharList[sum];
    return check;
}
```



6.11.2 Custom data CSV file format

This section describes the format of the CSV file used in CSV file input mode of the Custom Memory Data test.

80:EA:CA:80:00:01	ОТР	47F54	5	5566778801	SPI	8000	10	112233445566778899AA				
80:EA:CA:80:00:02	ОТР	47F54	5	5566778802	SPI	8000	10	112233445566778899AA				
80:EA:CA:80:00:03	ОТР	47F54	5	5566778803	SPI	8000	10	112233445566778899AA				
80:EA:CA:80:00:04	ОТР	47F54	5	5566778804	SPI	8000	10	112233445566778899AA	SPI	9000	256	11223344556677889900AABBCCDDEEF411223344556677889900AABBCCDDEEF41122334455667
80:EA:CA:80:00:05	ОТР	47F54	5	5566778805	SPI	8000	10	112233445566778899AA	SPI	9000	256	11223344556677889900AABBCCDDEEF411223344556677889900AABBCCDDEEF411223344556677
80:EA:CA:80:00:06	ОТР	47F54	5	5566778806	SPI	8000	10	112233445566778899AA				
80:EA:CA:80:00:07	ОТР	47F54	5	5566778807	SPI	8000	10	112233445566778899AA				
80:EA:CA:80:00:08	ОТР	47F54	5	5566778808	SPI	8000	10	112233445566778899AA				
80:EA:CA:80:00:09	ОТР	47F54	5	5566778809	SPI	8000	10	112233445566778899AA				
80:EA:CA:80:00:0A	ОТР	47F54	5	556677880A	SPI	8000	10	112233445566778899AA				
80:EA:CA:80:00:0B	ОТР	47F54	5	556677880B	SPI	8000	10	112233445566778899AA				
80:EA:CA:80:00:0C	ОТР	47F54	5	556677880C	SPI	8000	10	112233445566778899AA				
80:EA:CA:80:00:0D	ОТР	47F54	5	556677880D	SPI	8000	10	112233445566778899AA				
80:EA:CA:80:00:0E	ОТР	47F54	5	556677880E	SPI	8000	10	112233445566778899AA				
80:EA:CA:80:00:0F	ОТР	47F54	5	556677880F	SPI	8000	10	112233445566778899AA				
80:EA:CA:80:00:11	ОТР	47F54	5	5566778811	SPI	8000	10	112233445566778899AA				
80:EA:CA:80:00:12	ОТР	47F54	5	5566778812	SPI	8000	10	112233445566778899AA				
80:EA:CA:80:00:13	ОТР	47F54	5	5566778813	SPI	8000	10	112233445566778899AA				

Figure 27: Custom Memory Data CSV File Example

Each line in the CSV file corresponds to a specific DUT, which is bound to BD address. The BD address is written in the first column of the CSV file. After the DUT BD address up to five tests can exist.

Each of these tests must have the following columns in the correct order as described below:

- Memory type (DA14580/1/2/3/5/6 can have OTP, SPI, EEPROM and DA14681/2/3 can have OTP and QSPI),
- Start address
- Size of data in bytes
- Data to be written.

Iser Manual



Figure 27 shows an example of a CSV file targeted for DA14580 DUTs. In this particular example the CSV file contains information for DUTs with BD addresses 80:EA:CA:80:00:01 to 80:EA:CA:80:00:13. For BD addresses 80:EA:CA:80:00:04-05 there are three tests and two for the rest.

The first test, which is similar for all BD addresses with only the Data field to be different, is to write in the OTP Header memory of the DA14580 DUTs five bytes, in OTP address 0x47F54 (OTP Customer field).

The second test is identical for all DUTs. It is configured to write into the SPI flash address 0x8000 10 bytes (0x112233445566778899AA).

Finally the third test will only apply for BD addresses 80:EA:CA:80:00:04 and 80:EA:CA:80:00:05. This will write 256 bytes of data in address 0x9000 of the SPI flash memory.

6.12 Golden Unit Scan Test

This section describes the PLT Scan test procedure using the Golden Unit as scanner device.

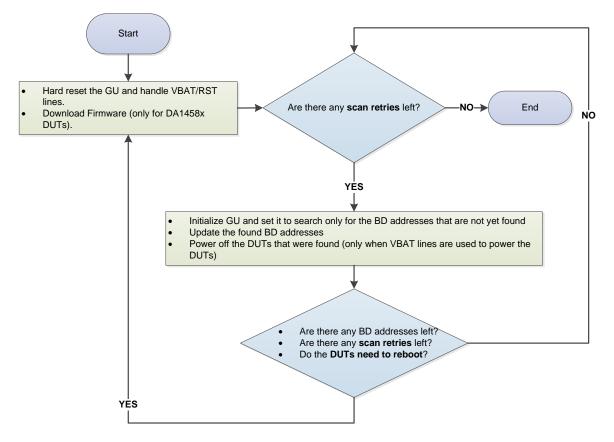


Figure 28: Golden Unit Scan Test

User can set various scan properties to adjust the Scan test procedure. The available properties that apply to the DA1458x devices are described Table 51 and for the DA1468x devices in Table 79.

Figure 28 shows the Scan sequence. First the Golden Unit and the DUTs are reset. At this stage if the *Firmware load enable* is active (option is available only in DA1458x DUTs) the PLT will download the selected firmware. Then the Golden Unit will begin scanning for the BD addresses of all active DUTs. After each Scan cycle, the already found BD addresses are removed from the search list of the Golden Unit and the appropriate DUTs will be powered off. This procedure will continue until the retries have reached the *Scan retries* set by the user. The PLT will reset the Golden Unit after a specific number or retries, given in *DUT reboot* option. Finally, the parameters *DUT reboot time* and

User Manual	Revision 4.3	03-Feb-2022





DUT reboot difference set the DUT time needed to perform a POR with a small delay between the DUTs if needed.

Enable		
Scan retries	6	
DUT reboot	3	
DUT reboot difference	37	
DUT reboot time	25	
👿 Firmware load enable	e	
Firmware path		binaries\prox_reporter_580.bin

Figure 29: Golden Unit Scan Test Example Parameters

Figure 29 shows an example for DA1580 DUT connected with *VBAT only* mode as described in VBAT/Reset Signals Operation. For this example the following steps will be executed.

- Reset the Golden Unit, power off the DUTs and wait for 2500ms. Power on and load prox_reporter_580.bin firmware to each DUT with a 37 ms time difference between them.
- Execute three Golden Unit scan procedures. After each scan procedure is finished power off the found DUTs.
- Again Reset the Golden Unit, power off the DUTs and wait for 2500ms. Power on and load prox_reporter_580.bin firmware to each DUT with a 37 ms time difference between them.
- Continue with another three Golden Unit scan procedures and after each scan procedure power off the found DUTs.

6.13 Creating Firmware Files under "binaries" Folder

In order for the PLT to work various firmware are used, based on the device type (Golden Unit or DUT), the chipset flavor (DA14580/1/2/3/5/6 or DA146801/2/3) or the purpose of the firmware (different firmware for production tests and for memory programming).

All these firmware are kept under the binaries folder on the PLT software package as shown in Figure 30. In order to create these firmware, the default SDK packages can be used, downloaded from the customer portal, and then apply to them the source code patches located under the fw_files folder in the PLT software package, shown in Figure 31.

nare with 🔻 New folder			
Name	Date modified	Туре	Size
鷆 GU	9/10/2017 7:03 μμ	File folder	
pxp_reporter_683_00.bin.cached	22/8/2017 5:36 µµ	CACHED File	79 KB
pxp_reporter_681_01.bin.cached	22/8/2017 5:36 µµ	CACHED File	81 KE
pxp_reporter_681_00.bin.cached	4/7/2017 4:56 μμ	CACHED File	118 KE
uartboot_681_01.bin	14/9/2017 11:53 πμ	BIN File	24 KE
uartboot_681_00.bin	28/11/2016 2:35 μμ	BIN File	15 KI
prox_reporter_585.bin	4/7/2017 4:56 μμ	BIN File	26 KI
prox_reporter_580.bin	4/7/2017 4:56 μμ	BIN File	27 KI
prod_test_683_00.bin	22/8/2017 4:15 µµ	BIN File	61 K
prod_test_681_01.bin	22/8/2017 4:54 μμ	BIN File	63 KI
prod_test_681_00.bin	18/11/2016 10:20 πμ	BIN File	54 KE
prod_test_585_def.bin	4/7/2017 4:56 µµ	BIN File	19 KI
prod_test_585.bin	4/10/2017 2:08 µµ	BIN File	24 KI
prod_test_582.bin	4/7/2017 12:19 μμ	BIN File	27 Ki
prod_test_581.bin	4/7/2017 12:19 μμ	BIN File	20 KE
prod_test_580.bin	4/7/2017 11:45 πμ	BIN File	24 KE
flash_programmer_585.bin	4/7/2017 1:09 μμ	BIN File	9 KI
flash_programmer_580.bin	4/7/2017 4:56 μμ	BIN File	8 KE
ble_app_barebone_580.bin	30/6/2017 3:58 µµ	BIN File	18 KE

Figure 30: Binaries

The source code patches maintain the folder structure of the SDK they are targeting, in order to apply the source code patch using a simple copy and replace to the files needed. After that the projects contain all the necessary changes and the same firmware can be built as those in the binaries folder of the PLT software package.

The "fw_files" folder has two main categories. Firmware targeted for the Golden Unit and for the DUTs. Under each category there is a folder indicating the IC target and then the SDK that is used.

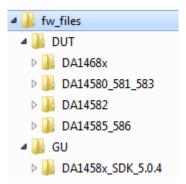


Figure 31: "fw_files" Folder Contents

Applying a source code patch for each one of the binaries is described below.

Golden Unit – Production Test Firmware

The Golden Unit is a DA1580 device. A modified version of the prod_test_580.bin firmware is used.

This patch contains all the changes needed to re-create the following firmware:

• prod_test_GU.bin

In order to re-create the exact source code of the prod_test_GU.bin firmware:

- 1. Use a clean copy of the DA1458x_SDK_5.0.4 SDK from the customer portal.
- 2. Copy all the contents from the "...\fw_files\GU\DA1458x_SDK_5.0.4\DA1458x_SDK\5.0.4\" folder to the default SDK.
- 3. The Keil v5 project file of the prod_test_GU.bin is the "prod_test.uvprojx" under the folder "\5.0.4\projects\target_apps\prod_test\prod_test\Keil_5\".

User	Manual

DA14580/1/2/3 – Production Test Firmware, Flash Programmer Firmware, Proximity Reporter, BLE App Barebone

This patch contains all the changes needed to re-creates the following firmwares:

- prod_test_580.bin
- prod_test_581.bin
- flash_programmer_580.bin
- prox_reporter_580.bin
- ble_app_barebone_580.bin

Note: Due to functional differences between the DA14580 and DA14581 chips, a different production test firmware for each IC is needed.

Note: Because DA14582 supports Audio test, another patch must be applied over this, in order to create a production test firmware that supports audio test for the DA14582 DUTs, as described later.

In order to re-create the exact source code of the above firmwares:

- 1. Use a clean copy of the DA1458x_SDK_5.0.4 SDK from the customer portal.
- Copy all the contents from the "...\fw_files\DUT\DA14580_581_583\DA1458x_SDK_5.0.4\DA1458x_SDK\5.0.4\" folder to the default SDK.
- The Keil v5 project file of the prod_test_580.bin and prod_test_581.bin is the "prod_test.uvprojx" under the folder
 "\5.0.4\projects\target_apps\prod_test\prod_test\Keil_5\". To select between the
 DA14580 and DA14581 there is a "Select Target" option next to the project properties.
- 4. The Keil v5 project file of the flash_programmer_580.bin is the "programmer.uvprojx" under the folder "\5.0.4\utilities\flash_programmer\". Make sure that "programmer_uart" option is selected under "Select Target".
- 5. The Keil v5 project file of the prox_reporter_580.bin is the "prox_reporter.uvprojx" under the folder "\5.0.4\projects\target apps\ble examples\prox reporter\Keil 5\".
- 6. The Keil v5 project file of the ble_app_barebone_580.bin is the "ble_app_barebone.uvprojx" under the folder "\5.0.4\projects\target_apps\ble_examples\ble_app_barebone\Keil_5\".

Note: The PLT uses the same firmware for DA14583 and DA14580, so there is no need for a different production test binary.

DA14582 – Production Test Firmware supporting Audio test

This patch contains all the changes needed to re-creates the following firmwares:

• prod_test_582.bin

Note: This patch requires applying the DA14580/1/2/3 – Production Test Firmware, Flash Programmer Firmware, Proximity Reporter patch first.

In order to re-create the exact source code of the above firmware:

- 1. Use the modified SDK version as described in the above section.
- 2. Copy all the contents from the "...\fw_files\DUT\DA14582\DA1458x_SDK_5.0.4\DA1458x_SDK\5.0.4\" folder to the current SDK.
- 3. The Keil v5 project file of the prod_test_582.bin is the "prod_test.uvprojx" under the folder "\5.0.4\projects\target_apps\prod_test\prod_test\Keil_5\". In "Select Target" option select the "prod_test_580", "clean" and "build" the project.

User Manual



DA1458x/DA1468x Production Line Tool

DA14585/6 – Production Test Firmware, Flash Programmer Firmware, Proximity Reporter

This patch contains all the changes needed to re-creates the following firmwares:

- prod_test_585.bin
- flash_programmer_585.bin
- prox_reporter_585.bin

In order to re-create the exact source code of the above firmwares:

- 1. Use a clean copy of the DA14585_SDK_6.0.4.326 from the customer portal.
- 2. Copy all the contents from the "...\fw_files\DUT\DA14585_586\DA14585_SDK_6.0.4.326\DA14585_SDK\6.0.4.326\" folder to the default SDK.
- 3. The Keil v5 project file of the prod_test_585. bin is the "prod_test.uvprojx" under the folder "\6.0.4.326\projects\target apps\prod test\prod test\Keil 5\".
- 4. The Keil v5 project file of the flash_programmer_585.bin is the "programmer.uvprojx" under the folder \6.0.4.326\utilities\flash_programmer\". Make sure that "programmer_uart" option is selected under "Select Target".
- 5. The Keil v5 project file of the prox_reporter_585.bin is the "prox_reporter.uvprojx" under the folder "\6.0.4.326\projects\target_apps\ble_examples\prox_reporter\Keil_5\".

DA14681/2/3 – Production Test Firmware, Uartboot Firmware, Proximity Reporter

This patch contains all the changes needed to re-creates the following firmware:

- prod_test_681_01.bin
- prod_test_683_00.bin
- uartboot_681_01.bin
- pxp_reporter_681_01.bin.cached
- pxp_reporter_683_00.bin.cached

In order to re-create the exact source code of the above firmwares:

- 1. Use a clean copy of the DA1468x_DA15xxx_SDK_1.0.10.1072 from the customer portal.
- 2. Copy all the contents from the "...\fw_files\DUT\DA1468x-DA15xxx\DA1468x DA15xxx SDK 1.0.10.1072\" folder to the default SDK.
- The Smart Snippets Studio project file of the prod_test_681_01.bin and prod_test_683_00.bin is the "plt_fw" under the folder
 "...\DA1468x_DA15xxx_SDK_1.0.10.1072\projects\dk_apps\reference_designs\plt_fw". To create each binary, select from the drop down menu the "Release RAM" option for each chip.
- 4. The Smart Snippets Studio project file of the uartboot_681_01.bin is the "uartboot" under the folder "...\DA1468x_DA15xxx_SDK_1.0.10.1072\sdk\bsp\system\loaders\uartboot\". To create the binary, select from the drop down menu the "Release" option.
- 5. The Smart Snippets Studio project file of the pxp_reporter_681_01.bin.cached and pxp_reporter_683_00.bin.cached is the "pxp_reporter" under the folder "...\DA1468x_DA15xxx_SDK_1.0.10.1072\projects\dk_apps\demos\pxp_reporter\". To create each binary, select from the drop down menu the "QSPI_Release" option for each chip.

Each binary will be created under the project folder in a folder having the same name as the selected option.

User Manual	Revision 4.3	03-Feb-2022



Note: The pxp_reporter source code generates a .bin file. In order to write it to the QSPI Flash memory and boot from it, a .cached version of the binary must be created using the "bin2image.exe". See 0 for more details.

7 Applications

7.1 Introduction

The PLT software includes three different applications (Table 5). The CFG PLT is used to setup the system according to the device hardware options and select the required tests and memory actions to be performed. The GUI and the CLI PLT applications are used to perform the tests, monitor their progress in real-time and view the test results.

7.2 **CFG PLT Application**

DA1458x/DA1468x Production Line Tool Configuration - v_4.x.x.x									
File Run	_								
Hardware Setup	General	BD addresses	UART	Test Settings	Memory Functions	Memory Header	Debug Settings	Security	
▼ Station Identi	fication								
Device IC									
▼ Active DUTs									
▼ DUT COM Po	orts								
▼ Golden Unit (COM Port								
VBAT/Reset N	Node								
C:\DA1458x_DA1468x_PLT_v4_x\params\params.xml									
DA14580									

Note 1 Each Hardware Setup field can be minimized by clicking on it, but it will not be disabled. The tests will run if they are enabled, even when the test field is minimized and not shown.

Figure 32: CFG PLT Startup Screen

The CFG PLT application (DA1458x_DA1468x_CFG_PLT.exe) is a GUI application tool, which is mainly used to appropriately configure the tests and memory operations the tool will perform. Depending on the selected device chipset and the enabled actions, only appropriate options are enabled and shown. Any change made by the user is validated before being saved to the XML file, with the use of a schema XSD file. This prevents erroneous values to be stored in the XML file that would harm the production procedure.

Figure 32 shows the initial CFG PLT screen. The Main Menu options are described in Table 18 and the bottom strip information is described in Table 19. The application begins with the **Hardware Setup** tab (see section 7.2.2). Users can navigate to the other PLT configurable options by selecting the different tabs.

When a tab is selected, the settings of this tab are reloaded from the XML file. If there is an error in the configuration file for a specific parameter, a warning message will be shown indicating which of the parameters has error. Additionally, the related graphic entry in the CFG application for the erroneous configuration parameter will be highlighted in red.

An example is given in Figure 33. Configuration parameter dut_num_1 has wrong value (error instead of either false or true) in the params.xml file. When the **Hardware Setup** CFG tab is selected the Warning message will be displayed and if **OK** is pressed the **Hardware Setup** tab will be loaded with the DUT 1 checkbox in red and the displayed value will be the default value taken from the XML schema document (params.xsd).



	<du< th=""><th></th><th>[s> ror<mark> Lse<th></th></mark></th></du<>		[s> ror <mark> Lse<th></th></mark>	
	Warning	Failed to load Tab	Page: {Hardware Setup} lut_nurm_1](0] is not vali	
Active DUTs DUT 1 DUT 2 DUT 3 DUT 4	DUT 5 DUT 6 DUT 7 DUT 8	DUT 9 DUT 10 DUT 11 DUT 12	DUT 13 DUT 14 DUT 15 DUT 16	

Figure 33: CFG PLT with Erroneous Configuration Parameter

When the user makes a change, the **Save** button will become **Save*** to indicate that a save is required.

In case of a configuration parameter error, pressing **Save** will save the default parameter value, overwriting the erroneous value.

Region	Option	Description
File	Open XML file	Opens a new XML file and loads its settings. The full path of the new XML file is shown at the bottom end of the screen.
	View XML file	Opens the XML file in notepad.
	Save as	Exports all settings to a new XML file. The full path of the new XML file is shown at the bottom end of the screen.
	Reset to defaults	Overwrites all parameters options in the XML file with their default values taken from the XSD file.
	Exit	Exits the CFG PLT application.
Run Run GUI PLT		Opens the GUI PLT application.
	Run CLI PLT	Opens the CLI PLT application.

Table 18: CFG PLT Main Menu Options

Table 19: CFG PLT Bottom Strip Options

Option	Description
C:\Release\params\params.xml	Shows the full path of the XML file that is currently used.
DA14580	Shows the selected device IC.
Save	Saves all the options of the currently selected tab. E.g. If General settings tab is selected, then only the settings for this tab will be saved.

7.2.1 XML and XSD Files

The CFG PLT application is a front-end user interface for the cfg_dll.dll library (Figure 20). The cfg_dll.dll library, explained in detail in Ref. [1], is an XML parser, editor and parameter validator. It has an easy-to-use API for reading and manipulating the params.xml file. File params.xsd is the XML schema used for parameter validation.

User Manual



DA1458x/DA1468x Production Line Tool

In the CFG PLT application all user selectable options are loaded and saved inside the XML file, by effectively using the cfg_dll.dll library API. The XSD schema file params.xsd is not edited in any way but only read by the cfg_dll.dll library API, whenever parameter validation is needed.

The params.xml file is separated into three main parts as explained in Table 20.

Table 20: XML File Parts

Part Name	Example	Description
Common part	<programming_enable>true</programming_enable> <tests_enable>true</tests_enable> <retest_failed>false</retest_failed> </td <td>The main top part of the XML file contains parameters common to any DUT, like the BD address mode, the COM ports and which device is enabled or disabled. It also holds the debug parameters, the test statistics and the test station name used in the logs.</td>	The main top part of the XML file contains parameters common to any DUT, like the BD address mode, the COM ports and which device is enabled or disabled. It also holds the debug parameters, the test statistics and the test station name used in the logs.
DA1458x	<pre><!-- DA1458x--> <config_params_da1458x> <!----> <!-- UART--> <!-- UART--> <ur> <urt_boot_pins>4 <uart_change_pins>false</uart_change_pins> <uart_pin_tx>P0_4</uart_pin_tx> <uart_pin_rx>P1_5</uart_pin_rx> <uart_baud_rate></uart_baud_rate></urt_boot_pins></ur></config_params_da1458x></pre>	The second XML part, with the element name config_params_da1458x, holds parameters used by DA1458x devices. Under this part all the test and the memory action settings are stored.
DA1468x	<pre><!-- DA1468x--> <config_params_da1468x></config_params_da1468x></pre>	The third and final XML part, with the element name config_params_da1468x, holds parameters used by DA1468x devices. Under this part all the test and the memory action settings are stored.

The XSD schema file, params.xsd, holds information about the overall structure of the params.xml file, the default and valid values a parameter can take and useful help information about the purpose of each parameter. An example part of the XSD file is given in Figure 34.

DA1458x/DA1468x Production Line Tool

```
<xs:element name="next bd addr"</pre>
            type="x:cfg_hex_array_6_bytes"
            x:use="required"
             x:default="00:00:00:00:00:01"
             x:info="The BD address of the first active DUT that will be used in the next test run. "/>
<!--cfg_hex_array_6_bytes-->
<xs:simpleType name="cfg_hex_array_6_bytes">
    xs:restriction base="xs:string"
        <xs:pattern value="([0-9A-Fa-f]|[0-9A-Fa-f][0-9A-Fa-f]][0-9A-Fa-f][0-9A-Fa-f]][0-9A-Fa-f]]]</pre>
    </xs:restriction>
</xs:simpleType>
<xs:element name="RF_path_loss_DUT_1"</pre>
            type="x:cfg dut path losses"
            x:use="required"
            x:default="0"
            x:info="Set the RF path losses in dB between the device and the GU or the BLE tester instrument."/>
<!--cfg dut path losses-->
<xs:simpleType name="cfg_dut_path_losses">
     <xs:restriction base="xs:float">
         <xs:minInclusive value="0"/>
         <xs:maxInclusive value="40"/>
     </xs:restriction>
 </xs:simpleTvpe>
▲ RF Tests
   Golden Unit
                                   Set the RF path losses in dBm between the device and the GU or the BLE tester instrument.
                          Path loss
 BLE Tester
   Path losses per DUT
                                   0'00
                          DUT 1
                                           DUT 5
                                                    0.00
                                                                     0.00
                                                                                      0.00
                                   0.00
                                                    0.00
                                                                     0.00
                                                                              DUT 14
                                                                                       0.00
                                   0.00
                                                    0.00
                                                                     0.00
                                                                                      0.00
                                                    0.00
                                                                     0.00
                          DUT 4
                                   0.00
                                           DUT 8
                                                                              DUT 16
                                                                                      0.00
```

Figure 34: XSD Schema File Example

Element $next_bd_addr$ holds the Next BD address, as described in section 7.2.4.1 and Table 29. It has a default value of x:default="00:00:00:00:00:01". This default value will be returned by the cfg_dll.dll API if the XML file has an error entry in the equivalent $next_bd_addr$ element, since the validation of the parameter will fail.

The x:info="The BD address ..." value will be loaded by the cfg_dll.dll API and be used in the CFG PLT tooltips. The type="x:cfg:hex_array_6_bytes" defines the parameter type. This is the actual XSD entry that is used for the parameter validation. The cfg:hex_array_6_bytes type is defined later in the file and has a rather complicated pattern defined with <xs:pattern value ="([0-9A-Fa-f]..."/>. If the next_bd_addr element in the XML file has a value that does not match this pattern, the validation of the parameter will fail and the cfg_dll.dll API will return the default value (00:00:00:00:01). In the CFG PLT, the default value will be shown in red, indicating that an error exists in the params.xml file for this parameter. It will not change the erroneous value will overwrite the erroneous value.

In the second example of Figure 34, the RF_path_loss_DUT_1 XSD element is shown. This element is used in the Path Losses per DUT as shown in Figure 57. This element has a default value of 0 and the allowed values are floats, between <xs:minInclusive value="0"/> and <xs:maxInclusive value="40"/>, as shown in the cfg_dut_path_losses type description. The x:info="Set the RF path .."/> will be loaded by the cfg_dll.dll API and used in the CFG PLT tooltips as shown in the bottom part of Figure 34.

7.2.2 Hardware Setup

This section describes the Hardware Setup settings available for the PLT hardware board, as shown in Figure 32.

User Manual	Revision 4.3	03-Feb-2022



DA1458x/DA1468x Production Line Tool

7.2.2.1 Station Identification

Station Identification				
Station ID	Test_station_1			

Figure 35: Station Identification

This field holds a name given by the user to distinguish between different test stations. The value of this field is written into the DUT log files. Table 21 describes the available options for the *Station Identification*.

Table 21: Station Identification

Option	Description	
Station ID	The name of the PLT test station.	

7.2.2.2 Device IC



Figure 36: Device IC

Users can select the device IC type. This option will also change any IC related graphics, such as selectable tabs and tests. Table 22 describes the available options for the *Device IC*.

Table 22: Device IC

Option	Description
Device IC	The Dialog BLE chipset used in the device under test.

7.2.2.3 Active DUTs

			Active DUTs
📝 DUT 13	DUT 9	DUT 5	📝 DUT 1
📝 DUT 14	DUT 10	DUT 6	DUT 2
DUT 15	DUT 11	🔽 DUT 7	V DUT 3
📝 DUT 16	DUT 12	DUT 8	DUT 4

Figure 37: Active DUTs

Enables or disables the testing for each DUT. Table 23 describes the available options for the *Active DUT*.

Table 23: Active DUTs

Option	Description	
DUT1-16	Enables the specific DUT device placed on connector DUT1-DUT16.	

User Manual



DA1458x/DA1468x Production Line Tool

7.2.2.4 DUT COM Ports

▲ DUT COM F	Ports			
DUT 1 157	DUT 5 161	DUT 9 165	DUT 13 169	
DUT 2 158	DUT 6 162	DUT 10 166	DUT 14 170	
DUT 3 159	DUT 7 163	DUT 11 167	DUT 15 171	
DUT 4 160	DUT 8 164	DUT 12 168	DUT 16 172	
Enum	Reset			

Figure 38: DUT COM Ports

This field shows the Windows COM port assigned to each DUT. The table is filled only when the 'COM Enum' action has been performed by the CFG or the GUI PLT applications, or when non-zero entries exist in the com_port_x params.xml options. When the 'COM Enum' action is performed, the tools will automatically find the DUT COM ports and save them in the params.xml file. These values will be read by the CFG PLT application and be displayed here. When a 'COM Enum' action has not been performed, the GUI PLT will automatically run it once in every first test execution.

Note: Great care must be taken when the params.xml file is shared across different stations, where different DUT COM Ports will probably exist. The 'COM Enum' action should then be performed again, so the new COM ports of the new PC system are identified and updated in the XML file.

Table 24 describes the available options for the DUT COM Ports.

Option	Description
DUT1-16	Shows the Widows COM port assigned to a specific DUT.
Reset	Sets all values to zero.
Enum	Executes the COM port enumeration procedure. The found COM ports are shown before being saved.

Table 24: DUT COM Ports

7.2.2.5 Golden Unit Port Selection



Figure 39: Golden Unit COM Port

This field holds the Golden Unit COM port. Manual or automatic COM port find can be selected.

The Golden Unit COM port can be manually selected from the list with all the available COM ports existing in the system. Additionally, it can automatically be found by pressing the **Auto** button. The automatic procedure searches the serial number of all system COM ports to find the "DialogSemi" string. Details on how to program the serial number in the GU FTDI can be found in Appendix G.

Option	Description
Auto	Initiates the automatic Golden Unit COM port find procedure.
Refresh	Refreshes the Dropdown menu with all the available system COM ports.
Dropdown Menu	Manually select the Golden Unit COM port from all of the available system COM ports.

Table 25: Golden Unit COM Port

User Manual



DA1458x/DA1468x Production Line Tool

7.2.2.6 VBAT/Reset Mode

▲ VBAT/Reset Mode				
VBAT low duration 2000 ms Reset duration 50 ms				
VBAT/Reset Mode VBAT Only	VBAT ov	Production test firmware download and perform tests	Flash programmer firmware download and perform memory actions	
	RESET			
	0V			

Figure 40: VBAT/Reset Mode Selection

This field holds the VBAT/Reset mode selections. This option sets the PLT VBAT and PLT Reset line modes for the DUT power supply and reset during the PLT test sequence. Table 26 describes the available selections.

Table 26: VBAT/Reset Mode

Option	Description
VBAT/Reset Mode	Select the operation for VBAT/Reset signals. Available options are:
	VBAT Only
	VBAT On with Reset
	VBAT as Reset
	VBAT and Reset
	VBAT/Reset Signals Operation chapter describes each mode in detail. Default setting is VBAT only.

7.2.3 General

7.2.3.1 Statistics



Figure 41: Statistics

This field holds the test result statistics. Table 27 describes the Statistics field.

Table 27: Statistics

Option	Description		
Pass	Shows the number of DUTs that have successfully passed all the tests.		
Fail	Shows the number of DUTs that have failed the tests.		
Total	Shows the number of DUTs that will be tested. This option is available only when <i>Range</i> mode is enabled in the BD Address Assignment.		
Left	Shows how many DUTs are still to be tested. This option is available only when <i>Range</i> mode is enabled in the BD Address Assignment.		

User Manual



DA1458x/DA1468x Production Line Tool

Option	Description
Runs	Shows the number of test runs the PLT has performed.
Reset	Pressing the Reset button clears all statistics values to their defaults. Values <i>Pass, Fail</i> and <i>Runs</i> will be set to zero. If <i>Range</i> mode is enabled in the BD Address Assignment, the <i>Total</i> and <i>Left</i> values will be set as the difference of <i>Next</i> and <i>End BD</i> address, otherwise will be set to zero.

7.2.3.2 Test Options

	Test Options				
1	Production tests				
	Download the production test firmware using the uart memory programmer firmware (uartboot bin)				
1	Memory programming				
1	Retest failed DUTs				
V	I Enable VBAT and UART at the end of the tests				
	Reset VBAT				
V	Run script before testing starts				
	Script path scripts\\run_before_tests.cmd				
1	Run script when testing is finished				
	Script path scripts\\vun_after_tests.cmd				

Figure 42: Test Options

This field holds generic PLT test procedure options. The PLT procedure is split into two main parts: *Production tests* and *Memory programming*.

Production tests include all the tests under Test Settings (DA1458x) or Test Settings (DA1468x). *Memory Programming* includes all the tests under Memory Functions (DA1458x) or Memory Functions (DA1468x) and Memory Header (DA1458x) or Memory Header (DA1468x).

Table 28 describes the available settings for the Test Options.

Table 28: Test Options

Option	Description			
Production tests	This option enables the production test operations.			
Download the production test firmware using the UART memory programmer firmware (uartboot.bin). (Only for DA14681/2/3 Devices)	This option enables downloading the production test firmware using the memory programming firmware. PLT will first reset the DUTs and download the memory programming firmware (uartboot.bin), then it will send the production test firmware to the DUTs and by using a special command it will replace the firmware and the DUTs will automatically reset to the new firmware.			
Memory programming	This option enables the memory programming operations.			
Re-test failed DUTs	When this option is enabled, any DUT that failed will immediately be retested with the exact same options, including the <i>BD address</i> assigned to it. This option is the same as option <i>Retest failed DUTs - Enable</i> under GUI PLT Settings.			
Enable VBAT and UART at the end of the tests	Enables the VBAT lines and UART communication between the PC and the devices after all tests have finished, in order sustaining communication with the DUTs, optionally with the latest downloaded firmware.			
Reset VBAT	If this option is enabled the VBAT line will be toggled. If not selected, the DUTs will keep in RAM the last test firmware downloaded by the PLT.			

User Manual



Option	Description
Run script before testing starts	This option enables the execution of a batch or an executable before the device testing procedure starts. The success return code should be 0 for the tool not to report an error.
Script path	The path of file to execute when the Run script before testing starts option is enabled.
Run script when testing is finished	This option enables the execution of a batch or an executable after the device testing procedure has finished. The success return code should be 0 for the tool not to report an error.
Script path	The path of file to execute when the <i>Run script when testing is finished</i> option is enabled.

7.2.4 BD Addresses

7.2.4.1 BD Address Assignment

▲ BD Address Assignment					
Â	If 'Start BD address field' is changed then, the 'Next BD address field' will take the same value. Next PLT test run will then set the updated Next BD address to the first active DUT.				
۲	Standard				
	Start BD address	00:00:00:00:00:01			
	Next BD address	00 : 00 : 00 : 00 : 01 On Save the 'Next BD address' value will take the 'Start BD address' value.			
\bigcirc	Range				
	Start BD address	00 : 00 : 00 : 00 : 01			
	Next BD address	00 : 00 : 00 : 00 : 01			
	End BD address	00 : 00 : 00 : 00 : 01			
\bigcirc	Load from file				
	Start BD address	00 : 00 : 00 : 00 : 01			
	Next BD address	00:00:00:00:00:01			
	BD address file	params/\bd_address.ini			
	Check for dupli	icate BD addresses			
\bigcirc	Barcode Scanner				
	Scanner interface	Refresh COM1 -			
	Scan mode	Automatic DUT position			

Figure 43: BD Address Assignment

The *BD* Address Assignment field defines different ways the PLT can handle the device BD address. The available modes are *Standard*, *Range*, *Load from file* and *Scan* mode.

The *Standard*, *Range*, and *Load from file* modes are similar. All of these have a *Start BD address*, which is the initial address at which the PLT session begins. The *Next BD address* field holds the BD address that will be used on the next PLT run, so the BD address assignment can be continued even after the GUI PLT is closed. For that reason, the *Next BD address* cannot be altered by the user. The *Next BD address* initial value is the same as the *Start BD address* when the PLT session begins.

For *Scan* mode an external barcode scanner is needed to assign the device BD addresses.

Note: In CFG PLT only the Start BD address is given. The assignment of the actual device BD addresses occurs in the GUI PLT at the beginning of each test run.

Note: The only invalid BD address is 00:00:00:00:00:00.

Standard Mode

Table 29 describes the available options for the *Standard* mode. In this mode the first active DUT takes the *Next BD address*. This BD address is incremented by one and assigned to the next active DUT until all active DUTs have a BD address assigned to them.

This assignment mode never runs out of BD addresses and it will continue assigning addresses until the *Next BD address* reaches FF:FF:FF:FF:FF:FF.

Table 29: BD Address Assignment - Standard Mode

Option	Description	
Start BD address	The BD address that the PLT session has started with.	
Next BD address	The BD address that will be used in the first active DUT of the next PLT run.	

Range Mode

Table 30 describes the available options for the *Range* mode. This mode is the same as *Standard* mode except for the additional *End BD address*.

Since both a Start BD and an End BD address exists, the total amount of devices to be tested can be calculated. Therefore, this mode enables the *Total* and *Left* fields in the Statistics, where *Total* is the number of the BD addresses to be used from *Start BD* address to *End BD* address and *Left* is the number of BD addresses remaining, which are the ones from *Next BD* address to *End BD* address.

Note: The *End BD address* must always be greater than the *Start BD address*. Also, when *Left* BD addresses are not enough for the remaining active DUTs, the PLT will not run.

Option	Description	
Start BD address	The BD address that the PLT session has started with.	
Next BD address	The BD address that will be used in the first active DUT of the next PLT run.	
End BD address	The BD address that the PLT session will end with.	

Table 30: BD Address Assignment Options - Range Mode

Load from File Mode

Table 31 describes the available options for the *Load from file* mode. In this mode, the *Start BD* address and the *Next BD* address have the same roles as before. The difference in this mode is that the BD addresses are loaded from a file in the order as they are written in that file, not using the automatic incremental method of the previous modes. In every test run the PLT will search for the first occurrence of the *Next BD* address in the file and will load it along with the BD addresses that follow, until all active DUTs have a BD address.

1	00:00:00:44:33:0a
2	00:00:00:44:33:09
3	00:00:00:44:33:08
4	00:00:00:11:22:08
5	00:00:00:11:22:06
6	00:00:00:11:22:05
7	00:00:00:11:22:04
8	00:00:00:11:22:03
9	00:00:00:11:22:02

Figure 44: Example for Load from File Mode

For example, consider three active DUTs: DUT3, DUT6, and DUT 9 and the *Next BD address* to be 00:00:00:11:22:08. Figure 44 shows the beginning of the BD address file used in this example. The PLT will search for the *Next BD address* in the file and load it to the first active DUT: DUT3. It will

lleor	Manua
USCI	manua



then continue with 00:00:00:11:22:06 for DUT6 and 00:00:00:11:22:05 for DUT9. It will also return 00:00:00:11:22:04 as the *Next BD address* to be used in the next PLT test run.

Note: The BD address file should always end with a zero BD address (00:00:00:00:00:00) and a new line at the end.

Table 31: BD	Address Assi	anment O	ntions - L	oad from	File Mode
	Audi 633 A33	ginnent O	puons - L		

Option	Description		
Start BD address	The BD address that the PLT session has started with.		
Next BD address	The BD address from file that will be used in the first active DUT of the next PLT run.		
BD address file	Path to the file that contains the BD addresses. Use button [] on the right to navigate and select a file.		
Check for duplicate BD addresses	Before any BD address is assignment happens, there will be a check to find double BD addresses in the selected BD address file.		

Scan Mode

Table 32 describes the available options for the *Scan* mode. For this option a USB-to-Serial barcode scanner should be used to scan for BD address barcodes with "xx:xx:xx:xx:xx" format.

The Barcode scanner options are the same as those used for the barcode scanner mode in Custom Memory Data for the DA1458x devices and in Custom Memory Data for the DA1468x devices.

Table 32: BD Address	Assignment	Options -	Scan Mode
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Option	Description
Scanner Interface	Selection of the barcode scanner COM port from a dropdown list with all the available system COM ports.
	A common USB to UART barcode scanner is supported. PLT has been tested with Honeywell Xenon 1900. Appendix K describes the setup procedure.
	This option is the exact same option as for the DA1458x devices in Custom Memory Data and the DA1468x devices in Custom Memory Data.
Scan mode	Scan DUT position: In this mode the users must first scan the DUT position number and then the BD address. The string used for the position of each DUT is "TEST POSITION 0xx" where "xx" is the DUT position number.
	Automatic DUT position: Scanned BD address will be assigned to the selected DUT. The DUT selection is automatically been made, starting from the first active DUT and selecting the next one after a successful BD address scan. Users can change the selected DUT using the controls on the GUI PLT screen shown in Figure 102.
	This option is the exact same option as for the DA1458x devices in Custom Memory Data and the DA1468x devices in Custom Memory Data.

7.2.5 UART (DA1458x)

7.2.5.1 UART Boot Pins Setup

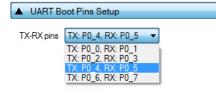


Figure 45: UART Boot Pins Setup - DA1458x

Table 33 describes the available options for the *TX-RX pins* of the *UART Boot Pins Setup* DA1458x options. *The TX-RX pins* selection defines the UART pins and the baud rate that will be used for firmware downloading to the DA1458x during booting.

User	Manual	
0301	manual	

Table 33: UART TX-RX Pins - DA1458x

Option	Description
TX: P0_0, RX: P0_1	Sets UART TX pin to P0_0, UART RX pin to P0_1 and Baud rate to 57600 bit/s.
TX: P0_2, RX: P0_3	Sets UART TX pin to P0_2, UART RX pin to P0_3 and Baud rate to 115200 bit/s.
TX: P0_4, RX: P0_5	Sets UART TX pin to P0_4, UART RX pin to P0_5 and Baud rate to 57600 bit/s.
TX: P0_6, RX: P0_7	Sets UART TX pin to P0_6, UART RX pin to P0_7 and Baud rate to 9600 bit/s.

Note: The baud rate is fixed during booting, since it is controlled by the device ROM bootloader.

7.2.5.2 UART Baud Rate

🔺 UART B	aud Rate					
Baud Rate	1000000 ▼ 9600 57600 115200 1000000					

Figure 46: UART Baud Rate - DA1458x

Table 34 shows the available options for the UART baud rate.

The *Baud Rate* selected here is used after the initial firmware (flash_programmer.bin) has been downloaded to the DUT. The software will send a command to the DUT to change the UART baud rate to the one selected. All following UART communications with the DUT will be performed using the new baud rate. Please note that this happening only during memory programming where the flash_programmer.bin is used. During tests (RF tests, XTAL trimming, etc.), where the production test firmware is used, the baud rate is fixed at 115200 bit/s.

Table 34: UART Baud Rate - DA1458x

Option	Description
Baud Rate	• 9600 [bit/s]
	• 57600 [bit/s]
	• 115200 [bit/s]
	• 1000000 [bit/s]
	Note: 1 Mbit/s is the fastest and safest with 0% baud rate error.

7.2.5.3 UART Programming GPIOs Setup

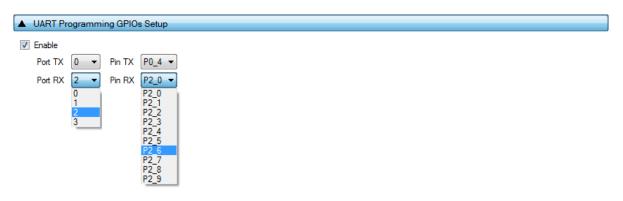


Figure 47: UART Programming GPIOs Setup - DA1458x

 Table 35 shows the available options for the UART Programming GPIOs to be used during memory programming for the DA1458x devices.

User Manual	Revision 4.3	03-Feb-2022

Note: This option should be **disabled** if the UART Programming GPIOs are exactly the same as the UART Boot Pins selected in UART Boot Pins Setup.

When this option is enabled, the user can configure a new set of UART pins to be used during tests and memory programming. The purpose of changing pins is to be able to use different UART pins than the predefined pairs supported by the DUT ROM bootloader, in case these default pins are used for other external components.

The DUT will always boot from a predefined pair of pins as configured in the *UART Boot Pins Setup*. Then it will switch to the new pins configured here by sending a command to the firmware, for both the *Production tests* and the *Memory programming* firmware. A separate UART hardware connection has to be made between the PLT hardware board and the DUT.

The DUT will have four UART connections with the PLT hardware. The connections should be made using enhanced PLT DUT connectors. For a single DUT, the UART boot pins should be connected to the PLT DUT connector 1 (DUT1) and the UART Programming GPIOs should be connected to the PLT DUT connector 2 (DUT2). In this configuration the PLT can support up to eight DUTs.

Table 35: UART Programming GPIOs Setup - DA1458x

Option	Description
Enable	This option enables the UART programming mode. Users can select the new UART TX-RX GPIOs from the dropdown lists.
Port TX	Dropdown list to select the port of the UART TX GPIO that will be used during testing. This option alters the contents of the <i>Pin TX</i> dropdown list to the available GPIOs based on the selected port.
Pin TX	Dropdown list to select the UART TX GPIO that will be used during testing.
Port RX	Dropdown list to select the port of the UART RX GPIO that will be used during testing. This option alters the contents of the <i>Pin RX</i> dropdown list to the available GPIOs based on the selected port.
Pin RX	Dropdown list to select the UART RX GPIO that will be used during testing.

7.2.6 Test Settings (DA1458x)

7.2.6.1 XTAL Trim

▲ XTAL Trim				
Enable GPIO input pulse pir Burn to OTP	P0_5 -			

Figure 48: XTAL Trim - DA1458x

Table 36 describes the available options for the DA1458x XTAL Trim operation.

Table	36:	XTAL	Trim -	DA1458x
-------	-----	------	--------	---------

Option	Description
Enable	This option enables the automatic crystal oscillator frequency calibration procedure.
GPIO input pulse pin	The GPIO on which the DUT will receive the reference pulse during calibration. The UART RX pin can be used for this purpose without any additional connection from the PLT hardware to the DUT.
Burn to OTP	When this option is selected, the XTAL trim value calculated from the automated calibration process will be written into the OTP XTAL trim header field and the OTP XTAL calibration flag will be set.

User Manual

7.2.6.2 RF Tests

This section refers to various RF tests conducted between the DUTs and the Golden Unit or an external BLE tester.

These tests can have multiple instances with different settings. Tests can be added and removed using the two buttons (e.g. and fin Figure 49) at the bottom right side of each panel.

Note: When adding or removing a test, all settings are refreshed with the values written to the XML file, meaning that any unsaved settings will be lost.

Golden Unit

▲ RF Tests	
Golden Unit	RF RX test settings using the Golden Unit. GU_RSSI_1 (*) GU_RSSI_2 (*) GU_RSSI_3 (*) © Enable Test name GU_RSSI_1 Settings Frequency 2424 • MHz Limits RSSI limit >= -70.0 dBm

Figure 49: Golden Unit RF Tests - DA1458x

Table 37 describes the available options for the RF RX test using the Golden Unit as a transmitter.

In the RF RX test the Golden Unit sends 500 packets on the selected BLE channel. The DUTs are set in receive mode and the RSSI is measured. If the RSSI measured by the DUT reception is less than the specified *RSSI limit* value, the device will fail and the tests will stop for that particular device.

Option	Description
Enable	This option enables the specific RF RX test using the Golden Unit as a transmitter.
Test name	The name assigned to each test. If this field is non-empty, then the assigned name will be shown on the tab and next to it an indication showing whether the specific test Is enabled or not.
Frequency	The BLE channel frequency used in the RF RX test using the Golden Unit.
RSSI limit	The RSSI limit for pass/fail criteria in the RF RX test using the Golden Unit. If the average RSSI of the device after it has received the packets transmitted from the Golden Unit is less than that the test will be considered as failed.

BLE Tester

In the *BLE Tester* panels a number of tests can be enabled that require an external BLE tester instrument. More detailed information about the BLE tester can be found in [1].



BLE Tester – General Settings

RF Tests	
Golden Unit General TX Power Frequency Offset Modulation Index RX Sensitivity Path losses per DUT	BLE tester general settings. ✓ Enable Settings Instrument mt8852b.dll Interface GPIB0::27

Figure 50: BLE Tester General Settings - DA1458x

Table 38 describes the general settings for the *BLE Tester* supported tests. Any available external instrument found by the ble tester driver DLL and their interfaces can be selected.

Option	Description
Enable	This option enables all of the BLE Tester tests, which include:
	BLE Tester TX Power
	Frequency Offset
	Modulation Index
	RX Sensitivity
Instrument	Select the BLE tester DLL name. Names are shown only if a BLE tester instrument DLL exists in the project ble_tester_instr_plugins folder.
Interface	The interface of the instrument to be used by the driver.

BLE Tester - TX Power

▲ RF Tests		
Golden Unit BLE Tester General Frequency Offset Modulation Index RX Sensitivity Path losses per DUT	BLE tester TX power test settings. TX_POW_1 (✓) TX_POW_2 (✓) TX_POW_3 (✓) ✓ Enable Test name TX_POW_1 Settings Frequency 2450 MHz Power range Auto ▼ Limits High Limit <= 10.00 dBm Low Limit >= -20.00 dBm Peak Average <= 3.00 dB	
		+

Figure 51: BLE Tester TX Power - DA1458x

User Manual	Revision 4.3	03-Feb-2022

Table 39 describes the available options for the *TX Power* test using a BLE Tester instrument.

Option	Description
Enable	This option enables the specific TX power test using a BLE tester instrument.
Test name	The name assigned to each test. If this field is non-empty, then the assigned name will be shown on the tab and next to it an indication showing whether the specific test Is enabled or not.
Frequency	The BLE channel frequency used in the BLE TX power test.
Power range	 Set the device TX output power range. Available options are: Auto (No auto option for Litepoint IQxeIM. Sets the instrument to trigger at -25dBm) +22 dBm to +7 dBm +9 dBm to -3 dBm +5 dBm to -7 dBm -4 dBm to -16 dBm -12 dBm to -26 dBm -24 dBm to -35 dBm
	Default value is <i>Auto.</i>
High limit	Set the average high power limit for the BLE TX output power pass/fail test criteria.
Low limit	Set the average low power limit for the BLE TX output power pass/fail test criteria.
Peak average	Set the peak-to-average power limit for the BLE TX output power pass/fail test criteria.

Table 39: BLE Tester TX Power - DA1458x

BLE Tester - Frequency Offset

▲ RF Tests		
Golden Unit BLE Tester General TX Power Prequency Offset Modulation Index RX Sensitivity Path losses per DUT	BLE tester TX frequency offset test settings. FREQ_OFFS_1 (✓) FREQ_OFFS_2 (✓) Image: Frequency FREQ_OFFS_1 Settings Frequency Imits Power range Positive Limit <=	

Figure 52: BLE Tester Frequency Offset - DA1458x

Table 40 describes the available options for the *Frequency Offset* test using a BLE Tester instrument.

if a TV fraguanay affect toot using a PLE tester instrument
ific TX frequency offset test using a BLE tester instrument.
test. If this field is non-empty, then the assigned name will tt to it an indication showing whether the specific test Is

Table 40: BLE Tester Frequency Offset - DA1458x

User Manual

03-Feb-2022



DA1458x/DA1468x Production Line Tool

Option	Description
Frequency	The BLE channel frequency used in the BLE TX frequency offset test.
Power range	Set the device TX output power range. Available options are: Auto +22 dBm to +7 dBm +9 dBm to -3 dBm +5 dBm to -7 dBm -4 dBm to -16 dBm -12 dBm to -26 dBm -24 dBm to -35 dBm Default value is <i>Auto</i> .
Positive limit	Set the maximum positive offset limit in kHz for the TX carrier frequency offset pass/fail test criteria.
Negative limit	Set the maximum negative offset limit in kHz for the TX carrier frequency offset pass/fail test criteria.
Drift packet limit	Set the overall packet drift in kHz for the TX drift pass/fail test criteria.
Drift rate limit	Set the drift rate limit in kHz/50 μ s for the TX drift pass/fail test criteria.

BLE Tester - Modulation Index

▲ RF Tests		
Golden Unit BLE Tester General TX Power Modulation Index RX Sensitivity Path losses per DUT	BLE tester TX modulation index test settings. MOD_IDX_1 (✓) MOD_IDX_2 (✓) Image: MOD_IDX_1 Image: Frequency 2450 • MHz Power range Auto Image: Frequency 2450 • MHz Power range Auto Image: Frequency 2450 • MHz F1 min <=	

Figure 53: BLE Tester Modulation Index - DA1458x

Table 41 describes the available options for the *Modulation Index* test using a BLE Tester instrument.

Table 41: BLE Tester Modulation Index - DA1458x

Option	Description
Enable	This option enables the specific TX modulation index test using a BLE tester instrument.
Test name	The name assigned to each test. If this field is non-empty, then the assigned name will be shown on the tab and next to it an indication showing whether the specific test Is enabled or not.
Frequency	The BLE channel frequency used in the BLE TX modulation index offset test.



DA1458x/DA1468x Production Line Tool

Option	Description	
Power range	Set the device TX output power range. Available options are: Auto +22 dBm to +7 dBm +9 dBm to -3 dBm +5 dBm to -7 dBm -4 dBm to -16 dBm -12 dBm to -26 dBm -24 dBm to -35 dBm Default value is <i>Auto</i> .	
F1 min	Set the F1 minimum average limit in kHz for the TX modulation index pass/fail test criteria.	
F1 max	Set the F1 maximum average limit in kHz for the TX modulation index pass/fail test criteria.	
F2 max	Set the F2 maximum limit in kHz for the TX modulation index pass/fail test criteria.	
F1/F2 ratio	Set the F1/F2 maximum average ratio limit for the TX modulation index pass/fail test criteria.	

BLE Tester - RX Sensitivity

▲ RF Tests		
Golden Unit BLE Tester General TX Power Frequency Offset Modulation Index RX Sensitivity Path losses per DUT	BLE tester RX sensitivity test settings. RSSI_1 (✓) RSSI_2 (✓) Image: Bable Test name RSSI_1 Settings Frequency 2450 ▼ MHz Pattem PRBS9 Spacing 625 us Num of packets 500 Tx power 0.00 dBm Limits RSSI limit >= -70.0 dBm	

Figure 54: BLE Tester RX Sensitivity - DA1458x

Table 42 describes the available options for the RX Sensitivity test using a BLE Tester instrument.

Option	Description
Enable	This option enables the specific RX sensitivity test using a BLE tester instrument.
Test name	The name assigned to each test. If this field is non-empty, then the assigned name will be shown on the tab and next to it an indication showing whether the specific test Is enabled or not.
Frequency	The BLE channel frequency used in the BLE RX sensitivity test.
Pattern	 The bit pattern of the TX data. Available options are: PRBS9 10101010 11110000

User Manual



Option	Description
Spacing	The packet spacing in μ s.
Num of packets	The number of packets the BLE tester instrument to transmit.
Tx power	The TX output power of the BLE tester instrument. Suggested values are 0 to -10 dBm.
Dirty	When enabled, the BLE tester packet generator can use a dirty table to transmit.
CRC alternate	When enabled, the BLE tester will alternatingly send packets with CRC correct and CRC incorrect.
RSSI limit	The RSSI limit for pass/fail criteria in the RF RX sensitivity test. If the average RSSI of the device after it has received the transmitted packets is less than this value, the test will be considered as failed.

Path Losses per DUT

▲ RF Tests				
Golden Unit BLE Tester 	DUT 2 40.00 I DUT 3 36.00 I	DUT 5 34.00 I DUT 6 34.00 I DUT 7 32.00 I	DUT 9 30.00 DUT 10 32.00 DUT 11 34.00 DUT 12 34.00	DUT 13 36.00 DUT 14 36.00 DUT 15 40.00 DUT 16 40.00

Figure 55: Path Losses per DUT - DA1458x

Table 43 describes the available options for the Path losses per DUT.

Based on the relative position of each DUT during the RF tests and since the RF tests are performed over the air, values can be used to correct for any path losses. These values are added to the limits of the TX Power and RF RX RSSI tests. Additional information can be found in 0.

Table 43: Path Losses per DUT from RF Tests DA1458x Options

Option	Description
DUT1-16	Set the calibrated path loss value for each DUT. These will be added as corrections to the limits of the TX Power and RF RX RSSI tests.



DA1458x/DA1468x Production Line Tool

7.2.6.3 Current Measurement Test

Current Meas	urement Test						
urrent measureme	ent general settings						
	anı general settings						
Enable							
Settings							
Instrument	ammeter_scpi.dll		•				
Interface	USB0::0x2A8D::0x0	101::MY55	500				
Idle current me	asurement						
Settings		Ohma	Waitking	1500			
🔽 Enable) Ohms	Wait time	1500	mSecs		
Settings			Wait time Resolution	1500 0.0001			
 Enable Settings Shunt resis 	stor 0.00	1 Amps		0.0001	Amps		
 Enable Settings Shunt resis Range 	stor 0.00 0.000 10	1 Amps	Resolution	0.0001	Amps		
 Enable Settings Shunt resis Range Samples 	stor 0.00 0.000 10 evice	1 Amps	Resolution SCPI cmd	0.0001	Amps 1		

Figure 56: Current Measurement Tests - DA1458x

In this test an external ammeter instrument can be used to calculate the total current consumption of all the active DUTs at the time of the sampling. The ammeter instrument can be connected in the blue banana plugs as described in Current Measurements or to an external power supply (if present) depending the selected VBAT/Reset Mode.

During measurement, PLT will control the instrument using the ammeter_driver DLL [1]. Table 44 describes the instrument selection settings found by the ammeter_driver DLL and in Table 45 the current measurement options for each sleep state.

Note: Modifications in the Production test firmware are mandatory in order to achieve the correct current consumption of a specific hardware design(IC and peripherals) for each sleep state. Running the default firmware without any modifications for the hardware design may cause increased current consumption.

Table 44: Current Measurement	Tests - DA1458x
-------------------------------	-----------------

Option	Description
Enable	This option enables all of Current Measurement tests, which include:
	Idle Current Measurement
	Extended Sleep Current Measurement
	Deep Sleep Current Measurement
	Only one of the Extended/Deep sleep current measurements can be selected, meaning that the other one will be disabled.
Instrument	Select the Ammeter instrument DLL name. Names are shown only if an ammeter instrument DLL exists in the project ammeter_instr_plugins folder.
Interface	The interface of the instrument to be used by the driver.

Table 45: Current Measurement for each Sleep State

Option	Description
Enable	This option enables the specific current measurement using the ammeter instrument provided in the <i>Instrument</i> section.
Shunt resistor	The value of the shunt resistor used for idle current measurement. Applicable only if a voltmeter or a NI-DAQ is used to measure current instead of a DMM. Values from 0 to 9999 are supported.
Wait time	The time in ms the PLT will wait before taking a current measurement, after it has sent an instruction to the DUTs to go into a specific sleep state. Supported values are 1 to 500000ms.
Sleep time (only for extended sleep)	The time in seconds that the DUTs will remain in extended sleep mode. A timer in the production test firmware will wake up the devices and set them to idle mode. Supported values are 1 to 9sec for DA14580/1/2/3 and up to 1200sec for the rest.
Range	The range value in Ampere units that the ammeter instrument will operate. Supported values are 0 to 9999 and default value is 0.001A.
Resolution	The ammeter instrument resolution value in Ampere units.
Samples	The number of samples that the ammeter instrument will read and average. 1 to 1000 is supported.
SCPI cmd	An SCPI command to be passed to the ammeter instrument just before the measurement is taken. Supports multiple commands separated with a column. Up to 256 characters are supported.
Upper limit	The upper limit value for the extended sleep current measurement test procedure, for a single DUT. Next to this input field the total upper limit current consumption for all the enabled DUTs is shown, which is the value to be used during testing. Note: During testing some DUTs may fail until the current measurement test takes place, in that case the PLT will automatically re-calculate the total upper limit by using the value given for a single DUT multiplied with the number of the active DUTs at the time that the test will run.
Low limit	The low limit value for the extended sleep current measurement test procedure, for a single DUT. Next to this input field the total upper limit current consumption for all the enabled DUTs is shown, which is the value to be used during testing. Note: During testing some DUTs may fail until the current measurement test takes place, in that case the PLT will automatically re-calculate the total low limit by using the value given for a single DUT multiplied with the number of the active DUTs at the time that the test will run.

7.2.6.4 GPIO/LED Test

GPIO\LED Tests	
GPI0_P1_0 (✓) GPI0_P1_2 (✓) GPI0_P1_3 (✓)	
Test name GPI0_P1_0	
Pin P1_0 - Retries 10 Low 50 ms High 50 ms	
	- +

Figure 57: GPIO/LED Tests - DA1458x

GPIO/LED Tests can have multiple instances with different settings. Tests can be added or removed using the two buttons (e.g. and in Figure 57) at the bottom right side of each panel.

User	Manual
0001	manadi



Note: When adding or removing a test, all settings are refreshed with the values written to the XML file, meaning that any unsaved settings will be lost.

Table 46 describes the available options for the GPIO/LED Tests DA1458x Options.

In these tests a specific pulse can be given to a GPIO and any LED connected to it can be visually tested. The *Pin* option sets the GPIO to be used, *Low* and *High* define the duty cycle and the *Retries* the number of pulses.

Option	Description
Enable	This option enables the GPIO/LED toggling. Can be used for visual LED testing.
Test name	The name assigned to each test. If this field is non-empty, then the assigned name will be shown on the tab and next to it an indication showing whether the specific test Is enabled or not.
Pin	The GPIO that will be used for the specific test.
Retries	Number of pulses to be generated for the specific test.
Low	Sets the amount of the OFF time of the pulse in ms for the specific test.
High	Sets the amount of the ON time of the pulse in ms for the specific test.

Table 46: GPIO/LED Tests - DA1458x

7.2.6.5 Audio Test

▲ Audio Test ✓ Enable Power level 0x 0055

Figure 58: Audio Test

Table 47 describes the available options for the Audio Test Trim DA1458x Options.

Enabling this test will set the DUTs to listen for a 4 kHz tone produced by the Golden Unit. The DUT will send the audio data received to the PLT software. The PLT software will decode them, analyze if a 4 kHz tone exists in the audio data, and calculate the *Power Level*. If the tone is not detected or if the power level calculated is less than the one entered here the test will fail.

In order to perform the audio test the Golden Unit can generate a 4 kHz tone using an external speaker connected as shown in Appendix M.

Note: Audio test is supported only for DA14582, DA14585 and DA14586 devices.

Table 47: Audio Test

Option	Description
Enable	This option enables the Audio testing.
Power level	The threshold limit of the power level calculated for the 4 kHz tone.



DA1458x/DA1468x Production Line Tool

7.2.6.6 Sensor Test

▲ Sensor Tests	
SENS_TEST_1 () SENS_TEST_2 () SENS_TEST_3 ()]
✓ Enable	
Settings	
Test name SENS_TEST_1	
Read/Write mode Write Register address 0x 00 Write data 0x AA	
SPI CLK P0_0 ▼ MISO P0_0 ▼ MOSI P0_0 ▼ CS P0_0 ▼	
✓ Interrupt GPIO check Interrupt GPIO	
Expected data 0x D1	
	-

Figure 59: Sensor Test - DA1458x

Sensor Tests can have multiple instances with different settings. Tests can be added and removed using the two buttons (e.g. e and in Figure 59) at the bottom right side of each panel.

Note: When adding or removing a test all settings are refreshed with the values written to the XML file, meaning that any unsaved settings will be lost.

Table 48 describes the available options for the Sensor Tests DA1458x Options.

Option	Description	
Enable	This option enables the specific sensor test.	
Test name	The name assigned to each test. If this field is non-empty, then the assigned name will be shown on the tab and next to it an indication showing whether the specific test Is enabled or not.	
Read / Write mode	Select the sensor test procedure, to read or write.	
Register address	The sensors register address to read or write data.	
Write data	The byte to be written at the sensor register.	
SPI / I2C	Select the interface that the sensor is connected to.	
SPI - CLK	Select the GPIO for the sensor SPI CLK.	
SPI - MISO	Select the GPIO for the sensor SPI MISO.	
SPI - MOSI	Select the GPIO for the sensor SPI MOSI.	
SPI - CS	Select the GPIO for the sensor SPI CS.	
I2C - SCL	Select the GPIO for the sensor I2C SCL.	
I2C - SDA	Select the GPIO for the sensor I2C SDA.	
Slave address	The sensor I2C bus slave address.	
Interrupt GPIO check	Enables the sensor interrupt signal test via GPIO.	
Interrupt GPIO	Select the GPIO to be used as a sensor interrupt.	
Expected data	The received sensor byte that will be expected on a successful operation.	

Table 48: Sensor Tests - DA1458x



7.2.6.7 Custom Test

Custom Test	
CUST_TEST_1(✓) CUST_TEST_2(✓) CUST_TEST_3(✓)	
Enable	
Test name CUST_TEST_1	
Command ID 0x 35	-

Figure 60: Custom Test - DA1458x

Custom Tests can have multiple instances with different settings. Tests can be added and removed using the two buttons (e.g. and in Figure 60) at the bottom right side of each panel.

Note: When adding or removing a test all settings are refreshed with the values written to the XML file, meaning that any unsaved settings will be lost.

Table 49 describes the available options for the DA1458x Custom Tests.

When enabled, the PLT software will send an HCI command via the UART to activate a customer defined test that will run on the DUTs. The HCI custom test command will contain a single byte as data (the *Command ID* byte), to be used mainly as identification for a specific test in the customized firmware. Default functionality of the production test firmware is to respond with the same Command ID. Otherwise PLT will be considered the test as failed.

Table 49: Custom Tests - DA1458x

Option	Description			
Enable	This option enables the specific custom test.			
Test name	The name assigned to each test. If this field is non-empty, then the assigned name will be shown on the tab and next to it an indication showing whether the specific test Is enabled or not.			
Command ID The byte that will be sent to the device running the production test firmwar				

7.2.6.8 Temperature Measurement Test

▲ Temperature Measurement	
Temperature measurement general settings.	
Enable	
Settings	
Instrument tmu_temp_sens.dll	
Interface COM5	

Figure 61: Temperature Measurement Test - DA1458x

Table 50 describes the available options of the DA1458x Temperature Measurement Test.

Table 50: Temperature Measurement Test - DA1458x

Option	Description
Enable	This option enables the temperature measurement test.



Option	Description		
Instrument	Selects the temperature measurement DLL. Names are shown only if a temperature measurement instrument DLL exists in the project folder temp_meas_instr_plugins.		
Interface	The interface of the instrument to be used by the driver.		

7.2.6.9 Scan Test

ican Test		
Enable		
Scan retries	9	
DUT reboot	3	
DUT reboot difference	37	
DUT reboot time	25	
🔽 Firmware load enable	•	
Firmware path		binaries\prox_reporter_580.bin

Figure 62: Scan Test - DA1458x

Table 51 describes the available options for the DA1458x Scan Test.

By enabling this test, the Golden Unit will scan for the DUT's BD addresses advertised after the customer firmware has been burned. For this test to work, a bootable firmware with the ability to advertise with the BD address given by the PLT, must be burned into each DUT. Additionally, the BD addresses provided by the PLT should be burned into OTP memory, such that the devices advertise with the BD addresses that the tool uses.

Option	Description
Enable	This option enables the Scan test.
Scan retries	The total number of BLE advertising scans the Golden Unit will perform.
DUT reboot	Define after how many retries the PLT will reboot the DUTs.
DUT reboot difference	Set the time difference between each DUT when the PLT reboots the devices, in order to avoid air collisions.
DUT reboot time	The time the VBAT will remain low during the device reboot. This value is time in ms*100. (e.g. 15 is 1500ms).
Firmware load enable	By enabling this option a new image will be downloaded to all active DUTs before scanning for BLE advertising devices.
Firmware path	The path of the binary file to download to the devices for the scan test.

Table 51: Scan Test DA1458x Options



7.2.7 Memory Functions (DA1458x)

This section describes the Memory Functions settings available when using DA1458x devices. Memory functions include OTP, SPI Flash, and I2C EEPROM memory programming.

7.2.7.1 **OTP Memory**

•	OTP Memory	
1] Write enable	
	💿 No check 🔘 Check empty 💿 Check if data match	
	Verify image	
	Different image per DUT	
	Image path	binaries\prox_reporter_580.bin

Figure 63: OTP Memory - DA1458x

This test enables the OTP memory programming. Table 52 describes the available options for the *OTP Memory* image write operation.

Table 52: OTP Memory - DA1458x

Option	Description		
Write enable	This option enables the OTP image write operation.		
 No check Check empty Check if data match 	 Memory protection options: No check: No protection is enabled. PLT will attempt to burn the OTP memory without running any check. Check empty: PLT will first check if it the OTP memory to be burned is empty, and if it is it will then proceed to burn it. Check if data match: PLT will first check if the memory to be burned is empty. If it is not then it will compare its contents with the data to be burned. If the data are not the same the test will fail without making any change to the memory. For DA14585/6 devices if the data are the same PLT will not perform any burning to the memory to prevent using the OTP repair memory for these devices. For the DA14580/1/2/3 devices PLT will burn again the same data to the memory. 		
Verify image	If this option is enabled, the PLT reads back the contents of the OTP memory and compares them to the original image file. If these do not match, the OTP memory programming will fail.		
Different image per DUT	If this option is selected, a different image per DUT can be burned into the OTP. The image name must be specific for each DUT, as described below.		
Image path	Via this field the user specifies the image file to be burned into the OTP. A .bin binary file of any name can be selected. If option <i>Different image per DUT</i> is selected, the user only selects the directory of the images. In that case the binary file names must have the following format: img_0X.bin, where 'X' denotes the DUT number. For example, if the user has activated DUTs 1, 5 and 10 then img_01.img, img_05.img and img_10.img binary files should exist in the selected OTP image path as shown in Figure 64.		



DA1458x/DA1468x Production Line Tool

C→ C→ Different_image_per_DUT → 4→ Search Different_image_per_DUT >					
Organize 🔻	Include in library 🔻	Share with 👻 New folder			
> 🔆 Favorites	Name	Date modified	Туре		Size
	img_01.bin	26/1/2016 6:05 μμ	BIN File		28 KB
🛛 🌉 Desktop	img_05.bin	26/1/2016 6:07 μμ	BIN File		28 KB
	img_10.bin	26/1/2016 6:11 μμ	BIN File		28 KB

Figure 64: Different Image per DUT Folder Example

7.2.7.2 SPI Flash Memory

SPI Flash Memory	
✓ SPI pin setup CLK P0_0 ▼ MISO P0_5 ▼ MOSI P0_6 ▼ CS P0_3 ▼	
Spi erase 1 (✓) SPI Erase 2 (✓) SPI Erase 3 (✓)	
Image: Spierase 1	
V Entire memory	
Start address 0x 00000000 Sectors 00000064	
SPI write 1 (🗸) SPI write 2 (🗸) SPI write 3 (🗸)	
V Write enable	
Test name	
Write image in chunks of 3960 bytes	
Verify image	
Bootable image	
Start address 0x 00000000	
Different image per DUT	
Image path binaries\prox_reporter_580.bin	
	-

Figure 65: SPI Flash Memory - DA1458x

This section explains the settings of the SPI Flash Memory operations. Table 53 describes the available options for the *SPI Pin Setup*.

Table	53:	SPI	Pin	Setup -	DA1458x
TUDIC	00.	0.1		Occup	DAITOON

Option	Description
SPI pin setup	This option enables the SPI pin selections. If this option is disabled default pin configuration will be used. For the DA14583 and DA1586 this option will be disabled and their default pin configuration as described in Appendix I and Appendix J will be used.



Option	Description
CLK	Sets the GPIO for the CLK pin of the SPI bus. Default GPIO pin is P0_0.
MISO	Sets the GPIO for the MISO pin of the SPI bus. Default GPIO pin is P0_5.
MOSI	Sets the GPIO for the MOSI pin of the SPI bus. Default GPIO pin is P0_6.
CS	Sets the GPIO for the CS pin of the SPI bus. Default GPIO pin is P0_3.

Both erase and write tests can have multiple instances with different settings. Tests can be added and removed using the two buttons (e.g. and in Figure 65) at the bottom right side of each panel.

Note: When adding or removing a test all settings are refreshed with the values written to the XML file, meaning that any unsaved settings will be lost.

The SPI Flash memory should be erased before any image is written to it. Table 54 describes the available options for the *SPI Flash Erase* operation.

Option	Description
Erase enable	This option will enable the specific SPI Flash erase test.
Check empty	After Flash erasure the PLT software can verify the erasure result by sending a specific command to the flash_programmer.bin firmware running in the DUT. The firmware will read the SPI Flash memory and check if it is empty. The result will be returned to the PLT software.
Test name	The name assigned to each test. If this field is non-empty, then the assigned name will be shown on the tab and next to it an indication showing whether the specific test Is enabled or not.
Entire memory	When this checkbox is selected, the entire memory can be erased. Otherwise, the user can give a start address and a specific number of sectors to be erased.
Start address	The user can enter a specific start address for the SPI Flash erasure to start.
Sectors	The number of sectors to erase, starting from the <i>Start address</i> explained above.

Table 54: SPI Flash Erase - DA1458x

After every SPI Flash erase operation has finished, the SPI image write tests will begin. Table 55 describes the available options for the *SPI Flash Image Write* operation.

Table 55: SF	9 Flash	Image	Write -	- DA1458x
--------------	---------	-------	---------	-----------

Option	Description
Write enable	This will enable the specific SPI Flash image programming operation.
Test name	The name assigned to each test. If this field is non-empty, then the assigned name will be shown on the tab and next to it an indication showing whether the specific test Is enabled or not.
Write image in chunks of "user_input" bytes.	During memory programming PLT will split the image into chunks. The size of the chunks is user defined using this field. Values from 1 byte to 32760 bytes are supported.
Verify image	By selecting this option the PLT software will read back the contents of the SPI Flash memory, after an image was burned, and compare them to the original image file. If these do not match then the SPI memory programming will fail.
Bootable image	When selecting this checkbox the PLT software will write a boot header at SPI address 0 and will always burn the image at SPI address 0x8.
Start address	The user can configure the SPI Flash start address where the image will be written. If <i>Bootable image</i> is selected, this option will be disabled.



Option	Description
Different image per DUT	If this option is selected, a different image per DUT can be burned into the SPI Flash. The image name must be specific for each DUT, as described below.
Image path	Via this field the user specifies the image file to be burned into the SPI Flash memory. A .bin binary file of any name can be selected.
	If option <i>Different image per DUT</i> is selected the user only selects the directory of the images. In that case, the binary file names must have the following format: img_0x.bin, where 'X' denotes the DUT number. For example, if the user has activated DUTs 1, 5 and 10 then img_01.img, img_05.img and img_10.img binary files should exist in the selected SPI image path, as shown in Figure 64.

7.2.7.3 I2C EEPROM Memory

▲ I2C EEPROM Memory	
SCL P0_2 SDA P0_3	
EEPROM_WR_1 () EEPROM_WR_2 () EEPROM_WR_3 ()	
Vite enable	
Test name EEPROM_WR_1	
Write image in chunks of 3960 bytes	
Venfy image	
Bootable image	
Start address 0x 00000000	
Different image per DUT	
Image path binaries\prox_reporter_580.bin	-

Figure 66: I2C EEPROM Memory - DA1458x

In this section an I2C EEPROM memory can be programmed. Table 56 describes the available options for the *I2C Pin Setup*.

Table 56: I2C Pin Setup - DA1458x

Option	Description
I2C pin setup	This option enables the I2C pin selections. If this option is disabled, the default pin configuration will be used.
SCL	Sets the GPIO for the SCL pin of the I2C bus. Default GPIO pin is P0_2.
SDA	Sets the GPIO for the SDA pin of the I2C bus. Default GPIO pin is P0_3.

The I2C EEPROM image write tests can be performed multiple times with different settings each

time. Tests can be added and removed using the two buttons (e.g. 🔳 and 🔳 in Figure 66) at the bottom right side of each panel.

Note: When adding or removing a test all settings are refreshed with the values written to the XML file, meaning that any unsaved settings will be lost.

Table 57 describes the available options for the I2C EEPROM Image Write operation.

Table 57: I2C EEPROM Image Write - DA1458x

Option	Description
Write enable	This will enable the specific I2C/EEPROM image programming test.



Option	Description
Test name	The name assigned to each test. If this field is non-empty, then the assigned name will be shown on the tab and next to it an indication showing whether the specific test Is enabled or not.
Write image in chunks of "user_input" bytes.	During memory programming PLT will split the image into chunks. The size of the chunks is user defined using this field. Values from 1 byte to 32760 bytes are supported.
Verify image	By selecting this option the PLT software will read back the contents of the EEPROM and compare them to the original image file. If these do not match then the EEPROM memory programming will fail.
Bootable image	When selecting this checkbox the PLT software will write a boot header at EEPROM address 0 and will always burn the image at the EERPOM address 0x20.
Start address	Users can configure the start EEPROM address that the image will be written at. If <i>Bootable image</i> is selected, this option is disabled.
Different image per DUT	If this option is selected, a different image per DUT can be burned into the EEPROM memory. The image name must be specific for each DUT, as described below.
Image path	This field specifies the image file to be burned into the EEPROM memory. A .bin binary file of any name can be selected. If option <i>Different image per DUT</i> is selected, the user only selects the directory of the images. In that case the binary file names must have the following format: img 0X.bin,
	where 'X' denotes the DUT number. For example, if the user has activated DUTs 1, 5 and 10 then img_01.img, img_05.img and img_10.img binary files should exist in the selected image path, as shown in Figure 64.

7.2.7.4 Memory read

▲ Memory Read	
OTP BDA (🗸) OTP CUST (🗸) SPI DATA (🗸)	
Read enable	
Test name OTP BDA	
Start address 0x 047FD4	
Size 6	
Memory type OTP -	

Figure 67: Memory Read Test - DA1458x

Memory Read Tests can have multiple instances with different settings. Tests can be added or removed using the two buttons (e.g. and in Figure 67) at the bottom right side of each panel.

Note: When adding or removing a test, all settings are refreshed with the values written to the XML file, meaning that any unsaved settings will be lost.

Table 58 describes the memory read test options. With this test the user can read up to 256 bytes of data from any address from any available memory for the DA1580/1/2/3/5/6 devices, such as OTP, SPI Flash and EEPROM.

Option	Description
Read enable	This will enable the specific memory reading test.
Test name	The name assigned to each test. If this field is non-empty, then the assigned name will be shown on the tab and next to it an indication showing whether the specific test Is enabled or not.

Table 58: Memory Read Test - DA1458x



Option	Description		
Start address	Configures the Start address for the read test. For the OTP memory of the DA14580/1/2/3 devices 0x40000 offset should be used (e.g. BD address is written in 0x47FD4), for the DA14585/6 devices this is not needed (e.g. BD address is written in 0xFFA8). DA14580/1/2/3 OTP valid address is 0x40000 to 0x47FFF and DA14585/6 OTP address 0x0000 – 0x10000.		
Size	Number of bytes to read, up to 256 bytes.		
Memory type	The type of memory to read the data from. Available options are: OTP, SPI FLASH, and I2C EEPROM.		
	Note: For the FLASH and EEPROM memories the pin configurations are taken from the SPI Flash Memory and I2C EEPROM Memory sections. These options must be enabled in order for the <i>Memory Read</i> test to operate successfully.		

7.2.8 Memory Header (DA1458x)

This section describes the OTP Header programming settings available when using DA14580, DA14581, DA14582, or DA14583 devices.

7.2.8.1 General

OTP Header	
General Write	
No check Check empty Check if data match	
Verify	
XTAL 16MHz trim value 00 : 00 : 05 : FC	
☑ Boot specific mapping - SPI GPIO boot pins	
CLK PO_0 V MISO PO_5 V MOSI PO_6 V CS PO_3 V	
Set wake-up command opcode	
Command opcode BA	
Serial speed selection 0x2: Divide by 4 🔹	
JTAG enable Yes 🔻	
32kHz source External 32kHz 💌	
DMA length 1FC0	
Software generated customer specific field	
Customer specific field 112233445566778899AABBCCDDEEFF	
Application flag 1 and 2 No	

Figure 68: OTP Header - DA1458x

Table 59 describes the available options for DA1458x OTP Header programming.

Table 59: OTP Header - DA1458x

Option	Description
Write	This option enables the OTP header programming.



Option	Description	
 No check Check empty Check if data match 	 Memory protection options: No check: No protection is enabled. PLT will attempt to burn the OTP memory without running any check. Check empty: PLT will first check if it the OTP memory to be burned is empty, and if it is it will then proceed to burn it. Check if data match: PLT will first check if the memory to be burned is empty. If it is not then it will compare its contents with the data to be burned. If the data are not the same the test will fail without making any change to the memory. For DA14585/6 devices if the data are the same PLT will not perform any burning to the memory to prevent using the OTP repair memory for these devices. For the DA14580/1/2/3 devices PLT will burn again the same data to the memory. 	
Verify	Each value written in the OTP header can be read back and compared with the original one to verify a successful write.	
XTAL trim calibration flag (Only for DA14580/1/2/3 Devices)	If Burn to OTP in XTAL Trim is selected, this option is disabled as the XTAL trim value and flag will be burned during the automatic calibration process. If these are not executed, the users have the option to manually write the OTP XTAL trim value and enable the calibration flag here.	
XTAL 16 MHz trim value	Crystal calibration value common to all devices. Can be burned only if the automatic crystal frequency calibration process and Burn to OTP in XTAL Trim are disabled and XTAL trim calibration flag is enabled (only for DA14580/1/2/3 devices).	
Boot specific mapping – SPI GPIO boot pins (only for DA14585 devices)	Enables external booting from a specific SPI interface configuration. This option also enables the following options for the SPI flash boot configuration for the DA14585 devices. Note: In DA14586 the boot specific mapping section is already pre-programmed with the internal SPI pins as described in Appendix J. If this is needed to be changed for DA14586 DUTs, this area can be written as a DA14585 device and it will overridden using an OTP memory repair cell.	
CLK (only for DA14585 devices)	Sets the GPIO for the CLK pin of the SPI bus.	
MISO (only for DA14585 devices)	Sets the GPIO for the MISO pin of the SPI bus.	
MOSI (only for DA14585 devices)	Sets the GPIO for the MOSI pin of the SPI bus.	
CS (only for DA14585 devices)	Sets the GPIO for the CS pin of the SPI bus.	
Set wake-up command opcode (only for DA14585 devices)	Default wake-up command opcode is "AB". If a different one is needed to be used it can be set using this flag and the following field.	
Command opcode (only for DA14585 devices)	The command opcode to be used.	
Serial speed selection (only for DA14585 devices)	Division factor for SPI.	
JTAG enable	Enable the JTAG support.	
32 kHz source	Selects the low power 32 kHz clock source.	
DMA length	The size (in words) for the DMA controller to copy from OTP to system RAM during boot. Should match the OTP image size. Max value for the DA14580-1-2-3 devices is 0x1FC0. Max value for the DA14585-6 devices is 0x3E00.	



DA1458x/DA1468x Production Line Tool

Option	Description	
Software generated specific field	When enabled, a PLT software function will be called that can generate a customer specific field per DUT. Users can edit this function by adding their code for creating the customer specific field.	
	For the CLI executable this function is called:	
	<pre>int cli_sw_customer_field(_cfg_params *cfg_params_t);</pre>	
	For the GUI executable the function is called:	
	<pre>void gui_plt_sw_customer_field(_cfg_params *cfg_params_t);</pre>	
Customer specific field	If option <i>Software generated customer specific field</i> is not set, the user can manually enter the value to be written into the DUT OTP. The same value will be programmed to all DUTs.	
Application flag 1 and 2	If this option is set, the device will boot only from the OTP memory. Used for a production ready device. There is no other means to access the device apart from JTAG, if this is still enabled in the OTP header.	

7.2.8.2 BD Address

BD address		
Viite		
No check	Check empty	Check if data match
Verify		
🔽 Read		
Compare		

Figure 69: BD Address - DA1458x

The BD address can be written independently from the rest OTP header options described before. Table 60 describes the available options for the *BD Address* programming.

Option	Description
Write	When selected, the BD address will be written in the OTP Header.
No check	Memory protection options:
 Check empty Check if data 	No check: No protection is enabled. PLT will attempt to burn the OTP memory without running any check.
match	Check empty: PLT will first check if it the OTP memory to be burned is empty, and if it is it will then proceed to burn it.
	Check if data match: PLT will first check if the memory to be burned is empty. If it is not then it will compare its contents with the data to be burned. If the data are not the same the test will fail without making any change to the memory. For DA14585/6 devices if the data are the same PLT will not perform any burning to the memory to prevent using the OTP repair memory for these devices. For the DA14580/1/2/3 devices PLT will burn again the same data to the memory.
Verify	When selected, the BD address will be read back from the OTP Header and will be compared to the original.
Read	This option will read the BD address written in the OTP Header field. It is a standalone memory operation. It does not depend on the previous tests to run, but it is necessary for the following <i>Compare</i> test.
Compare	If the <i>Read</i> option is enabled, a comparison will be performed between the read BD address and the BD address entered in the DUT by the PLT, as described in the BD address DUT assignment method.

Table 60: BD Address - DA1458x



DA1458x/DA1468x Production Line Tool

7.2.8.3 Custom Memory Data

e enable		
Verify data		
iput		
Barcode scanner	Scanner interface	Refresh COM1 Scan mode Automatic DUT position
CSV file	CSV file path pa	rams\/mem_data_example.csv
Manual	Edit data	112233445566778899AA
Memory	The	s SPI and EEPROM memory GPIOs will be taken from the 'Memory Functions' tab!
Start address 0x	00007100	
	10	

Figure 70: Custom Memory Data - DA1458x

Table 61: Custom Memory Data - DA1458x

Option	Description		
Write enable	This option enables the Custom data programming.		
Verify data	When selected, the data written will be read back from the memory and will be compared to the original.		
Barcode scanner	Custom data input options:		
CSV fileManual data	Scanner interface (Barcode scanner)	Selection of the barcode scanner COM port from a dropdown list with all the available system COM ports.	
		A common USB to UART barcode scanner is supported. PLT has been tested with Honeywell Xenon 1900. Appendix K describes the setup procedure.	
		This option is the exact same option as in Scan Mode and the DA1468x devices in Custom Memory Data.	
	Scan mode (Barcode scanner)	Scan DUT position: In this mode the users must first scan the DUT position number and then the BD address. The string used for the position of each DUT is "TEST POSITION 0xx" where "xx" is the DUT position number.	
		Automatic DUT position: Scanned BD address will be assigned to the selected DUT. The DUT selection is automatically been made, starting from the first active DUT and selecting the next one after a successful BD address scan. Users can change the selected DUT using the controls on the GUI PLT screen shown in Figure 102.	
		This option is the exact same option as in Scan Mode and the DA1468x devices in Custom Memory Data.	
	CSV file path (CSV file)	Path to the CSV file containing data for each device discriminated using BD addresses. The CSV file format is described in Custom data CSV file format.	
	Edit data (Manual data)	Hexadecimal data input of up to 256 bytes to burn. These data will be burned to all active DUTs.	
Memory	Memory type selection to burn the data. Available options are OTP, SPI and EEPROM. Note: For the FLASH and EEPROM memories the pin configurations are taken from the SPI Flash Memory and I2C EEPROM Memory sections. These options must be enabled in order for the <i>Memory Read</i> test to operate successfully.		



DA1458x/DA1468x Production Line Tool

Option	Description	
Start address	Memory address offset to begin burning the data. DA14580/1/2/3 OTP valid address is 0x40000 to 0x47FFF and DA14585/6 OTP address 0x0000 – 0x10000.	
Data size	The size of the memory data to burn. In barcode scanner, the data size is the number of scanned ASCII characters. In manual data, data size is the number of bytes.	

7.2.9 UART (DA1468x)

7.2.9.1 UART Boot Pins Setup

LUART E	Boot Pin Setup
TX-RX pin	TX: P1_3, RX: P2_3 TX: P0_1, RX: P0_2 TX: P0_5, RX: P0_3 TX: P1_0, RX: P1_5 TX: P1_2, RX: P1_4 TX: P1_3, RX: P2_3

Figure 71: UART Boot Pins Setup - DA1468x

Table 62 describes the available options for the *TX-RX pins* of the DA1468x *UART Boot Pins Setup*. *The TX-RX pins* selection defines the UART pins and baud rate setup that will be used for firmware downloading to the DA1468x during booting.

Table 62: UART TX-RX Pins - DA1468x

Option	Description
TX: P0_1, RX: P0_2	Sets UART TX pin to P0_1, UART RX pin to P0_2 and Baud rate to 115200 bit/s.
TX: P0_5, RX: P0_3	Sets UART TX pin to P0_5, UART RX pin to P0_3 and Baud rate to 57600 bit/s.
TX: P1_0, RX: P1_5	Sets UART TX pin to P1_0, UART RX pin to P1_5 and Baud rate to 57600 bit/s.
TX: P1_2, RX: P1_4	Sets UART TX pin to P1_2, UART RX pin to P1_4 and Baud rate to 57600 bit/s.
TX: P1_3, RX: P2_3	Sets UART TX pin to P1_3, UART RX pin to P2_3 and Baud rate to 57600 bit/s.

Note: The baud rate is fixed during booting, since it is controlled by the device ROM bootloader.

7.2.9.2 UART Baud Rate

▲ UART B	aud Rate				
Baud Rate	1000000 🔻				
	9600	1			
	19200 38400				
	57600				
	115200				
	230400 812500				
	1000000				

Figure 72: UART Baud Rate - DA1468x

Table 63 shows the available options for the DA1468x UART Baud Rate used during memory programming only.

The *Baud Rate* selected here is used after the firmware (uartboot.bin) has been downloaded to the DUT. The software will send a command to the DUT to change the UART baud rate to the one selected here. All following UART communications with the DUT will be performed using the new baud rate. Please note that this is happening only during memory programming where uartboot.bin

	User	Man	lleu	
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is used. During tests (RF tests, XTAL trimming, etc.), where the production test firmware is used, the baud rate is fixed at 115200 bit/s.

Table 63: UART Baud Rate - DA	A1468x
-------------------------------	--------

Option	Description
Baud Rate	• 9600 (bit/s)
	• 19200 (bit/s)
	• 38400 (bit/s)
	• 57600 (bit/s)
	• 115200 (bit/s)
	• 230400 (bit/s)
	• 100000 (bit/s)
	Note: 1 Mbit/s is the fastest and safest with 0% baud rate error.

7.2.10 Test Settings (DA1468x)

7.2.10.1	XTA	L Trim

	XTAL Trim
1	Enable
	GPIO input pulse pin P2_3 -
	Bum to OTP
	Bum to QSPI
	Address 0x 0008F000

Figure 73: XTAL Trim - DA1468x

Table 64 describes the available options for the DA1468x XTAL Trim operation.

Table 64: XTAL Trim - DA1468x

Option	Description
Enable	This option enables the automatic crystal oscillator frequency calibration procedure.
GPIO input pulse pin	The DUT GPIO to receive the reference pulse during calibration. UART RX pin can be used without any additional connection from the PLT hardware to the DUT.
Burn to OTP	If <i>Burn to OTP</i> option is selected, the XTAL trim value calculated from the automated calibration process will be written in the OTP XTAL trim header field.
Burn to QSPI	If selected, the XTAL trim value calculated from the automated calibration process will be written in the QSPI Flash.
Address	The QSPI Flash address where the XTAL trim value will be written. Default value is 0x0008F000.

7.2.10.2 RF Tests

This section refers to various RF tests conducted between the DUTs and the Golden Unit or an external BLE tester.

The following tests can have multiple instances with different settings. Tests can be added and removed using the two buttons (e.g. and in Figure 74) at the bottom right side of each panel.

Note: When adding or removing a test all settings are refreshed with the values written to the XML file, meaning that any unsaved settings will be lost.

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Revision 4.3



Golden Unit

▲ RF Tests	
Golden Unit BLE Tester Path losses per DUT	RF RX test settings using the Golden Unit. GU_RSSI_1 (✓) GU_RSSI_2 (✓) GU_RSSI_3 (✓) © Enable Test name GU_RSSI_1 Settings Frequency 2424 • MHz Limits RSSI limit >= -70.0 dBm

Figure 74: Golden Unit RF Tests - DA1468x

Table 65 describes the available options for the DA1468x *RF RX* test using the *Golden Unit* as a transmitter.

In the RF RX test the Golden Unit sends 500 packets. The DUTs are set in receive mode and the RSSI is measured. If the RSSI measured by the DUT reception is less than the specified *RSSI limit*, the device will fail and the tests will stop for that particular device.

Option	Description
Enable	This option enables the specific RF RX test using the Golden Unit as a transmitter.
Test name	The name assigned to each test. If this field is non-empty, then the assigned name will be shown on the tab and next to it an indication showing whether the specific test Is enabled or not.
Frequency	The BLE channel frequency used in the RF RX test using the Golden Unit.
RSSI limit	The RSSI limit for pass/fail criteria in the RF RX test using the Golden Unit. If the average RSSI of the device after it has received the packets transmitted from the Golden Unit is less than this value, the test will be considered as failed.

Table 65: Golden Unit RF Tests - DA1468x



BLE Tester

In the *BLE Tester* panels a number of tests can be enabled that require an external BLE tester instrument. More detailed information about the BLE tester can be found in [1].

BLE Tester - General

▲ RF Tests	
Golden Unit BLE Tester General TX Power Frequency Offset Modulation Index RX Sensitivity Path losses per DUT	BLE tester general settings. Instrument mt3852b.dll ▼ Interface GPIB0::27

Figure 75: BLE Tester General Settings - DA1468x

Table 66 describes the *General* settings for the *BLE Tester* supported tests. Any available external instrument found by the ble tester driver DLL and their interfaces can be selected.

Table 66:	BLE Tester	General	Settings -	DA1468x
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Option	Description				
Enable	This option enables all of the BLE Tester tests, which include:				
	BLE Tester TX Power				
	Frequency Offset				
	Modulation Index				
	RX Sensitivity				
Instrument	Selects the BLE tester DLL. Names are shown only if a BLE tester instrument DLL exists in the project folder ble_tester_instr_plugins.				
Interface	The interface of the instrument to be used by the driver.				



BLE Tester - TX Power

	▲ RF Tests		
Golden Unit BLE Tester General TX_POW_1 (✓) TX_POW_2 (✓) TX_POW_3 (✓) Frequency Offset Modulation Index RX Sensitivity Path losses per DUT Enable Test name TX_POW_1 Settings Frequency 2450 • MHz Power range Auto • Limits High Limit <= 10.00 dBm Low Limit >= -20.00 dBm Peak Average <= 3.00 dB	General <mark>TX Power</mark> Frequency Offset Modulation Index RX Sensitivity	TX_POW_1 (✓) TX_POW_2 (✓) TX_POW_3 (✓) ✓ Enable Test name TX_POW_1 Settings Frequency Imits High Limit <=	

Figure 76: BLE Tester TX Power - DA1468x

Table 67 describes the available options for the DA1468x *TX Power* test using a BLE Tester instrument.

Option	Description			
Enable	This option enables the specific TX power test using a BLE tester instrument.			
Test name	The name assigned to each test. If this field is non-empty, then the assigned name will be shown on the tab and next to it an indication showing whether the specific test Is enabled or not.			
Frequency	The BLE channel frequency used in the BLE TX power test.			
Power range	Set the device TX output power range. Available options are:			
	• Auto (No auto option for Litepoint IQxelM. Sets the instrument to trigger at -25dBm)			
	• +22 dBm to +7 dBm			
	• +9 dBm to -3 dBm			
	• +5 dBm to -7 dBm			
	• -4 dBm to -16 dBm			
	• -12 dBm to -26 dBm			
	• -24 dBm to -35 dBm			
	Default value is Auto.			
High limit	Set the average high power limit for the BLE TX output power pass/fail test criteria.			
Low limit	Set the average low power limit for the BLE TX output power pass/fail test criteria.			
Peak average	Set the peak-to-average power limit for the BLE TX output power pass/fail test criteria.			

Table 67: BLE Tester TX Power - DA1468x





BLE Tester - Frequency Offset

▲ RF Tests		
Golden Unit BLE Tester General TX Power Frequency Offset Modulation Index RX Sensitivity Path losses per DUT	BLE tester TX frequency offset test settings. FREQ_OFFS_1 (✓) FREQ_OFFS_2 (✓) Image: Test name FREQ_OFFS_1 Settings Settings Frequency 2450 ▼ MHz Power range Auto ▼	
	Positive Limit <=	-

Figure 77: BLE Tester Frequency Offset - DA1468x

Table 68 describes the available options for the *Frequency Offset* test using a BLE Tester instrument.

Option	Description		
Enable	This option enables the specific TX frequency offset test using a BLE tester instrument.		
Test name	The name assigned to each test. If this field is non-empty, then the assigned name will be shown on the tab and next to it an indication showing whether the specific test Is enabled or not.		
Frequency	The BLE channel frequency used in the BLE TX frequency offset test.		
Power range	Set the device TX output power range. Available options are: • Auto • +22 dBm to +7 dBm • +9 dBm to -3 dBm • +5 dBm to -7 dBm • -4 dBm to -16 dBm • -12 dBm to -26 dBm • -24 dBm to -35 dBm Default value is <i>Auto</i> .		
Positive limit	Set the maximum positive offset limit in kHz for the TX carrier frequency offset pass/fail test criteria.		
Negative limit	Set the maximum negative offset limit in kHz for the TX carrier frequency offset pass/fail test criteria.		
Drift packet limit	Set the overall packet drift in kHz for the TX drift pass/fail test criteria.		
Drift rate limit	Set the drift rate limit in kHz/50 μs for the TX drift pass/fail test criteria.		

Table 68: BLE Tester Frequency Offset - DA1468x



BLE Tester - Modulation Index

	▲ RF Tests	
Golden Unit BLE Tester General TX Power Frequency Offset MOD_IDX_1 (✓) MOD_IDX_2 (✓) MOD_IDX_3 (✓) Image: BLE tester TX modulation index test settings. MOD_IDX_1 (✓) MOD_IDX_2 (✓) MOD_IDX_3 (✓) Image: BLE tester TX modulation index test settings. MOD_IDX_1 (✓) MOD_IDX_2 (✓) MOD_IDX_3 (✓) Image: BLE tester TX modulation index test settings. MOD_IDX_1 (✓) MOD_IDX_2 (✓) MOD_IDX_3 (✓) Image: BLE tester TX modulation index test settings. Image: BLE tester TX modulation index test settings. MOD_IDX_1 (✓) MOD_IDX_2 (✓) MOD_IDX_3 (✓) Image: BLE tester TX modulation index test settings. Image: BLE tester TX modulation index test settings. <td>BLE Tester General TX Power Frequency Offset Modulation Index TX Sensitivity</td> <td>MOD_IDX_1 (✓) MOD_IDX_2 (✓) MOD_IDX_3 (✓) ✓ Enable Test name MOD_IDX_1 Settings Frequency 2450 ▼ MHz Power range Auto ▼ Limits F1 min <= 225 kHz F1 max >= 275 kHz</td>	BLE Tester General TX Power Frequency Offset Modulation Index TX Sensitivity	MOD_IDX_1 (✓) MOD_IDX_2 (✓) MOD_IDX_3 (✓) ✓ Enable Test name MOD_IDX_1 Settings Frequency 2450 ▼ MHz Power range Auto ▼ Limits F1 min <= 225 kHz F1 max >= 275 kHz

Figure 78: BLE Tester Modulation Index - DA1468x

Table 69 describes the available options for the *Modulation Index* test using a BLE Tester instrument.

Option	Description				
Enable	This option enables the specific TX modulation index test using a BLE tester instrument.				
Test name	The name assigned to each test. If this field is non-empty, then the assigned name will be shown on the tab and next to it an indication showing whether the specific test Is enabled or not.				
Frequency	The BLE channel frequency used in the BLE TX modulation index offset test.				
Power range	 Set the device TX output power range. Available options are: Auto +22 dBm to +7 dBm +9 dBm to -3 dBm +5 dBm to -7 dBm -4 dBm to -16 dBm -12 dBm to -26 dBm -24 dBm to -35 dBm Default value is Auto. 				
F1 min	Set the F1 minimum average limit in kHz for the TX modulation index pass/fail test criteria.				
F1 max	Set the F1 maximum average limit in kHz for the TX modulation index pass/fail test criteria.				
F2 max	Set the F2 maximum limit in kHz for the TX modulation index pass/fail test criteria.				
F1/F2 ratio	Set the F1/F2 maximum average ratio limit for the TX modulation index pass/fail test criteria.				

Table 69: BLE Tester Modulation Index - DA1468x





BLE Tester - RX Sensitivity

▲ RF Tests	
Golden Unit	BLE tester RX sensitivity test settings. RSSI_1 (✓) RSSI_2 (✓) RSSI_3 (✓) ✓ Enable Test name RSSI_1 Settings Frequency 2450 MHz Pattem PRBS9 → Spacing 625 us Num of packets 500 Tx power 0.00 dBm Dirty CRC alternate Limits RSSI limit >= -70.0 dBm

Figure 79: BLE Tester RX Sensitivity - DA1468x

Table 70 describes the available options for the RX Sensitivity test using a BLE Tester instrument.

Option	Description			
Enable	This option enables the specific RX sensitivity test using a BLE tester instrument.			
Test name	The name assigned to each test. If this field is non-empty, then the assigned name will be shown on the tab and next to it an indication showing whether the specific test Is enabled or not.			
Frequency	The BLE channel frequency used in the BLE RX sensitivity test.			
Pattern	 The bit pattern of the TX data. Available options are: PRBS9 10101010 11110000 			
Spacing	The packet spacing in μs.			
Num of packets	The number of packets the BLE tester instrument to transmit.			
Tx power	The TX output power of the BLE tester instrument. Suggested values are 0 to -10 dBm.			
Dirty	When enabled, the BLE tester packet generator can use a dirty table to transmit.			
CRC alternate	When enabled, the BLE tester will alternatingly send packets with CRC correct and CRC incorrect.			
RSSI limit	The RSSI limit for pass/fail criteria in the RF RX sensitivity test. If the average RSSI of the device after it has received the transmitted packets is less than this value, the test will be considered as failed.			

Table 70: BLE Tester RX Sensitivity - DA1468x

Path Losses per DUT

▲ RF Tests					
Golden Unit BLE Tester General TX Power Frequency Offset Modulation Index RX Sensitivity Path losses per DUT	Path losses per DUT DUT 1 40.00 DUT 2 40.00 DUT 3 36.00 DUT 4 36.00	 F. Values 0.00 to 40.00dE DUT 5 34.00 DUT 6 34.00 DUT 7 32.00 DUT 8 30.00 	3. DUT 9 30.00 DUT 10 32.00 DUT 11 34.00 DUT 12 34.00	DUT 13 36.00 DUT 14 36.00 DUT 15 40.00 DUT 16 40.00	

Figure 80: Path Losses per DUT - DA1468x

Table 71 describes the available options for the Path losses per DUT.

Based on the relative position of each DUT during the RF tests and since the RF tests are performed over the air, values can be used to correct for any path losses. These values are added to the limits of the TX Power and RF RX RSSI tests. Additional information can be found on 0.

Table 71: Path Losses per DUT from RF Tests DA1468x Options

Option	Description
DUT1-16	Set the path loss value for each DUT. These will be added as corrections to the limits of the TX Power and RF RX RSSI tests

7.2.10.3 Current Measurement Test

Current Measurement Test

```
Current measurement general settings
```

Enable

Settings					
Instrument	ammeter_scpi.dll		•		
Interface	USB0::0x2A8D::0x0	101::MY55	5500		
Idle current me	asurement				
Enable					
Settings					
Shunt resis	stor 0.00	Ohms	Wait time	1500	mSecs
Range	0.000	Amps	Resolution	0.0001	Amps
Samples	1()	SCPI cmd	CURR:DC:NPLC	:1
Limits per d	levice				
	- 0.0°	2 Amps	Total limit v	alue of 16 DUTs is	s 0,32.
Upper limit	0.04				

Figure 81: Current Measurement Tests - DA1468x

User Manual	Revision 4.3	03-Feb-2022



In this test an external ammeter instrument can be used to calculate the total current consumption of all the active DUTs at the time of the sampling. The ammeter instrument can be connected in the blue banana plugs as described in Current Measurements or to an external power supply (if present) depending the selected VBAT/Reset Mode.

During measurement PLT will control the instrument using the ammeter_driver DLL [1]. Table 72 describes the instrument selection settings found by the ammeter_driver DLL and in Table 73 the current measurement options for each sleep state.

Note: Modifications in the Production test firmware are mandatory in order to achieve the correct current consumption of a specific hardware design(IC and peripherals) for each sleep state. Running the default firmware without any modifications for the hardware design may cause increased current consumption.

Option	Description
Enable	This option enables all of Current Measurement tests, which include:
	Idle Current Measurement
	Extended Sleep Current Measurement
	Deep Sleep Current Measurement
	Only one of the Extended/Deep sleep current measurements can be selected, meaning that the other one will be disabled.
Instrument	Select the Ammeter instrument DLL name. Names are shown only if an ammeter instrument DLL exists in the project ammeter_instr_plugins folder.
Interface	The interface of the instrument to be used by the driver.

Table 72: Current Measurement Tests - DA1458x

Table 73: Current Measurement for each Sleep State

Option	Description
Enable	This option enables the specific current measurement using the ammeter instrument provided in the <i>Instrument</i> section.
Shunt resistor	The value of the shunt resistor used for idle current measurement. Applicable only if a voltmeter or a NI-DAQ is used to measure current instead of a DMM. Values from 0 to 9999 are supported.
Wait time	The time in milliseconds the PLT will wait before taking a current measurement, after it has sent an instruction to the DUTs to go into a specific sleep state. Supported values are 1 to 500000ms.
Sleep time (only for extended sleep)	The time in seconds that the DUTs will remain in extended sleep mode. A timer in the production test firmware will wake up the devices and set them to idle mode. Supported values are 1 to 1200sec.
Range	The range value in Ampere units that the ammeter instrument will operate. Supported values are 0 to 9999 and default value is 0.001A.
Resolution	The ammeter instrument resolution value in Ampere units.
Samples	The number of samples that the ammeter instrument will read and average. 1 to 1000 is supported.
SCPI cmd	An SCPI command to be passed to the ammeter instrument just before the measurement is taken. Supports multiple commands separated with a column. Up to 256 characters are supported.



Option	Description
Upper limit	The upper limit value for the extended sleep current measurement test procedure, for a single DUT.
	Next to this input field the total upper limit current consumption for all the enabled DUTs is shown, which is the value to be used during testing. Note: During testing some DUTs may fail until the current measurement test takes place, in that case the PLT will automatically re-calculate the total upper limit by using the value given for a single DUT multiplied with the number of the active DUTs at the time that the test will run.
Low limit	The low limit value for the extended sleep current measurement test procedure, for a single DUT.
	Next to this input field the total upper limit current consumption for all the enabled DUTs is shown, which is the value to be used during testing. Note: During testing some DUTs may fail until the current measurement test takes place, in that case the PLT will automatically re-calculate the total low limit by using the value given for a single DUT multiplied with the number of the active DUTs at the time that the test will run.

7.2.10.4 GPIO/LED Test

▲ GPIO\LED Tests	
GPI0_P1_0 (✓) GPI0_P1_2 (✓) GPI0_P1_3 (✓)	
Test name GPI0_P1_0	
Pin P1_0 Retries 10 Low 50 ms High 50 ms GPIO power level 3.3V	

Figure 82: GPIO/LED Tests - DA1468x

GPIO/LED Tests can have multiple instances with different settings. Tests can be added or removed using the two buttons (e.g. and and a in Figure 82) at the bottom right side of each panel.

Note: When adding or removing a test, all settings are refreshed with the values written to the XML file, meaning that any unsaved settings will be lost.

Table 74 describes the available options for the GPIO/LED Tests DA1468x Options.

In these tests a specific pulse can be given to a GPIO and any LED connected to it can be visually tested. The *Pin* option sets the GPIO to be used, *Low* and *High* define the duty cycle and the *Retries* the number of pulses.

Option	Description
Enable	This option enables the GPIO/LED toggling. Can be used for visual LED testing.
Test name	The name assigned to each test. If this field is non-empty, then the assigned name will be shown on the tab and next to it an indication showing whether the specific test Is enabled or not.
Pin	The GPIO that will be used for the specific test.
Retries	Number of pulses to be generated for the specific test.
Low	Sets the amount of the OFF time of the pulse in ms for the specific test.
High	Sets the amount of the ON time of the pulse in ms for the specific test.
GPIO power level	Sets the power level of the GPIOs.

Table 74: GPIO/LED Tests - DA1468x



DA1458x/DA1468x Production Line Tool

7.2.10.5 Sensor Test

▲ Sensor Tests	
SENS_TEST_1 (✓) SENS_TEST_2 (✓) SENS_TEST_3 (✓) Image: Sense test Image: Sense test Sense test]
Settings Test name SENS_TEST_1	
Read/Write mode Write - Register address 0x 00 Write data 0x AA	
SPI CLK P0_0 ▼ MISO P0_0 ▼ MOSI P0_0 ▼ CS P0_0 ▼	
I2C SCL P2_3 ▼ SDA P2_0 ▼ Slave address 0x 00	
Interrupt GPIO check Interrupt GPIO ▼	
GPIO power level 3.3V -	
Expected data 0x D1	

Figure 83: Sensor Test - DA1468x

Sensor Tests can have multiple instances with different settings. Tests can be added and removed using the two buttons (e.g. and in Figure 83) at the bottom right side of each panel.

Note: When adding or removing a test all settings are refreshed with the values written to the XML file, meaning that any unsaved settings will be lost.

Table 75 describes the available options for the Sensor Tests DA1468x Options.

Option	Description
Enable	This option enables the specific sensor test.
Test name	The name assigned to each test. If this field is non-empty, then the assigned name will be shown on the tab and next to it an indication showing whether the specific test Is enabled or not.
Read / Write mode	Select the sensor test procedure, to read or write.
Register address	The sensors register address to read or write data.
Write data	The byte to be written at the sensor register.
SPI / I2C	Select the interface that the sensor is connected to.
SPI - CLK	Select the GPIO for the sensor SPI CLK.
SPI - MISO	Select the GPIO for the sensor SPI MISO.
SPI - MOSI	Select the GPIO for the sensor SPI MOSI.
SPI - CS	Select the GPIO for the sensor SPI CS.
I2C - SCL	Select the GPIO for the sensor I2C SCL.
I2C - SDA	Select the GPIO for the sensor I2C SDA.
Slave address	The sensor I2C bus slave address.
Interrupt GPIO check	Enables the sensor interrupt signal test via GPIO.
Interrupt GPIO	Select the GPIO to be used as a sensor interrupt.
GPIO power level	Sets the power level of the GPIOs.

Table 75: Sensor Tests - DA1468x



DA1458x/DA1468x Production Line Tool

Option	Description
Expected data	The received sensor byte that will be expected on a successful operation.

7.2.10.6 ADC Calibration (DA14681-00 AD only)

ADC Calibration		
🔽 Enable		
Enable voltage	e meter	
Instrument	volt_meter_scpi.dll	•
Interface		GPIB0::22
VBAT voltage	3.700	
Validation limit	0.0030	
✓ Write to QSPI		
Verify		
Address Ox	00080121	
Write to OTP		
Verify		
<u> </u>		

Figure 84: ADC Calibration - DA14681-00 (AD)

Table 76 describes the available options for the *ADC Calibration* operation available and necessary only for DA14681-00 based devices.

Table 76: ADC Calibration - DA14681-00 (AD)

Option	Description
Enable	Enable the ADC calibration procedure for DA14681-00 devices.
Enable voltage meter	Enable the use of a voltage meter instrument in the ADC calibration procedure.
Instrument	Select the voltage meter instrument DLL. Names are shown only if a voltage measurement instrument DLL exists in the project folder volt_meter_instr_plugins.
Interface	The interface of the instrument to be used by the driver.
VBAT Voltage	Set the external VBAT value in volts.
Validation limit	After the ADC calibration procedure finishes a validation procedure will be performed to verify the result. This value indicates the validation limit in volts.
Write to QSPI	Enable the writing of the ADC calibration value to QSPI Flash.
Write to QSPI - Verify	Verify the writing of the ADC calibration value to QSPI Flash.
Address	The QSPI Flash address where the ADC calibration value will be burned.
Write to OTP	Enable the writing of the ADC calibration value to OTP.
Write to OTP - Verify	Verify the writing of the ADC calibration value to OTP.



7.2.10.7 Custom Test

▲ Custom Test	
CUST_TEST_1() CUST_TEST_2() CUST_TEST_3()	
Enable	
Test name CUST_TEST_1	
Command ID 0x 35	-

Figure 85: Custom Test - DA1468x

Custom tests can have multiple instances with different settings. Tests can be added and removed using the two buttons (e.g. \blacksquare and \blacksquare in Figure 85) at the bottom right side of each panel.

Note: When adding or removing a test all settings are refreshed with the values written to the XML file, meaning that any unsaved settings will be lost.

Table 77 describes the available options for the DA1468x Custom Tests.

When enabled, the PLT software will send an HCI command through UART to activate a customer defined test that will run on the DUTs. The HCI custom test command will contain a single byte as data (the *Command ID* byte), to be used mainly as identification for a specific test in the firmware. Default functionality of the production test firmware is to respond with the same *Command ID*. Otherwise the test will be considered as failed.

Table 77: Custom Tests DA1468x Options

Option	Description	
Enable	This option enables the specific custom test.	
Test name	The name assigned to each test. If this field is non-empty, then the assigned name will be shown on the tab and next to it an indication showing whether the specific test Is enabled or not.	
Command ID	The byte that will be sent to the device running the production test firmware.	

7.2.10.8 Temperature Measurement Test

▲ Temperature Measurement				
Temperature measurement general settings.				
Enable				
Settings				
Instrument	tmu_temp_sens.dll 🔹			
Interface	COM5			

Figure 86: Temperature Measurement Test - DA1468x

Table 78 describes the available options for the DA1468x Temperature Measurement Test.

Table 78: Ten	nperature Measurement	t Test - DA1468x
---------------	-----------------------	------------------

Option	Description	
Enable	This option enables the Temperature measurement test.	
Instrument	Select the Temperature measurement DLL. Names are shown only if a Temperature measurement instrument DLL exists in the project folder temp_meas_instr_plugins.	



DA1458x/DA1468x Production Line Tool

Option	Description
Interface	The interface of the instrument to be used by the driver.

7.2.10.9 Scan Test

_		
*	Scan Test	
_		
1	Enable	
	Scan retries	9
	DUT reboot	3
	DUT reboot difference	37
	DUT reboot time	25

Figure 87: Scan Test - DA1468x

Table 79 describes the available options for the DA1468x Scan Test.

By enabling this test, the Golden Unit will scan for the DUT's BD addresses advertised after the customer firmware has been burned. For this test to work, a bootable firmware with the ability to advertise with the BD address given by the PLT must be burned into each DUT. Additionally, the BD addresses provided by the PLT should be burned into OTP memory such that the devices advertise with the BD addresses the tool uses.

Table 79: Scan Test DA1468x Options

Option	Description
Enable	This option enables the Scan test.
Scan retries	The total number of BLE advertising scans the Golden Unit will perform.
DUT reboot	Define after how many retries the PLT will reboot the DUTs.
DUT reboot difference	Set the time difference between each DUT when the PLT reboots the devices, in order to avoid air collisions.
DUT reboot time	The time the VBAT will remain low during the device reboot. This value is time in ms*100. (e.g. 15 is 1500ms).



7.2.11 Memory Functions (DA1468x)

This section describes the Memory Functions settings available when using DA1468x devices. Memory functions include OTP and QSPI Flash memory programming.

7.2.11.1 **OTP Memory**

▲ OTP				
Vite enable				
No check	💿 Check empty 💿 Check if data match			
Verify image				
Different i	Different image per DUT			
Image path	binaries\\pxp_reporter_681_01.bin.cached			

Figure 88: OTP Memory - DA1468x

This test enables the OTP memory programming. Table 80 describes the available options for the *OTP Memory* image write operation.

Table 80: OTP Memory - DA1468x

Option	Description
Write enable	This option enables the OTP image write operation.
 No check Check empty Check if data match 	 Memory protection options: No check: No protection is enabled. PLT will attempt to burn the OTP memory without running any check. Check empty: PLT will first check if it the OTP memory to be burned is empty, and if it is it will then proceed to burn it. Check if data match: PLT will first check if the memory to be burned is empty. If it is not then it will compare its contents with the data to be burned. If the data are not the same the test will fail without making any change to the memory. If the data are the same, PLT will not perform any burning to the memory to prevent using the OTP repair memory for these devices.
Verify image	If this option is enabled, the PLT reads back the contents of the OTP memory and compares them to the original image file. If these do not match, the OTP memory programming will fail.
Different image per DUT	If this option is selected, a different image per DUT can be burned into the OTP. The image name must be specific for each DUT, as described below.
Image path	Via this field the user specifies the image file to be burned into the OTP. A .bin binary file of any name can be selected. If option <i>Different image per DUT</i> is selected, the user only selects the directory of the images. In that case the binary file names must have the following format: img_0x.bin, where 'X' denotes the DUT number. For example, if the user has activated DUTs 1, 5 and 10 then img_01.img, img_05.img and img_10.img binary files should exist in the selected OTP image path, as shown in Figure 64.



DA1458x/DA1468x Production Line Tool

7.2.11.2 QSPI Flash Memory

A QSPI Flash	
QSPI erase 1 (✓) QSPI Erase 2 (✓) QSPI Erase 3 (✓)	
Image: Check empty Image: Check empty Image: Check e	
Entire memory	
Start address 0x 00000000 Size 0x 00100000	
QSPI write 1 (✓) QSPI Write 2 (✓) QSPI Write 3 (✓) ✓ Write enable	
Test name	
Verify image	
Start address 0x 00000000	
Different image per DUT	
Image path binaries\\pxp_reporter_681_01.bin.cached	
	= 🗄

Figure 89: QSPI Flash - DA1468x

This section describes how the QSPI Flash memory can be erased and programmed.

Both erase and write operations can have multiple instances with different settings. Tests can be added and removed using the two buttons (e.g. and in Figure 89) at the bottom right side of each panel.

Note: When adding or removing a test all settings are refreshed with the values written to the XML file, meaning that any unsaved settings will be lost.

The QSPI Flash memory should be erased before any image is written to it. Table 81 describes the available options for the *QSPI Flash Erase* operation.

Option	Description
Erase enable	This will enable the specific QSPI Flash erase test.
Check empty	After Flash erasure the PLT software can verify the result by sending a specific command to the uartboot.bin firmware running in the DUT. The firmware will read the QSPI Flash and check if it is empty. The result will be returned to the PLT software.
Entire memory	This option is only available for the <i>Erase enable</i> option. When this checkbox is selected, the entire memory can be erased. Otherwise the user can give a start address and a specific number of bytes to be erased.
Start address	The user can enter a specific start address for the QSPI erasure to start.
Size	The size in bytes to erase, starting from the <i>Start address</i> as explained above.

Table 81: QSPI Flash Erase - DA1468x

After every QSPI Flash erase test has finished, the QSPI image write tests will begin. Table 82 describes the available options for the QSPI Flash Image Write operation.

Table 82: QSPI Flash Image Write - DA1468x

Option	Description
Write enable	This will enable the specific QSPI Flash image programming test.



Option	Description
Verify image	By selecting this option the PLT software will read back the contents of the QSPI Flash memory and compare them to the original image file. If these do not match, the QSPI memory programming will fail.
Start address	The user can configure the QSPI Flash start address where the image will be written.
Different image per DUT	If this option is selected, ten a different image per DUT can be burned into the QSPI Flash. The image name must be specific for each DUT, as described below.
Image path	Via this field the user specifies the image file to be burned into the QSPI Flash memory. A .bin binary file of any name can be selected.
	If option <i>Different image per DUT</i> is selected, the user only specifies the directory of the images. In that case the binary file names must have the following format: img_0X.bin, where 'X' denotes the DUT number. For example, if the user has activated DUTs 1, 5 and 10 then img_01.img, img_05.img and img_10.img binary files should exist in the selected QSPI image path, as shown in Figure 64.

7.2.11.3 Memory read

Memory Read	
OTP BDA AREA () OTP NVM () QSPI BDA ()	
Read enable	
Test name OTP BDA AREA Start address 0x 07F8EA58	
Size 32	
Memory type OTP -	
	- +

Figure 90: Memory Read Test - DA1468x

Table 83: Memory Read Test - DA1468x

Option	Description
Read enable	This will enable the specific memory reading test.
Test name	The name assigned to each test. If this field is non-empty, then the assigned name will be shown on the tab and next to it an indication showing whether the specific test Is enabled or not.
Start address	Configures the Start address for the read test. OTP valid address is 0x07F80000 – 0x7F8FFFF.
Size	Number of bytes to read, up to 256 bytes.
Memory type	The type of memory to read the data from. Available options are: OTP and QSPI FLASH.

7.2.12 Memory Header (DA1468x)

This section describes the Memory Header programming settings (OTP and QSPI), available when using DA1468x devices.



DA1458x/DA1468x Production Line Tool

7.2.12.1 OTP Header

▲ OTP Header	
General	
Vite Vite	
No check O Check empty Check if data match	
Verify	
Non-volatile memory FLASH -	
QSPI functions 0:Reset is in BootRom 1:Find "qQ" in BootRom 2:Loader is in BootRom 💌	
JTAG enable Yes 💌	
Mirrored \ Cached at startup Cached	
Product ready No 💌	
Write QSPI Flash Initialization Section	
Reset code	
Length 0x 00000000 Address 0x 00000000	
ID Code	
Length 0x 00000000 Address 0x 00000000	
Loader Code	
Length 0x 00000000 Address 0x 00000000	
Wakeup Code	
Length 0x 00000000 Address 0x 00000000	
Write loader file	
Loader path binaries\\qfis_loader.bin	

Figure 91: OTP Header - DA1468x

Table 84 describes the available options for the DA1468x OTP Header programming.

Option	Description
Write OTP Header	This option enables the OTP header programming.
 No check Check empty Check if data match 	Memory protection options: No check: No protection is enabled. PLT will attempt to burn the OTP memory without running any check. Check empty: PLT will first check if it the OTP memory to be burned is empty, and if
	it is it will then proceed to burn it. Check if data match: PLT will first check if the memory to be burned is empty. If it is not then it will compare its contents with the data to be burned. If the data are not the same the test will fail without making any change to the memory. If the data are the same, PLT will not perform any burning to the memory to prevent using the OTP repair memory for these devices.
Verify OTP Header	Each value written in the OTP header can be read back and compared with the original ones to verify a successful write.
Non-volatile memory	Enable OTP NVM mode. Available options are:FLASHOTP



DA1458x/DA1468x Production Line Tool

Option	Description
QSPI Functions	Select the QSPI functions. Available options are:
	• 0: Reset is in BootRom, 1: Find "qQ" in BootRom, 2: Loader is in BootRom
	• 0: Reset is in OTP, 1: Find "qQ" in BootRom, 2: Loader is in BootRom
	0: Reset is in BootRom, 1: Find "qQ" in OTP, 2: Loader is in BootRom
	• 0: Reset is in OTP, 1: Find "qQ" in OTP, 2: Loader is in BootRom
	0: Reset is in BootRom, 1: Find "qQ" in BootRom, 2: Loader is in OTP
	• 0: Reset is in OTP, 1: Find "qQ" in BootRom, 2: Loader is in OTP
	• 0: Reset is in BootRom, 1: Find "qQ" in OTP, 2: Loader is in OTP
	0: Reset is in OTP, 1: Find "qQ" in OTP, 2: Loader is in OTP
JTAG enable	Enable the JTAG support.
Mirrored/Cached at	Enable OTP cached mode. Available options are:
startup	Mirrored
	Cached
Product ready	When this flag is set the device will boot from the NVM selected (OTP or QSPI Flash). Should be used for a production ready device. If enabled, it will not be able to access the device again other than via JTAG, if this option is still enabled in the OTP header.
Write QSPI Flash Initialization Section	Enable the QSPI Flash Initialization Section.
Reset Code	The OTP header data for the QSPI reset code.
ID Code	The OTP header data for the QSPI "qQ" identification code.
Loader Code	The OTP header for the QSPI loader code.
Wakeup Code	The OTP header for the QSPI wakeup code.
Write loader file	Enable the writing of the loader file for the QSPI Flash Initialization Section.
Loader path	The file containing the data that will be burned in the QFIS loader.

7.2.12.2 OTP Header - BD Address

BD address		
1	Write	
	No check O Check em	pty 🔘 Check if data match
	Verify	Address 0x 07F8EA58
V	Read	Same address for both 'Write' and 'Read' actions.
	Compare	

Figure 92: OTP Header BD Address - DA1468x

Table 85 describes the available options for the DA1468x BD Address programming.

Table 85: OTP Header BD Address - DA1468x

Option	Description
Write	Enable burning the BD address into the device OTP header.



Option	Description	
No check	Memory protection options:	
 Check empty Check if data match 	No check: No protection is enabled. PLT will attempt to burn the OTP memory without running any check.	
	Check empty: PLT will first check if it the OTP memory to be burned is empty, and if it is it will then proceed to burn it.	
	Check if data match: PLT will first check if the memory to be burned is empty. If it is not then it will compare its contents with the data to be burned. If the data are not the same the test will fail without making any change to the memory. If the data are the same, PLT will not perform any burning to the memory to prevent using the OTP repair memory for these devices.	
Verify	When enabled, the PLT will read back the BD address burned into the OTP header and compare it to the one provided by the PLT.	
Read	This will read the BD address written in the OTP Header field. It does not depend on the previous tests to run, but it is necessary for the following <i>Compare</i> test.	
Compare	When the <i>Read</i> option is enabled, a comparison will be performed between the read BD address and the BD address entered in the DUT by the PLT, as described in the BD address DUT assignment method.	
Address	The OTP address where the BD address will be written. This field is the same for all o the above actions. Default value is 0x07F8EA58. OTP valid address is 0x07F80000 – 0x7F8FFFF.	

7.2.12.3 OTP Header - XTAL Trim

XTAL trim	
Vrite	
Verify	
Value 00 : 00 : 06 : 57	

Figure 93: OTP Header XTAL Trim - DA1468x

Table 86 describes the available options for the DA1468x OTP Header XTAL Trim programming operation.

Option	Description
Write	Enable burning the BD address into the device OTP header.
Verify	When enabled, the PLT will read back the BD address burned into the OTP header and compare it to the one provided by the PLT.
Value	Crystal oscillator calibration value common to all devices. Can be burned only if the automatic crystal burn calibration operation for the OTP memory in XTAL Trim is disabled.

Table 86: OTP Header XTAL Trim - DA1468x



DA1458x/DA1468x Production Line Tool

7.2.12.4 QSPI Header - BD Address

A QSPI Header	
BD address	
Vrite	
Verify	Address 0x 00080000
🔽 Read	Same address for both 'Write' and 'Read' actions.
Compare	

Figure 94: QSPI Header BD Address - DA1468x

Table 87 describes the available options for the DA1468x *BD Address* programming operation into the QSPI Header.

Table 87: QSPI Header BD Address - DA1468x

Option	Description	
Write	When selected the BD address will be written in the QSPI Header.	
Verify	If selected, the BD address will be read back from the QSPI Header and will be compared to the original.	
Read	This option will read the BD address written in the QSPI Header field. It does not depend on the previous tests to run, but it is necessary for the following <i>Compare</i> test.	
Compare	When the <i>Read</i> option is enabled, a comparison will be performed between the read BD address and the BD address entered in the DUT by the PLT, as described in the BD address DUT assignment method.	
Address	The QSPI Flash address where the BD address will be written. This field is the same for all of the above actions. Default value is 0x080000.	

7.2.12.5 QSPI Header - XTAL Trim

- XTAL trim	
Write	
Verify	
Address 0x 0008F000	
Value 00:00:06:57	

Figure 95: QSPI Header XTAL Trim

Table 88 describes the available options for the XTAL Trim programming into the QSPI Header.

Option	Description
Write	Enable burning a crystal oscillator calibration value, common to all devices.
Verify	When enabled, the crystal oscillator calibration value will be read back from the QSPI Flash and compared to the one the user has supplied.
Address	The QSPI Flash address where the crystal oscillator calibration value will be burned. Default value is 0x08F000.
Value	Crystal oscillator calibration value common to all devices. Can be burned only if the automatic crystal burn calibration operation for the QSPI memory in XTAL Trim is disabled.

Table 88: QSPI Header XTAL Trim

User Manual



DA1458x/DA1468x Production Line Tool

7.2.12.6 Custom Memory Data

om Memory Data Write enable		
Verify data		
Input Barcode scanner CSV file	Scanner interface Refresh COM1 Scan mode Automatic DUT posi CSV file path params\/mem_data_example.csv	ition 🔻
 Manual 	Edit data	00000000
Memory QS Start address 0x	PI	
Data size	23	
🔽 Use Homekit binan	y generator	
🔽 Unique data	3	

Figure 96: Custom Memory Data - DA1468x

Option	Description	
Write enable	This option enables the Custom data programming.	
Verify data	When selected, the data written will be read back from the memory and will be compared to the original.	
Barcode scanner	Custom data inpu	t options:
CSV fileManual data	Scanner interface (Barcode scanner)	Selection of the barcode scanner COM port from a dropdown list with all the available system COM ports.
		A common USB to UART barcode scanner is supported. PLT has been tested with Honeywell Xenon 1900. Appendix K describes the setup procedure.
		This option is the exact same option as in Scan Mode and the DA1458x devices in Custom Memory Data.
	Scan mode (Barcode scanner)	Scan DUT position: In this mode the users must first scan the DUT position number and then the BD address. The string used for the position of each DUT is "TEST POSITION 0xx" where "xx" is the DUT position number.
		Automatic DUT position: Scanned BD address will be assigned to the selected DUT. The DUT selection is automatically been made, starting from the first active DUT and selecting the next one after a successful BD address scan. Users can change the selected DUT using the controls on the GUI PLT screen shown in Figure 102.
		This option is the exact same option as in Scan Mode and the DA1458x devices in Custom Memory Data.
	CSV file path (CSV file)	Path to the CSV file containing data for each device discriminated using BD addresses. The CSV file format is described in Custom data CSV file format.
	Edit data (Manual data)	Hexadecimal data input of up to 256 bytes to burn. These data will be burned to all active DUTs.



Option	Description	
Memory (available with Barcode scanner and Manual data modes)	Memory type selection to burn the data. Available options are OTP and QSPI.	
Start address (available with Barcode scanner and Manual data modes)	Memory address offset to begin burning the data. OTP valid address is 0x07F80000 – 0x7F8FFFF.	
Data size (available with Barcode scanner	The size of the memory data to burn. In barcode scanner, the data size is the number of scanned ASCII characters. In manual data, data size is the number of bytes.	
and Manual data modes)	If the Homekit binary generator is used, the data size entered here is the size of the setup code and serial number as explained in Table 16. In the example the data to be scanned are "12345678DIAG97969594P", meaning that the data size should be 21 since ASCII character will be scanned The data size to be actually burned into the devices will be 574 bytes, which is the binary size created by the SetupCode_Generator_680.exe application.	
Use Homekit binary generator (available with Barcode scanner mode)	If enabled the input memory data from the barcode scanner will be applied as input to the Dialog Homekit setup code binary generator. PLT will automatically call the setup code binary generator and burn the files created.	
Unique data (available with Barcode scanner mode)	If enabled the input memory data will be compared to each other and if same data are found an error will be issued. Comparison can only be performed per current PLT test run and not for previous tested devices.	
Binary generator (available with Barcode scanner mode)	The path to the Homekit setup code binary generator executable. PLT will automatically call this application and burn the files created.	

7.2.13 Debug Settings

▲ Debug Settings	
UI PLTD PDLL UDLL CFG DLL BLE Tester Ammeter Temperature measurement Barcode scanner	✓ Enable Output ✓ Console ✓ Console ✓ Error ✓ Error ✓ Info ✓ Error ✓ Info ✓ Ul_debug.txt

Figure 97: Debug Settings

Table 90 describes the available options for the *Debug Settings*. Debug messages are available in all PLT software blocks shown in Figure 20.

Note: Printing debug information may introduce system delay and thus some tests may fail due to time out expirations. We suggest having debug information disabled in all software blocks and only partially enable when there is a real need for it. From PLT v4.0 and onwards, this system delay has been almost eliminated as debug print messages are printed from a lower priority queue. It is safer, but it is still suggested to have the debug prints disabled.

Table 90: Debug Settings

Option	Description
Enable	Enable debug message prints for the selected library or UI.
Output - Console	Sends the debug messages to the stdio output. The PLT CLI does not support this option. If enabled, debug messages will be redirected to the equivalent files.
Output - File	Save the debug messages to a file.
Level - Error	Enable error debug level messages. All debug print messages marked as error will be printed.
Level - Info	Enable info debug level messages. All debug print messages marked as info will be printed.
Level - Debug	Enable low level debug level messages. All low level debug print messages will be printed.
File path	Select the file that the debug messages will be saved. The file should exist, otherwise it should be created manually. Used only when the option <i>Output - File</i> is selected.

7.2.14 Security

Change Password			
Old Password			
Disable password			
New Password			
Retype New Password			

Figure 98: Security

In this field a password can be set to protect specific tool actions, such as:

- Opening the CFG PLT or the GUI PLT application.
- Closing the CFG PLT or the GUI PLT application.
- Opening or refreshing configuration settings in the GUI PLT application.
- Opening the settings menu in the GUI PLT application.

Table 91 describes the available options for the Security Options.

Option	Description	
Old Password	Type the current password to enable changing of the following fields.	
Disable Password	This option will disable the password usage.	
New Password	Password Type a new password.	
Retype New Password	Verify the new password.	

Table 91: Security Options

7.3 GUI PLT Application

The GUI PLT (DA1458x_DA1468x_GUI_PLT.exe) is a Graphical User Interface application that performs the device validation and programming process. At the same time it allows the users to

User Manual



monitor the entire procedure in detail. The GUI PLT uses the same XML file configured from CFG PLT as described in section 7.2.

Note: If a change is made to the XML file from the CFG PLT, then the GUI PLT settings should be refreshed as described in Table 92.

Figure 99 shows the initial screen of the GUI PLT, which is described in Table 92.

DA1458x/DA1468x Production	on Line To	ool - v_4.x.x.x						
File Edit Run								
Start BD address 80:EA:CA:80:00:19	DUT	BD Addres	s Code		Stat	us		Result
Next BD address	1	80:EA:CA:80:00:19						
80:EA:CA:80:00:19	2	80:EA:CA:80:00:1A						
End BD address 00:00:00:00:00:00	3	80:EA:CA:80:00:1B						
Statistics	4	80:EA:CA:80:00:1C						
Pass: 0 Fail: 0	5	80:EA:CA:80:00:1D						
Total: 0 Left: 0	6	80:EA:CA:80:00:1E						
Runs: 0	7	80:EA:CA:80:00:1F						
IC DA14580	8	80:EA:CA:80:00:20						
COM Enum	9	80:EA:CA:80:00:21						
🔲 GU Check	10	80:EA:CA:80:00:22						
VBAT/UART	11	80:EA:CA:80:00:23						
UART check	12	80:EA:CA:80:00:24						
	13	80:EA:CA:80:00:25						
	14	80:EA:CA:80:00:26						
	15	80:EA:CA:80:00:27						
	16	80:EA:CA:80:00:28						
	GU	COM Port	Code		Stat	us		Result
		COM14						
		[BLE Tester	Temp	Ammeter	Voltmeter		
				. on p				
		L]	
Smartbond				ST	ART			
C:\DA1458x_DA1468x_PLT_v4.x\pa	irams\para	ams.xml				Retest failed:	Enabled Test Ti	me: 00:00:000

Figure 99: GUI PLT Main Screen

Table 92: GUI PLT Main Screen Description

Options	Description	
File options		
File > Open XML file	Opens a new XML file and loads its settings. The full path of the new XML file is shown at the bottom end of the screen.	
File > Refresh XML file	Reloads the settings from the XML file and initializes itself with the new settings.	
File > Open CSV file	Contains a list with all the available CSV files to open.	
File > Exit	Exits the GUI PLT application.	
Edit options		
Edit > Settings	Opens the GUI PLT Settings window.	



Options	Description
Run options	
Run > Run Configuration PLT	Opens the CFG PLT application.
Left Column options	
Start BD Address	The BD address the PLT session started with, as described in section 7.2.4.
Next BD Address	The BD address that will be used on the BD address assignment for the next run as described in section 7.2.4.
End BD Address	The BD address the PLT session ends with as described in section 7.2.4. This option is available only when <i>Range mode</i> is enabled.
Statistics	This field holds statistics for each PLT session. Table 27 describes the <i>Statistics</i> field.
IC	The selected IC of the PLT.
COM Enum	If this checkbox is enabled then the START button initiates the automatic Window COM port enumeration for the DUT.
GU Check	If this checkbox is enabled then the START button initiates the automatic Window COM port enumeration for the Golden Unit.
VBAT/UART	If this checkbox is enabled then the START button will enable the VBAT and UART for the DUTs selected under <i>VBAT/UART</i> in Table 93.
UART check	If this checkbox is enabled then the START button initiates the UART check procedure for the DUTs with a specified Baud rate set from the user through the GUI PLT Settings. During this test 1000 packets will be sent, received back and checked for errors. For the DA14580/1/2/3 and DA1468x DUTs the packets contain 252 bytes and for the DA1585/6 DUTs 100 bytes of data. Note: Before any UART transfer begins PLT ill download the production test firmware to the active DUTs.
Center screen options	·
DUT panel	Shows the following fields for each DUT:
	• DUT: DUT connector number on the PLT hardware. This field is also a button which opens the Log file for the specific DUT.
	• BD Address: BD address assigned to the DUT.
	• Code: Real-time status as a PLTD DLL special code described in [1].
	• Description: A brief description of the status code.
	• Result: Simplified color coded status showing the progress per DUT.
GU panel	Shows the following fields for the Golden Unit:
	• GU: A button which opens the Golden Unit Log file.
	COM Port: The COM port assigned to the Golden Unit.
	• Code: Real-time status as a PLTD DLL special code described in [1].
	• Status: A brief description of the status code.
	• Result: Simplified color coded status showing the progress of the GU.
Instrument panel	This field shows a simplified color coded status is shown for each of the instruments (BLE Tester , Temp, Ammeter and Voltmeter), if they are enabled.
START button	If one of the options <i>COM Enum</i> , <i>GU Check</i> , <i>VBAT/UART</i> or <i>UART check</i> is enabled, then pressing the <i>START</i> button will initiate the chosen test. If no option is selected, pressing the <i>START</i> button initiates the production procedure.
Bottom of the main screen	
Left panel: C:\Release\params\params.xml	Shows the full path of the XML file that is currently used.
C. Wreiease yaranis yaranis XIII	

User	M	an	ual
USCI		a	ua



DA1458x/DA1468x Production Line Tool

Options	Description
Center panel: Retest failed: Disabled	Shows if the Re-test option in GUI PLT Settings is enabled.
Right panel: Test Time: 00:00:000	This timer starts counting when the START button is pressed and runs until the PLT returns to its idle state, showing the approximate duration of the tests.

7.3.1 GUI PLT Settings

GUI settings
Hide results
BD address Code Status GU
Hide instruments
BLE Tester Temp Voltmeter Ammeter
Retest failed DUTs
Enable Ask to retry
Multiple runs
Enable
Times 0 Set
Test options
Production tests V Memory programming
VBAT/UART
Init DUTs 0x 0000 Set
UART check
Baud rate 1000000 -
Close

Figure 100: GUI PLT Settings

Figure 100 shows the *GUI PLT settings* window. In this window various graphic options and features can be set as described in Table 93.

Table 93: GUI PLT Settings

Field	Option	Description
Hide results	BD address	This option will hide the <i>BD address</i> column in the DUT panel of the GUI PLT.
	Code	This option will hide the <i>Code</i> column in the DUT panel of the GUI PLT.
	Status	This option will hide the <i>Status</i> column in the DUT panel of the GUI PLT.
	GU	This option will hide the <i>GU</i> column in the DUT panel of the GUI PLT.
Hide instruments	BLE Tester	This option will hide the <i>BLE Tester</i> column in the GU panel of the GUI PLT.
	Temp	This option will hide the <i>Temp</i> column in the GU panel of the GUI PLT.

User Manual

Revision 4.3



Field	Option	Description
	Voltmeter	This option will hide the <i>Voltmeter</i> column in the GU panel of the GUI PLT.
	Ammeter	This option will hide the <i>Ammeter</i> column in the GU panel of the GUI PLT.
Retest failed DUTs	Enable	If this option is enabled, any DUT that failed during the main procedure will immediately re-run the tests having the exact same options including the <i>BD address</i> assigned to it. This option is the exact same option as <i>Re-test failed DUTs</i> in section 7.2.3.2.
	Ask to retry	This option will show a message asking to do a re-test in case any DUT failed. If this option is disabled, the re-testing will be done automatically.
Multiple Runs	Enable	By enabling this option the GUI PLT will perform multiple procedures without any delay between them. This is used for only for evaluation.
	Times	The number of times to run.
Test Options	Production tests	Enables /Disables the production test procedure. This is the same option as <i>Production tests</i> in section 7.2.3.2.
	Memory programming	Enables /Disables the production test procedure. This is the same option as <i>Memory programming</i> in section 7.2.3.2.
VBAT/UART	Init	If this option is enabled, the PLT hardware will be reset before enabling the DUTs. This option is enabled only when <i>VBAT/UART</i> in the main screen is enabled.
	DUTs	Bitwise DUT set/reset for each of the 16 DUTs using a 16-bit hexadecimal value. 089
		Example: To enable only DUTs 1, 2, 15 and 16 use "C003" (1100 0000 0000 0011 = 0xC003).
UART check	Baud rate	Sets the Baud rate for the UART check test.

7.3.2 Barcode Scanner Mode

A barcode scanner can be used for two purposes. It can be used to scan DUT BD addresses and/or Custom Memory Data. If any these options have the Barcode scanner option enabled then the Barcode Scan option will appear in the GUI PLT as shown in Figure 101. If both options are enabled then the GUI PLT will first use the Barcode scanner for the BD address Scan Mode assignment and then for the Custom Memory Data.

In all cases described in section 7.2.4.1 except Scan Mode, the GUI PLT assigns BD addresses right before the PLT starts the production test run. Device BD addresses should be scanned before the start of a production test run. If the *START* button is pressed without any BD address being assigned to the device, the PLT will **not** run the tests.



IC DA14681-01 (AE)
COM Enum
GU Check
VBAT/UART
UART check
Barcode Scan

Figure 101: Barcode Scan Option in GUI PLT

Two different device BD address scanning procedures are supported. If the same BD address is used twice an error message appears in the DUT panel. It then waits for a unique BD address. An example is shown in Figure 103.

- 1. Scan DUT position. In this mode the user must first scan the DUT position and then the BD address. The string used for the position of each DUT is "TEST POSITION 0xx" where "xx" is the DUT number 1 to 16.
- 2. Automatic DUT position. The scanned BD address will be assigned to the selected DUT. DUT selection is done automatically. The PLT starts from the first active DUT and goes to the next after a successful BD address scan. The user can change the selected DUT via the controls shown in Figure 102. If the scanned BD address was successfully assigned, the PLT will automatically select the next active DUT and wait for a new BD address to be scanned.



Figure 102: Barcode Scanner Controls

If the Custom Memory Data test requires data to be scanned then the user must scan the Custom data after the BD address for each DUT. Homekit Setup Code Scan Example provides detailed steps showing how to scan both BD addresses and data for the Custom Memory data test.

After all active DUTs have BD addresses assigned, the user should press the *END* button in the controls to return to the main screen. Pressing the *START* button will then start the test execution.

Note: If the *Barcode Scan* button is pressed again, all BD addresses will be reset and the BD address assignment procedure will begin again.

DUT	BD Address	Code	Status	Result
1	11:22:33:44:55:06		BARCODE SCANNER BD ADDRESS OK	PASS
2	00:00:00:00:00:00		BD ADDRESS 11:22:33:44:55:06 ALREADY USED. RETRY	CHECK
3	11:22:33:44:55:08		BARCODE SCANNER BD ADDRESS OK	PASS
4	11:22:33:44:55:09		BARCODE SCANNER BD ADDRESS OK	PASS
9	11:22:33:44:55:13		BARCODE SCANNER BD ADDRESS OK	PASS
10	00:00:00:00:00:00			
11	00:00:00:00:00			
12	00:00:00:00:00:00			

Figure 103: Barcode Scan - BD Address Assignment

User Manual

7.3.2.1 Homekit Setup Code Scan Example

An example of using the barcode scanner and Custom Memory Data will be given. A barcode scanner will be used to scan different Homekit setup codes. PLT will call the *SetupCode_Generator_680.exe* application to create the binaries that contains the DUTs serial numbers and the hashed version of the setup codes. Finally it will program the binaries to the DUTs. The process will be described in Table 94. The example will use DA14681-01 DUTs and configure the PLT such that to perform XTAL trim test, RF test and homekit setup code scanning and programming.

#	Action										
1	Copy PLT software DA1458x_DA146	8x_PLT_v_4.x.x.x und	er C: \ directory								
2	Open DA1458x_DA1468x_CFG_PLT.exe.										
	► DA1458x_DA1468x_PLT_v4.x ►										
	ler										
	Name	Date modified	Туре	Size							
	ammeter_instr_plugins	9/10/2017 7:03 µµ	File folder								
	🌗 binaries	9/10/2017 7:03 µµ	File folder								
	ble_tester_instr_plugins	9/10/2017 7:03 µµ	File folder								
	퉬 icons	9/10/2017 7:03 µµ	File folder								
	IQmeasure_3.1.2	9/10/2017 7:03 µµ	File folder								
	🌗 params	9/10/2017 7:03 µµ	File folder								
	퉬 scripts	9/10/2017 7:03 µµ	File folder								
	temp_meas_instr_plugins	9/10/2017 7:03 µµ	File folder								
	volt_meter_instr_plugins	9/10/2017 7:03 μμ	File folder								
	a DA1458x_DA1468x_CFG_PLT.exe	9/10/2017 3:29 µµ	Application	3.277 KB							
	DA1458x_DA1468x_CLI_PLT.exe	9/10/2017 3:27 µµ	Application	567 KB							
	DA1458x_DA1468x_GUI_PLT.exe	9/10/2017 3:28 µµ	Application	660 KB							
	Device IC Device IC DA14681-01 (AE)										
ļ	Go to Hardware Setup-> Active DL button.	JTs and select DUT13, I	DUT14, DUT15	and <i>DUT16</i> . Press th	ie Save						
	▲ Active DUTs										
	🔲 DUT 1 📃 DUT 5	DUT 9 👽 DUT 13	}								
	DUT 2 DUT 6	DUT 10	ļ.								
	DUT 3 DUT 7	DUT 11 🔽 DUT 15									
	DUT 4 DUT 8	DUT 12 🛛 🛛 DUT 16	5								
5	Go to Hardware Setup-> Golden U Press the Save*button.	Init COM Port and auto-o	detect the COM	port. Press the Auto	button						
	Golden Unit COM Port										
	Set the GU COM port Auto Refre	sh COM4 👻									

Table 94: Homekit Setup Code Scan Example



#	Action							
6	Go to <i>Test Settings->XTAL Trim</i> and enable the settings as shown in the following picture. Press the <i>Save*</i> button.							
	These settings will enable the XTAL trim calibration test. The result of the XTAL trim calibration will be saved into QSPI flash. Dialog SDK firmware is able to read the value from this specific QSPI address (0x8F000) and apply it to the appropriate chipset XTAL trim register.							
	▲ XTAL Trim							
	☑ Enable GPIO input pulse pin P2_3 ▼							
	Bum to OTP							
	Burn to QSPI							
	Address 0x 0008F000							
7	Go to <i>Test Settings->RF Tests</i> and enable the settings shown in the following picture. Three RF tests at channels 2424MHz, 2450MHz and 2476MHz are already enabled in the PLT by default. Check that all settings are correct. Press the <i>Save*</i> button.							
	▲ RF Tests							
	Golden Unit BLE Tester Path losses per DUT RF RX test settings using the Golden Unit. GU_RSSI_1 (✓) GU_RSSI_3 (✓)							
	Image: Weight of the second secon							
	Settings							
	Frequency 2424 VHz							
	Limits							
	RSSI limit >= -70.0 dBm							
8	Deselect everything in <i>Memory Functions</i> tab. No need to burn any image for this example. Press the <i>Save*</i> button.							
9	Connect to the PC a USB to Serial (COM) barcode scanner instrument. Keep the Windows COM port assigned to the instrument.							





#	Action									
10	Change the So	Header->Custom canner Interface C he Save*button.					ollowing picture. arcode scanner in			
	Custom Memory Data									
	Custom Memory Data									
	Write enable									
	Verify da	ta								
	Input									
	e Barcode	scanner Scanner interf	Scan mode	Automatic DUT positio	n 🔻					
	CSV file	CSV file path	params\\m	em_data_example.csv						
	Manual	Edit data					0000000			
	Memory	QSPI -								
	Start addres	s 0x 000E1000								
	Data size	21								
	 ✓ Use Homekit binary generator ✓ Unique data Binary generator binaries\\SetupCode_Generator_680.exe 									
	Dinary	Dinanes (Sec	upcode_de	leiatoi_oou.exe						
11	Close DA1458	x_DA1468x_CFG	_PLT.exe	e and open DA145	58x_DA14	68x_GUI_PLT.ex	ĸe.			
12	The initial DA1	458x DA1468x 0	SUI PLT.	exe screen will ap	pear.					
	File Edit Run									
	Start BD address 00:00:00:00:00:00	DUT BD Address 13 00:00:00:00:00:01	Code	Status	5	Result				
	Next BD address 00:00:00:00:00:01	13 00:00:00:00:00:00 14 00:00:00:00:00:00 20:00:00:00:00								
	End BD address	15 00:00:00:00:00:02								
	00:00:00:00:00:00	16 00:00:00:00:04								
	Pass: 0 Fail: 0	GU COM Port	Code	Status	5	Result				
	Total: 0 Left 0	COM4								
	Runs: 0		DIE	Tester Temp Voltm	otor					
	IC DA14681-01 (AE)		DLL	rester remp volum	eter					
	COM Enum									
	GU Check									
	VBAT/UART									
	Barcode Scan									
	sh III (a			OTADT						
	Smart bond			START						
	C:\DA1458x_DA1468x_PLT_v_4.x	params\params.xml			Retest failed: I	Disabled Test Time: 00:00:000				



#	Action					
13	Press the Barco	ode Scan b	utton on	the bottom left corner. The following sci	een will a	ppear.
	File Edit Run					
	Start BD address 00:00:00:00:00:01		D Address	Memory Data	Result	
	Next BD address 00:00:00:00:00:01		0:00:00:01		2	
	End BD address 00:00:00:00:00:00		0:00:00:03			
	Statistics	16 00:00:0	0:00:00:04			
	Pass: 0 Fail: 0	GU	COM Port	Status	Result	
	Total: 0 Left: 0 Runs: 0		COM4			
	IC			BLE Tester Temp Voltmeter		
	DA14681-01 (AE)					
	GU Check					
	UBAT/UART					
	Barcode Scan					
	1) III (a	1	PREV	END		
	Smart bond		PREV	END		
	C:\DA1458x_DA1468x_PLT_v_4.x\p	arams\params.xml		Retest failed: Disabled	Test Time: 00:00:000	
14	Use the barcod	e scanner i	nstrume	nt to scan four different homekit setup c	odes with	specific format as
				ur different example codes are given ne		op como ronnar ao
		45953404LU09G:	14000096	23793852LU()9G1A000161	
		44613980LU09G:	1A000011	56795235LU0:	9G1A000038	
15	When the barco	odes, given	in step 1	4, are scanned using the barcode scan	ner instru	ment the GUI PLT will
	be as shown ne		·			
	File Edit Run Start BD address					
	00:00:00:00:00:01		O Address	Memory Data 45953404LU09G1A00009	Result OK	
	Next BD address 00:00:00:00:00:01		0:00:00:02	23793852LU09G1A00016	ок	
	End BD address 00:00:00:00:00:00	15 00:00:00	0:00:00:03	44613980LU09G1A00001	ОК	
	Statistics Pass: 0	16 00:00:00	0:00:00:04	56795235LU09G1A00003	ок	
	Pass: 0 Fail: 0 Total: 0	GU C	OM Port	Status	Result	
	Left: 0 Runs: 0		COM4			
	IC DA14681-01 (AE)			BLE Tester Temp Voltmeter		
	GU Check					
	VBAT/UART					
	Barcode Scan					
			,			
	sti 💶 (te	ſ	PREV	END		
	Smart bond	l	FREV			
	C:\DA1458x_DA1468x_PLT_v_4.x\pa	rams\params.xml	l	Retest failed: Disabled	st Time: 00:00:000	
16	If something ao	es wrona.	either na	vigate to the different DUT Memory Data	a cells usi	ing the PREV/NEXT
				nd then the <i>Barcode Scan</i> button again		
	previous scanne	ed data wil	l be eras	ed.		
		ent well just	press th	e END button. The tool will return to its	initial scre	een as shown in step
	12.					



	Action							
17	Press the Spac	ce keyboard key t	o start the	PLT tests. The PLT	process will p	proceed.		
	Start BD address 00:00:00:00:00:01	DUT BD Address	Code	Status		Result		
	Next BD address 00:00:00:00:00:05	13 00:00:00:00:00:01	0 NOT ACT					
	End BD address	14 00:00:00:00:00:00 15 00:00:00:00:00:03		T IDENTIFY STARTED		PASS		
	00:00:00:00:00:00 Statistics	16 00:00:00:00:00:04		T IDENTIFY OK		PASS		
	Pass: 0 Fail: 0	GU COM Port	Code	Status		Result		
	Total: 0 Left: 0 Runs: 1	COM4	34 RD TESTE	ER COM LOOPBACK OK		ОК		
	IC DA14681-01 (AE)		BLE Test					
	COM Enum		NUTUSE	D NOT USED NOT USED				
	GU Check							
	Barcode Scan							
	Ssmart bond							
	C:\DA1458x_DA1468x_PLT_v_4.x\p	params\params.xml		Ret	est failed: Disabled Test 1	Time: 00:05:048		
18	create four diffe DA1458x_DA1	erent binaries. Th /468x_PLT_v_4.x	e binaries \ x.x\execut	ables\binaries.			000.exe il	J
	► DA1458x_DA14	468x_PLT_v_4.x ▶ ex	ecutables 🕨	binaries 🕨				
	e with 🔻 New	v folder						
		~			-			
	Name			Date modified	Туре	Size		
	Name			Date modified 08-Mar-17 4:49 PM	lype File folder	Size		
	鷆 GU	2LU09G1A00016.bin				Size	1 KB	
	↓ GU 23793852	2LU09G1A00016.bin 0LU09G1A00001.bin		08-Mar-17 4:49 PM	File folder	Size	1 KB 1 KB	
	GU 23793852 44613980			08-Mar-17 4:49 PM 08-Mar-17 5:18 PM	File folder BIN File	Size		
	GU 23793852 44613980 45953404	0LU09G1A00001.bin		08-Mar-17 4:49 PM 08-Mar-17 5:18 PM 08-Mar-17 5:18 PM	File folder BIN File BIN File	Size	1 KB	
19	GU 23793852 44613980 45953404 56795235 If everything fir	0LU09G1A00001.bin 4LU09G1A00009.bin 5LU09G1A00003.bin	or the follow	08-Mar-17 4:49 PM 08-Mar-17 5:18 PM 08-Mar-17 5:18 PM 08-Mar-17 5:18 PM	File folder BIN File BIN File BIN File BIN File	Size	1 KB 1 KB	
19	GU 23793852 44613980 45953404 56795233	0LU09G1A00001.bin 4LU09G1A00009.bin 5LU09G1A00003.bin	or the follov	08-Mar-17 4:49 PM 08-Mar-17 5:18 PM 08-Mar-17 5:18 PM 08-Mar-17 5:18 PM 08-Mar-17 5:18 PM	File folder BIN File BIN File BIN File BIN File	Size	1 KB 1 KB	
19	GU 23793852 44613980 45953404 56795235 If everything fir File Edit Run Start BD address 00000.0000.001 Next BD address	0LU09G1A00001.bin 4LU09G1A00009.bin 5LU09G1A00003.bin hished with no err	Code 215 CUSTON	08-Mar-17 4:49 PM 08-Mar-17 5:18 PM 08-Mar-17 5:18 PM 08-Mar-17 5:18 PM 08-Mar-17 5:18 PM wing screen will be s Status	File folder BIN File BIN File BIN File BIN File	Result PASS	1 KB 1 KB	
19	GU 23793852 44613980 45953404 5679523 If everything fin File Edit Run Start BD address 00000.000000 Next BD address 00000.000005 End BD address	0LU09G1A00001.bin 4LU09G1A00009.bin 5LU09G1A00003.bin hished with no err 13 00000000001 14 000000000002	Code 215 CUSTON 215 CUSTON	08-Mar-17 4:49 PM 08-Mar-17 5:18 PM 08-Mar-17 5:18 PM 08-Mar-17 5:18 PM 08-Mar-17 5:18 PM wing screen will be s Status ADATA WRITE OK	File folder BIN File BIN File BIN File BIN File	Result PASS PASS	1 KB 1 KB	
19	GU 23793852 44613980 45953404 56795233 If everything fir File Edit Run Start BD address 0000.00.000.05 End BD address 0000.00.000.05 End BD address 0000.00.000.05 Statistics	DLU09G1A00001.bin 4LU09G1A00009.bin 5LU09G1A00003.bin hished with no err	Code 215 CUSTON 215 CUSTON 215 CUSTON 215 CUSTON	08-Mar-17 4:49 PM 08-Mar-17 5:18 PM 08-Mar-17 5:18 PM 08-Mar-17 5:18 PM 08-Mar-17 5:18 PM wing screen will be s Status	File folder BIN File BIN File BIN File BIN File	Result PASS	1 KB 1 KB	
19	GU 23793852 44613980 45953404 56795235 If everything fin File Edit Run Start BD address 0000.00.00005 End BD address 0000.00.0005 End BD address 0000.00005 End BD address 0000.00005 End BD address 0000.00005 End BD address 0000.00005 End BD address 00000000005 End BD address 0000000005 End BD address 000000005 End BD address 00000005 End BD address 000000005 End BD address 00000005 End BD address 0000005 End BD address 0000005 End BD address 00000005 End BD address 0000005 End BD address 00000005 End BD address 0000005 End BD address 000005 End BD address 000005 End BD address 00000	DLU09G1A00001.bin 4LU09G1A00009.bin 5LU09G1A00003.bin hished with no err DUT BD Address 13 000000000.01 14 00000000.02 15 00000000.03 16 0000000.04 GU COM Port	Code 215 CUSTON 215 CUSTON 215 CUSTON 215 CUSTON 215 CUSTON 215 CUSTON Code Code	08-Mar-17 4:49 PM 08-Mar-17 5:18 PM 08-Mar-17 5:18 PM 08-Mar-17 5:18 PM 08-Mar-17 5:18 PM wing screen will be s Status ADATA WRITE OK ADATA WRITE OK ADATA WRITE OK ADATA WRITE OK ADATA WRITE OK ADATA WRITE OK	File folder BIN File BIN File BIN File BIN File	Result PASS PASS PASS PASS PASS Result	1 KB 1 KB	
19	GU 23793852 44613980 44613980 45953404 56795233 If everything fir File Edit Run Start BD address 00000000000 Next BD address 00000000000 Statistics Pass: 4	0LU09G1A00001.bin 4LU09G1A00009.bin 5LU09G1A00003.bin hished with no err 13 000000000001 14 00000000000 15 000000000000000000000000	Code 215 CUSTON 215 CUSTON 215 CUSTON 215 CUSTON 215 CUSTON	08-Mar-17 4:49 PM 08-Mar-17 5:18 PM 08-Mar-17 5:18 PM 08-Mar-17 5:18 PM 08-Mar-17 5:18 PM wing screen will be s Status ADATA WRITE OK ADATA WRITE OK ADATA WRITE OK ADATA WRITE OK ADATA WRITE OK ADATA WRITE OK	File folder BIN File BIN File BIN File BIN File	Result PASS PASS PASS PASS PASS	1 KB 1 KB	
9	GU 23793852 44613980 45953404 56795233 If everything fir File Edit Run Start BD address 000000.000000 Next BD address 000000.000000 Statistics Pass: 4 Fail: 0 Total: 0 Runs: 1 IC	DLU09G1A00001.bin 4LU09G1A00009.bin 5LU09G1A00003.bin hished with no err DUT BD Address 13 000000000.01 14 00000000.02 15 00000000.03 16 0000000.04 GU COM Port	Code 215 CUSTON 215 CUSTON 215 CUSTON 215 CUSTON 215 CUSTON 226 RD TEST BLE Test	08-Mar-17 4:49 PM 08-Mar-17 5:18 PM 08-Mar-17 5:18 PM 08-Mar-17 5:18 PM 08-Mar-17 5:18 PM Wing screen will be s Status MADTA WRITE OK ADATA WRITE OK ADATA WRITE OK MDATA WRITE OK Status TER INIT OK Ster Temp Voltmeter	File folder BIN File BIN File BIN File BIN File	Result PASS PASS PASS PASS PASS Result	1 KB 1 KB	
9	GU 23793852 44613980 45953404 56795235 If everything fin File Edit Run Start BD address 0000.00.000.05 End BD address 0000.00.00005 End BD address 0000.000005 End BD address 0000.00005 End BD address 000000005 End BD address 0000000005 End BD address 000000005 End BD address 000000005 End BD address 0000000005 End BD address 0000000005 End BD address 00000000005 End BD address 000000005 End BD address 00000005 End BD address 000000005 End BD address 00000005 End BD address 00000005 End BD address 00000005 End BD address 00000005 End BD address 000000005 End BD address 00000005 End BD address 00000	DLU09G1A00001.bin 4LU09G1A00009.bin 5LU09G1A00003.bin hished with no err DUT BD Address 13 000000000.01 14 00000000.02 15 00000000.03 16 0000000.04 GU COM Port	Code 215 CUSTON 215 CUSTON 215 CUSTON 215 CUSTON 215 CUSTON 206 RD TEST	08-Mar-17 4:49 PM 08-Mar-17 5:18 PM 08-Mar-17 5:18 PM 08-Mar-17 5:18 PM 08-Mar-17 5:18 PM Wing screen will be s Status MADTA WRITE OK ADATA WRITE OK ADATA WRITE OK MDATA WRITE OK Status TER INIT OK Ster Temp Voltmeter	File folder BIN File BIN File BIN File BIN File	Result PASS PASS PASS PASS PASS Result	1 KB 1 KB	
9	GU 23793852 44613980 44613980 45953404 56795233 If everything fir File Edit Run Start BD address 000000000000 Next BD address 000000000000 Statistics Pass 4 Fail: 0 Contenum Contenum Contenum GU Check	DLU09G1A00001.bin 4LU09G1A00009.bin 5LU09G1A00003.bin hished with no err DUT BD Address 13 000000000.01 14 00000000.02 15 00000000.03 16 0000000.04 GU COM Port	Code 215 CUSTON 215 CUSTON 215 CUSTON 215 CUSTON 215 CUSTON 226 RD TEST BLE Test	08-Mar-17 4:49 PM 08-Mar-17 5:18 PM 08-Mar-17 5:18 PM 08-Mar-17 5:18 PM 08-Mar-17 5:18 PM Wing screen will be s Status MADTA WRITE OK ADATA WRITE OK ADATA WRITE OK MDATA WRITE OK Status TER INIT OK Ster Temp Voltmeter	File folder BIN File BIN File BIN File BIN File	Result PASS PASS PASS PASS PASS Result	1 KB 1 KB	
9	GU 23793852 44613980 45953404 56795233 If everything fir File Edit Run Start BD address 000000000000 Next BD address 0000000000000 Statistics Pass: 4 Fail: 0 Runs: 1 IC DA14681-01 (AE) COM Enum GU Check VBAT/UART	DLU09G1A00001.bin 4LU09G1A00009.bin 5LU09G1A00003.bin hished with no err DUT BD Address 13 000000000.01 14 00000000.02 15 00000000.03 16 0000000.04 GU COM Port	Code 215 CUSTON 215 CUSTON 215 CUSTON 215 CUSTON 215 CUSTON 226 RD TEST BLE Test	08-Mar-17 4:49 PM 08-Mar-17 5:18 PM 08-Mar-17 5:18 PM 08-Mar-17 5:18 PM 08-Mar-17 5:18 PM Wing screen will be s Status MADTA WRITE OK ADATA WRITE OK ADATA WRITE OK MDATA WRITE OK Status TER INIT OK Ster Temp Voltmeter	File folder BIN File BIN File BIN File BIN File	Result PASS PASS PASS PASS PASS Result	1 KB 1 KB	
9	GU 23793852 44613980 44613980 45953404 56795233 If everything fir File Edit Run Start BD address 000000000000 Next BD address 000000000000 Statistics Pass 4 Fail: 0 Contenum Contenum Contenum GU Check	DLU09G1A00001.bin 4LU09G1A00009.bin 5LU09G1A00003.bin hished with no err DUT BD Address 13 000000000.01 14 00000000.02 15 00000000.03 16 0000000.04 GU COM Port	Code 215 CUSTON 215 CUSTON 215 CUSTON 215 CUSTON 215 CUSTON 226 RD TEST BLE Test	08-Mar-17 4:49 PM 08-Mar-17 5:18 PM 08-Mar-17 5:18 PM 08-Mar-17 5:18 PM 08-Mar-17 5:18 PM Wing screen will be s Status MADTA WRITE OK ADATA WRITE OK ADATA WRITE OK MDATA WRITE OK Status TER INIT OK Ster Temp Voltmeter	File folder BIN File BIN File BIN File BIN File	Result PASS PASS PASS PASS PASS Result	1 KB 1 KB	
19	GU 23793852 44613980 45953404 56795233 If everything fin File Edit Run Start BD address 00:00:00:00:00:00 Next BD address 00:00:00:00:00:00 Statistics Pass: 4 Fai: 0 Total: 0 Runs: 1 IC DA14681-01 (AE) COM Enum GU Check VBAT/UART Barcode Scan	DLU09G1A00001.bin 4LU09G1A00009.bin 5LU09G1A00003.bin hished with no err DUT BD Address 13 000000000.01 14 00000000.02 15 00000000.03 16 0000000.04 GU COM Port	Code 215 CUSTON 215 CUSTON 215 CUSTON 215 CUSTON 215 CUSTON 215 CUSTON 26 RD TEST	08-Mar-17 4:49 PM 08-Mar-17 5:18 PM 08-Mar-17 5:18 PM 08-Mar-17 5:18 PM 08-Mar-17 5:18 PM Wing screen will be s Status MADTA WRITE OK ADATA WRITE OK ADATA WRITE OK MDATA WRITE OK Status TER INIT OK Ster Temp Voltmeter	File folder BIN File BIN File BIN File BIN File	Result PASS PASS PASS PASS PASS Result	1 KB 1 KB	
9	GU 23793852 44613980 45953404 56795235 If everything fire File Edit Run Start BD address 0000.00.000.00 End BD address 0000.00.000.00 Statistics Pass: 4 Fait: 0 Content Conte	DLU09G1A00001.bin 4LU09G1A00009.bin 5LU09G1A00003.bin hished with no err 13 00000000001 14 00000000000 15 00000000000 16 00000000000 GU COM Port COM4	Code 215 CUSTON 215 CUSTON 215 CUSTON 215 CUSTON 215 CUSTON 215 CUSTON 26 RD TEST	08-Mar-17 4:49 PM 08-Mar-17 5:18 PM 08-Mar-17 5:18 PM 08-Mar-17 5:18 PM 08-Mar-17 5:18 PM 08-Mar-17 5:18 PM Wring screen will be s Status MDATA WRITE OK ADATA WRITE OK ADATA WRITE OK ADATA WRITE OK ADATA WRITE OK Status TER INIT OK Status	File folder BIN File BIN File BIN File BIN File	Result PASS PASS PASS PASS PASS Result	1 KB 1 KB	

7.3.3 Running the GUI PLT and Executing Tests

The GUI PLT starts the test procedure when users press the *START* button. Before initiating the test procedure the GUI PLT will assign BD addresses to the active DUTs and check for any wrong configuration parameters. Immediately thereafter the testing procedure will begin. The GUI PLT will update the status of the procedure for each DUT and the Golden Unit (Figure 104). The *START* button is replaced by a progress bar indicating the progress of the tests.

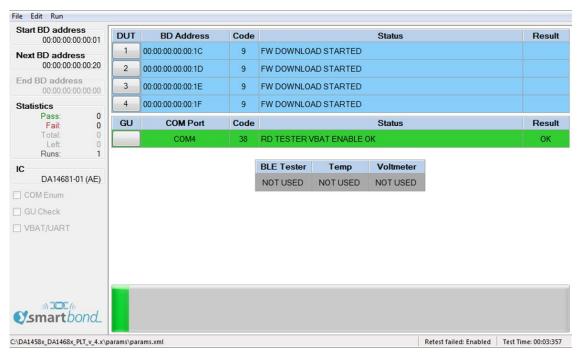


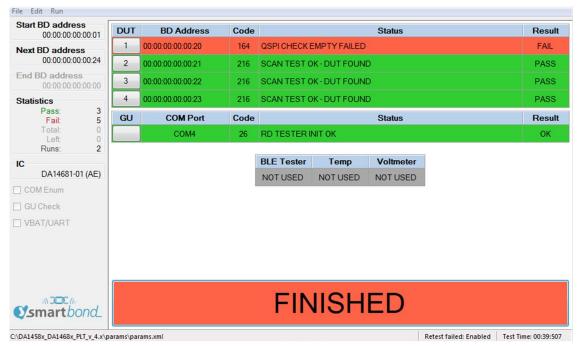
Figure 104: GUI PLT during Testing (1 of 2)

If an error in a DUT is found (Figure 105), the GUI PLT will show the status code, a brief description of the error and the color of the DUT's status line will turn red. At all times the DUT number button can be pressed to access the DUT Log File to get more details about the parameters used, calculated values and the reason of failure in the case of an error.

Start BD address 00:00:00:00:00:01	DUT	BD Address	Code			Status		Result
Next BD address	1	00:00:00:00:00:1C	164	QSPI CHECK	EMPTY FAILED			FAIL
00:00:00:00:00:20	2	00:00:00:00:00:1D	166	QSPI IMAGE V	VRITE STARTE	D		
End BD address 00:00:00:00:00:00	3	00:00:00:00:00:1E	166	QSPI IMAGE V	VRITE STARTE	D		
Statistics	4	00:00:00:00:00:1F	166	QSPI IMAGE V	VRITE STARTE	D		
Pass: 0 Fail: 0	GU	COM Port	Code			Status		Result
Total: 0 Left: 0		COM4	38	RD TESTER V	/BAT ENABLE (ок		ОК
Runs: 1							3	
				BLE Tester	Temp	Voltmeter		
DA14681-01 (AE)				NOT USED	NOT USED	NOT USED		
COM Enum								
GU Check								
VBAT/UART								
smartbond_								

Figure 105: GUI PLT During Testing (2 of 2)

After the testing procedure is completed (Figure 106), the progress bar shows *FINISHED* and its color will be red if any DUT has failed, otherwise it will be green. If there is an error and the *Retest failed DUTs* and *Ask to retry* options are enabled, a message will appear asking if the user would like to retest the failed DUTs, as shown in Figure 107. When the GUI PLT performs a retest run, all options (including the BD addresses) remain the same and only the tests that failed are retested. At this time the CSV File and all the DUT Log Files will be updated.







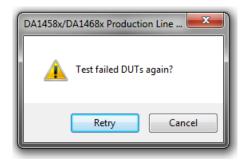


Figure 107: GUI PLT Retry Failed DUTs Message

If the DUT fails again, after the retest has finished the GUI PLT will remain in the *FINISHED* screen (Figure 106) with the *FINISHED* button shown in red.

7.3.4 Debug Console

Section 7.2.12.6 shows the debug settings for all PLT applications including the GUI PLT. If at least one debug session is enabled with the output set to *Console*, the GUI PLT will open a new console window showing the desired debug information.

Figure 108 shows an example of the *Debug Console*. Depending on the type of the message a different color is used: *DEBUG* messages are light blue, *INFO* messages are white and *ERROR* messages are red.

6 DA1458x/DA1	c Production Line Tool Debug
12:17:55.385	NF0] [GUI] [cfg_GUI::cfg_GUI_MainForm::cfg_gui_get_value 118] >>>
12:17:55.386	NFO] [GUI] [cfg GUI::cfg GUI MainForm::cfg gui string to char ¦ 1689] >>>
12:17:55.386	NFO] [GUI] [cfg GUI::cfg GUI MainForm::cfg gui char to string 1719] >>>
12:17:55.386	NF0] [GUI] [cfg_GUI::cfg_GUI_MainForm::cfg_gui_get_value + 118] >>>
12:17:55.386	NFO] [GUI] [cfg_GUI::cfg_GUI_MainForm::cfg_qui_string_to_char 1689] >>>
12:17:55.387	NF0] [GUI] [cfg_GUI::cfg_GUI_MainForm::cfg_gui_char_to_string 1719] >>>
12:17:55.388	NF0] [GUI] [cfg_GUI::cfg_GUI_MainForm::CustomTestCmdIDEn68xCheckbox_CheckedChanged 1168] >>>
12:17:55.388	NF0] [GUI] [cfg_GUI::cfg_GUI_MainForm::cfg_gui_button_change 1117] >>>
12:17:55.392	NF0] [GUI] [cfg_GUI::cfg_GUI_MainForm::cfg_gui_get_value 118] >>>
12:17:55.392	NF0] [GUI] [cfg_GUI::cfg_GUI_MainForm::cfg_gui_string_to_char { 1689] >>>
12:17:55.392	NF0] [GUI] [cfg_GUI::cfg_GUI_MainForm::cfg_gui_char_to_string_! 1719] >>>
12:17:55.393	NF0] [GUI] [cfg_GUI::cfg_GUI_MainForm::cfg_gui_get_value 118] >>>
12:17:55.393	NF0] [GUI] [cfy_GUI::cfy_GUI_MainForm::cfy_gui_string_to_char 1689] >>>
12:17:55.435	EBUG] [GUI] [cfg_GUI::cfg_GUI_MainForm::cfg_gui_get_value 127] >>> ERROR: Failed to get value [custom_test_data] from file.
12:17:55.435	NF0] [GUI] [cfg_GUI::cfg_GUI_MainForm::cfg_gui_char_to_string 1719] >>>
	RRÓRI IGUII Icig_GUI::cig_GUI_MainForm::cig_guI_draw_test_settings_da1468x 42211 >>> ERROR: Value of Icustom_test_data1131 is n
Valia.	NF0] [GU1] [cfg_GU1::cfg_GU1_MainForm::cfg_gui_char_to_string 1719] >>>
12-17-33-430	NROJ [GUI] [cfg_GUI::cfg_GUI_MainForm::cfg_gui_ent_co_string 1/17] ///
19-19-55.430	MROJ [cub] [cig_dul]::cig_dul]MainForm::cig_dul_string_to_char 1689] >>>
19-19-55 496	NFO1 [doi] [cfg_doi:.cfg_doi_nahrormcfg_gdi_string_do_latring_to_string 1719] >>>
12:17:55 436	NFOI [GUI] [cfg_GUI::cfg_GUI_MainForm::cfg_gui_get_info 152] >>>
12:17:55 436	NC01 [GU1] [cfg_GU1::cfg_GU1_MainForm::cfg_gu1_string_to_char 1689] >>>
12:17:55.437	NPOI [GUI] [cfg_GUI::cfg_GUI_MainForm::cfg_gui_char_to_string 1719] >>>
12:17:55.437	NPO1 [Cull] [cfg_Gull::cfg_Gull MainForm::cfg_gulget_info 152] >>>
12:17:55.437	NF0] [GUI] [cfg_GUI::cfg_GUI_MainForm::cfg_gui_string_to_char + 1689] >>>
12:17:55.437	NFO] [GUI] [cfg_GUI::cfg_GUI_MainForm::cfg_gui_char_to_string 1719] >>>
12:17:55.437	NFO] [GUI] [cfg_GUI::cfg_GUI_MainForm::cfg_gui_get_info 152] >>>
12:17:55.437	NF01 [GUI] [cfg_GUI::cfg_GUI_MainForm::cfg_gui_string_to_char 1689] >>>

Figure 108: Debug Console

User Manual



7.3.5 DUT Log File

File Edit Format View Help Software: DA1458x/DA1468x Production Line PutD DL Version: V_3.172.2.22 PpLL Version: V_3.172.2.22 Production test BLE firmware version: 8.0.15.0 Production test App firmware version: 00.03 Date: 2016-11-28 Start Time: 19:02:48.942 End Time: 19:02:48.557 Station ID: Test_station_1 Device ID: 1 COM port: 25 BD address: 00:00:00:00:00:00:00:024 !=time> _caction> !=y02:49.811 DUT_UDLL_FW_DOWNLOAD_START !=y03:00.857 DUT_UDLL_FW_DOWNLOAD_START !=y03:00.857 DUL_firmware download initialized. Fir !=y03:01.366 DUT_UDLL_FW_DOWNLOAD_OK !=ya3:01.368 DUT_PDL_COM_PORT_START !=y03:01.368 DUT_PDL_FW_VERSION_GET_START !=y03:01.461 DUT_PDL_COM_PORT_START !=y03:01.462 DUT_PDL_FW_VERSION_GET_START !=y03:01.462 DUT_PDL_FW_VERSION_GET_S
software version: v_3.172.2.22 PLTD DLL version: v_3.172.2.22 PDLU Version: v_3.172.2.22 uDLL version: v_3.172.2.22 uDL version: v.3.172.2.22 uDL version: v.3.172.2.22 uDL version: v.3.172.2.22 uDL version: v.3.172.2.22 version: version: v.3.172.2.20 version:
<time><action><pass fail=""> <info>###################################</info></pass></action></time>
[19:03:03.301DUT_PDLL_XTAL_TRIM_READ_STARTSTARTEDXTAL trim value read started.[19:03:03.308DUT_PDLL_XTAL_TRIM_READ_OKPASSXTAL trim value read oK. value is=[116:[19:03:03.413DUT_PDLL_PKT_RX_STATS_START_INITSTARTEDRF RX packet test with statistics star1[19:03:03.460DUT_PDLL_PKT_RX_STATS_START_OKPASSRF RX packet test with statistics star1[19:03:03.480DUT_PDLL_PKT_RX_STATS_STARTE_OKPASSRF RX packet test with statistics star1[19:03:03.873DUT_PDLL_PKT_RX_STATS_STOP_INITSTARTEDRF RX packet test with statistics stop[19:03:03.908DUT_PDLL_PKT_RX_STATS_STOP_ED_OKPASSRF RX packet test with statistics stop1[19:03:03.915DUT_PDLL_PKT_RX_TATS_STOPPED_OKPASSGolden Unit RF RX packet test with statistics stop1[19:03:03.971DUT_PDLL_PKT_RX_STATS_START_INITSTARTEDRF RX packet test with statistics star1[19:03:03.971DUT_PDLL_PKT_RX_STATS_STARTSTARTEDRF RX packet test with statistics star1[19:03:03.9399DUT_PDLL_PKT_RX_STATS_STARTED_OKPASSRF RX packet test with statistics star1[19:03:03.971DUT_PDL_PKT_RX_STATS_START_DOKPASSRF RX packet test with statistics star1[19:03:03.93.999DUT_PDL_PKT_RX_STATS_STARTED_OKPASSRF RX packet test with statistics star1[19:03:03.903.903DUT_PDL_PKT_RX_STATS_STARTED_OKPASSRF RX packet test with statistics star1[19:03:03.904.336DUT_PDL_PKT_RX_STATS_STARTED_OKPASSRF RX packet test with statistics star1[19:03:03.903.909DUT_P
< H

Figure 109: DUT Log File

Figure 109 shows a Log file generated for DUT1 during testing.

In the first few lines of the log a header is created giving vital information about the PLT hardware and the software. It includes the firmware and software version, the station name and test dates and times. It also holds information about the DUT, such as the connector number in the PLT hardware, the BD address assigned to it and the Windows COM port. For the DUTs that have failed, the log file is renamed with the word "_FAILED" at the end for easier retrieval.

The Log file is created at the beginning of each test, containing only the header and all information available at the time of creation. As the device testing progresses the status of each test is written at the end of the log file, including information about the DUT and a timestamp of the event. After the tests finish the header is updated with the end time of the test and the firmware versions, which were retrieved during testing.

7.3.6 CSV File

Start time	End time	DUT	BD addres Overall sta	COM port FW downl	FW path 2	FW versio	FW versio	QSPI eras	QSPI chec	QSPI burn	QSPI imag	g FW d
17:08:53	17:10:43	1	00:00:00:0 FAIL	25 PASS	C:\Users\	PASS	00.03	PASS	FAIL			
17:08:53	17:10:43	2	00:00:00:0 FAIL	26 PASS	C:\Users\	PASS	00.03	PASS	FAIL			
17:10:48	17:13:24	1	00:00:00:0 FAIL	25 PASS	C:\Users\	PASS	00.03	PASS	FAIL			
17:10:48	17:13:24	2	00:00:00:0 FAIL	26 PASS	C:\Users\	PASS	00.03	PASS	PASS	FAIL	binaries\\	pxp_
17:13:30	17:16:39	1	00:00:00:0 FAIL	25 PASS	C:\Users\	PASS	00.03	PASS	FAIL			
17:13:30	17:16:39	2	00:00:00:0 FAIL	26 PASS	C:\Users\	PASS	00.03	PASS	PASS	FAIL	binaries\\	pxp_
17:17:00	17:17:10	1	00:00:00:0 FAIL	25 FAIL	C:\Users\	pdimopou	Desktop\I	DA1458x_C	A1468x_Pl	.T_v_4.0\sc	ource\proc	ductio
17:17:00	17:17:10	2	00:00:00:0 FAIL	26 PASS	C:\Users\	FAIL						
17:17:55	17:18:13	1	00:00:00:0 FAIL	25 FAIL	C:\Users\	pdimopou	Desktop\I	DA1458x_C	A1468x_Pl	.T_v_4.0\sc	ource\proc	ductio
17:17:55	17:18:13	2	00:00:00:0 FAIL	26 PASS	C:\Users\	FAIL						
17:19:56	17:20:22	1	00:00:00:0 FAIL	25 PASS	C:\Users\	PASS	00.03	PASS	FAIL			
17:19:56	17:20:22	2	00:00:00:0 PASS	26 PASS	C:\Users\	PASS	00.03	PASS	PASS	PASS	binaries\	pxp_
17:21:39	17:22:16	1	00:00:00:0 FAIL	25 PASS	C:\Users\	PASS	00.03	PASS	FAIL			
17:21:39	17:22:16	2	00:00:00:0 FAIL	26 PASS	C:\Users\	PASS	00.03	PASS	FAIL			
17:22:18	17:25:41	1	00:00:00:0 FAIL	25 PASS	C:\Users\	PASS	00.03	PASS	FAIL			
17:22:18	17:25:41	2	00:00:00:0 FAIL	26 PASS	C:\Users\	PASS	00.03	PASS	FAIL			
17:25:47	17:26:08	1	00:00:00:0 FAIL	25 PASS	C:\Users\	PASS	00.03	PASS	FAIL			
17:25:47	17:26:08	2	00:00:00:0 PASS	26 PASS	C:\Users\	PASS	00.03	PASS	PASS	PASS	binaries\\	pxp_
18:57:45	18:58:48	1	00:00:00:0 FAIL	25 PASS	C:\Users\	PASS	00.03	PASS	FAIL			PASS
18:57:45	18:58:48	2	00:00:00:0 PASS	26 PASS	C:\Users\	PASS	00.03	PASS	PASS	PASS	binaries\\	PAS
18:57:45	18:58:48	3	00:00:00:0 PASS	27 PASS	C:\Users\	PASS	00.03	PASS	PASS	PASS	binaries\\	PAS
18:57:45	18:58:48	4	00:00:00:0 PASS	28 PASS	C:\Users\	PASS	00.03	PASS	PASS	PASS	binaries\\	PASS
18:59:40	19:00:20	1	00:00:00:0 FAIL	25 PASS	C:\Users\	PASS	00.03	PASS	FAIL			PAS
18:59:40	19:00:20	2	00:00:00:0 PASS	26 PASS	C:\Users\	PASS	00.03	PASS	PASS	PASS	binaries\\	PASS

Figure 110: CSV File

Figure 110 shows an example of a generated CSV file. As with the DUT Log File, the PLT software and hardware information are shown along with valuable DUT information. The CSV file keeps information about all the production tests of a single day. A new CSV file will be created every day.

7.4 CLI PLT Application

The CLI PLT (DA1458x_DA1468x_CLI_PLT.exe) is a Command Line Interface application with similar functionality and features as the GUI PLT. It performs the device testing and memory programming. At the same time it allows users to monitor the test procedure in detail. It supports the same configuration file created from the CFG PLT and can run the same tests as the GUI PLT.

7.4.1 CLI Introduction

Figure 111 shows the initial screen of the CLI PLT software. The CLI PLT can be executed from a command line prompt, passing arguments externally and initiating the tests immediately. This is useful for scripting/batch files as shown in section 7.4.4.

Parameters are automatically loaded from the params/params.xml file when the CLI PLT starts. If there is a parameter error, a warning will be shown. It is recommended to run the 'x' command or start the CFG PLT before running the tests and check the configuration parameters. If a change is made to the params.xml configuration file while CLI is open, the file should be reloaded using the 'i' command.

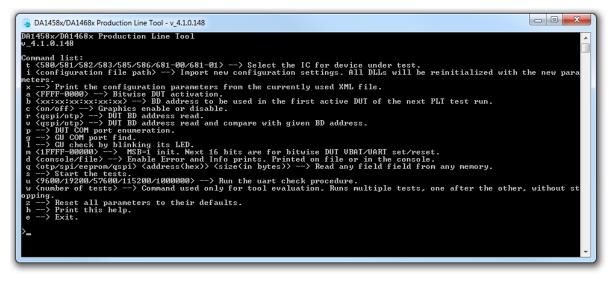


Figure 111: CLI Software Start Screen

7.4.2 CLI Commands

Table 95 lists all available CLI commands. A list with brief description of these commands can be printed using the 'h' command.

Command	Arguments	Description
t	 580 581 582 583 585 586 680 681 	Selects the type of IC that the DUT uses. This option will change the DUT IC setting in the configuration file and reload all the settings if there is a switch from any DA1458x IC to a DA1468x IC and vice versa. Example: "t 580".
i	Path to XML configuration file.	Initializes the PLT with the parameters found in the params.xml file. Example: "i params\params.xml".

Table 95: CLI Commands

User Manual	Revision 4.3	03-Feb-2022



Command	Arguments	Description
х	none	Print the configuration parameters from the currently used XML file.
a	Hex values from "FFFF" to "0000".	 Bitwise DUT activation. Sets the active DUTs to be tested. Examples: "a 1": Only DUT 1 will be activated and tested. "a 9": DUTs 1 and DUT 4 will be activated and tested.
b	xx:xx:xx:xx:xx:xx	Sets the start BD address of the first active DUT. Example: "b FE:00:11:22:33:44"
С	on/off	Enables or disables the graphics debug output of the CLI. Useful in the read BD address command <i>r</i> , in order to see only the DUT BD address returned and not the entire process. Example: "c on"
r	qspiotp	Reads the BD addresses of the active DUTs. It is better to disable the graphics beforehand by running the command "c off". Example: "r qspi"
V	qspiotp	Verify the BD addresses of the active DUTs. It is better to disable the graphics beforehand by running the command "c off".
р	none	Execute the automatic DUT Window COM port enumeration.
g	none	Execute the automatic GU Window COM port enumeration.
1	none	Run the Golden Unit sanity check. The Golden Unit will start blinking its red LED.
m	First character: "1" or "0". Then hex value from "FFFF" to "0000".	MSB character should be '1' the first time this command is executed. Consecutive 'm' commands should have the MSB character set to '0'. The next 16 bits are used for bitwise DUT VBAT/UART enable/disable. Example: "m 1FFFF"
d	consolefile	Use this option to enable error and info prints. Choose file output or console output. Only the <i>file</i> option is currently supported. Example: "d file"
đ	First argument • otp • spi • eeprom • qspi Second argument • The address offset in hexadecimal Third argument • The size in bytes to read	This option can read from any memory, for any address offset up to 256 bytes of data.
S	none	Starts the tests.
u	 9600 19200 57600 115200 1000000 	This command performs a UART check connection for all the active DUTs for a specific Baud rate.
W	Number of tests to run.	This command is used only for PLT evaluation. It starts multiple tests. These are executed one after the other without user intervention.



DA1458x/DA1468x Production Line Tool

Command	Arguments	Description					
Z	none	Resets all the XML parameters to their defaults.					
h	none	Help print out. Prints the list of the CLI commands that are available.					
е	none	Exits the application.					

7.4.3 Running the CLI and Executing Tests

There are a number of options to be called in order to make sure that the CLI PLT is set up correctly. Each of following commands is explained in Table 95.

Using the help command ('h') the entire CLI command list will be shown.
 Example: >h

Set Console Options

- To redirect the debugging messages to the file use command 'd'. This option is going to replace the UI debug values in the configuration file.
 Example: >d file
- To show or hide any prints in the Console window use command 'c' with on/off argument. Example: >c on

Check, Reset, Reload and Change Settings

 Because the configuration file is automatically loaded, use the 'x' command (Figure 112) to see the loaded settings. Errors will be shown in red.
 Example: >x

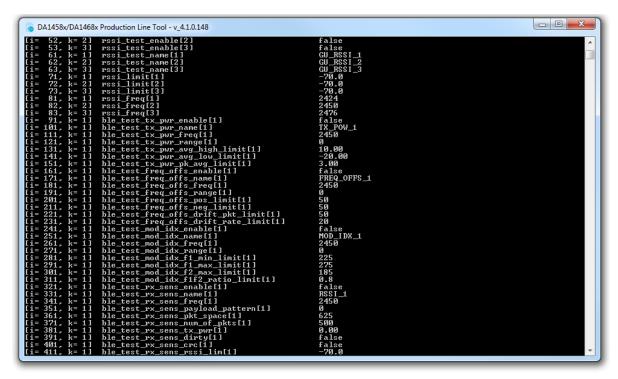


Figure 112: CLI PLT Print Settings (x Command)

- To Reset the XML parameters in the configuration file to their defaults use the 'z' command. Example: >z
- To reload the configuration file or to load another one use the 'i' command.

liser	Manual
0.001	manaa

Example: >i params/params.xml

• To change only the selected device IC use the 't xxx' command, where 'xxx' is the desired IC selection. If a change from DA1458x to DA1468x (and vice versa) is made, all the settings will be reloaded.

Example: >t 580

• To change the active DUTs use the 'a' command. As an argument a 16-bit hexadecimal value is used, which is the bitwise representation of the active DUTs with DUT 1 being the LSB. This command will replace the dut_num_x values in the configuration file.

The following example will enable only DUT1, DUT2, DUT15 and DUT 16. Example: $a \ C003$

 To change the BD address that will be used in the next run use the 'b' command. This option is going to replace the BD address and Statistics values in the configuration file. Example: >b 00:00:00:00:00:01

Hardware Specific Tests

- To automatically find the Windows COM Port assigned to the Golden Unit use the 'g' command. This command will replace the gu_com_port value in the configuration file.
 Example: >q
- To verify that the Golden Unit COM port is found correctly and to check if the Golden Unit is ready run the '1' command.

Example: >1

To automatically find the Windows COM Port assigned for each DUT use the 'p' command. This command will replace the com_port_dut_x values in the configuration file.

Example: >p

DŪT	BD ADDRESS	CODE	STATUS	RESULT
2	00:00:55:00:00:01	Ø	NOT ACTIVE	
3	00:00:55:00:00:02	2	COM PORT IDENTIFY STARTED	
4	00:00:55:00:00:03	3	COM PORT IDENTIFY OK	PASS
GU	COM4	34	RD TESTER COM LOOPBACK OK	OK

Figure 113: CLI PLT DUT COM Port Enumeration ('p' Command)

• To run a UART error check use the 'u' command followed with a specific Baud rate. Example: >u 1000000

PLT Production Tests

• To check if there is a BD address written in the active DUTs use the 'r' command. To read the BD addresses and verify that they are the same as the ones currently assigned use the 'v' command. Both commands use 'qspi' or 'otp' as argument to define the memory header.

The following example will read the BD address from the QSPI memory header and compare it with the one currently assigned to the DUTs.

Example: >v qspi



DA1458x/DA1468x Production Line Tool

	RD TESTER INIT OK	OK
03 00:00:55:00:00:02	GIVEN BD ADDRESS 00:00:55:00:00:01 00:00:55:00:00:02 00:00:55:00:00:03	STATUS Match Match Match Match



• Use the 's' command to begin testing with the current configuration. Figure 115 shows the CLI during the testing. After all the tests have finished, the result remains on the screen as shown in Figure 116.

DUT 2 3 4 GU	BD ADDRESS 00:00:55:00:00:01 00:00:01 00:00:55:00:00:02 00:00:03 COM4 BLE TESTER TEMP NOT USED NOT USED	CODE STATUS 9 FW DOWNLOAD STARTED 9 FW DOWNLOAD STARTED 9 FW DOWNLOAD STARTED 38 RD TESTER VBAT ENABLE OK VOLT NOT USED	RESULT OK						
	Figure 115: CLI PLT During Testing								
DUT	BD ADDRESS	CODE STATUS	RESULT						

DUT BD ADDRESS	CODE STATUS	RESULT
2 00:00:55:00:00:01	216 SCAN TEST OK – DUT FOUND	PASS
3 00:00:55:00:00:02	216 SCAN TEST OK – DUT FOUND	PASS
4 00:00:55:00:00:03	216 SCAN TEST OK – DUT FOUND	PASS
GU COM4	26 RD TESTER INIT OK	OK
BLE TESTER TEMP	VOLT	
NOT USED NOT USED	NOT USED	
DUT QSPI BD ADDRESS	GIVEN BD ADDRESS	STATUS
02 00:00:55:00:00:01	00:00:55:00:00:01	MATCH
03 00:00:55:00:00:02	00:00:55:00:02	MATCH
04 00:00:55:00:00:03	00:00:55:00:00:03	MATCH
return status = 0xFFF1		

Figure 116: CLI PLT Testing Finished

Use the 'q' command to read from any memory up to 156 bytes of data. The following example will read the BD address (6 bytes from offset 0x47FD4) of a DA14580 DUT.
 Example: >q otp 47FD4 6

Other Test Commands

• Use the 'm' command to power on and access the DUTs to perform further testing. This will open the VBAT and the COM ports from the PLT hardware to the DUTs. As an argument a '0' or '1' character is used to reset the PLT hardware. This is followed by a 16-bit hexadecimal number, which is the bitwise representation of the DUTs to use, with DUT 1 being the LSB.

In the following example the PLT hardware will be reset and DUTs 1, 2, 15 and 16 will be used. Example: >m 1C003

User Manual



7.4.4 Using CLI Commands as Arguments

It is possible to start the CLI program with the commands described in section 7.4.3 as arguments. This is useful for scripting/batch files.

C:\executables>DA1458x_DA1468x_CLI_PLT.exe -a 0001 -b 00:00:55:00:00:01 -s -b 00:00:55:00:00:01 -v qspi

Figure 117: CLI with Commands as Arguments

The example shown in Figure 117 will perform the following commands:

- 1. '-a 0001': Set the DUT1 as the only active DUT.
- 2. '-b 00:00:55:00:00:01'. Assign as the first BD address to be assigned the 00:00:55:00:00:01. This BD address will be used in DUT1 as it is the only active DUT.
- 3. '-s': Perform the tests. BD address write in QSPI header should be enabled for the following test to pass.
- 4. '-b 00:00:55:00:01: After the tests finish the BD address will be incremented, this command will reset it to 00:00:55:00:00:01.
- 5. '-v qspi': Read only the BD address written in the QSPI header and compare it with the one assigned to the DUT1. These are the same.

DA1458x/DA1468x Production Line Tool

Example Usage 8

In this section a simple example of the PLT will be described using two DA14580 devices. The example test procedure is explained step-by-step in Table 96.

The tests to run in this example are the XTAL trim, RF RSSI test, SPI erase, SPI check empty and SPI image write.

Two DUTs will be used at PLT DUT connector positions DUT1 and DUT2.

Table 96: DA14580 PLT Example Usage

Step	Description							
Hardw	are Connections							
1	Connect both DUTs to the PLT hardware as shown in DA1458x DK PRO Motherboard Connection. Four cables are needed. In order to use the SPI Flash memory a custom triple-jumper must be used.							
CFG G	FG GUI Settings							
2	Open CFG PLT and make the following selections.							
3	Hardware Setup							
	Station Identification	Device IC	Select DA14580 and then Save.					
	Station ID Test_station	Golden Unit	Press the Auto Button and					
	Device IC	COM Port	then Save.					
	Device IC DA14580	Active DUTs	Enable only DUT1 and DUT2 and Save.					
		DUT COM Ports	Press Enum button and then Save.					
	DUT COM Ports							
	DUT 1 25 DUT 5 0 DUT 9 0 DUT 13 0 DUT 2 26 DUT 6 0 DUT 10 0 DUT 14 0 DUT 3 0 DUT 7 0 DUT 11 0 DUT 15 0 DUT 4 0 DUT 8 0 DUT 12 0 DUT 16 0							
	Enum Reset							
	▲ Golden Unit COM Port Set the GU COM port Auto Refresh COM4							
4	VBAT/Reset Mode							
	▲ VBAT/Reset Mode VBAT low duration 2000 ms Reset duration 50 ms	VBAT low duration	Set a time for the POR that is sufficient enough for the DUTs to discharge their capacitors during the POR.					
	VBAT/Reset Mode VBAT Only	VBAT/Reset Mode	Since the DUTs will be powered from the PLT hardware and the Reset signal will not be used, use the VBAT only option.					
5	General							
	▲ Statistics	Statistics	Press the Reset Button and then Save.					

User Manual

Revision 4.3



Step	Description		
		Test Options	Enable all options and then press Save. Production tests are required to be enabled for the XTAL Trim and the RF tests to run. Memory programming is required for the QSPI erase and check empty functions. Disable the rest of the options.
6	UART		
	▲ UART Boot Pins Setup	UART Boot Pin Setup	TX: P0_4, RX: P0_5
	TX-RX pins TX: P0_4, RX: P0_5 ▼ ▲ UART Baud Rate Baud Rate 1000000 ▼ ▲ UART Programming GPIOs Setup Enable Port TX 0 ▼ Pin TX Port RX 0 ▼ Pin RX	UART Baud Rate	100000
7	Test Settings		
	▲ XTAL Trim ✓ Enable GPIO input pulse pin P0_5 ▼	XTAL Trim	Check <i>Enable</i> in XTAL Trim. Select the same pin as the <i>UART Rx</i> , <i>P0_5</i> . <i>Burn to OTP</i> is disabled
	■ Burn to OTP ▲ RF Tests Golden Unit ● BLE Tester Path losses per DUT RF RX test settings using the Golden Unit. Test 1 ☑ Enable Settings Frequency 2424 ▼ MHz Limits RSSI limit >= -70.0 dBm	RF Tests - Golden Unit	 Only one test is enabled for this example. In Golden Unit: Check <i>Enable</i> Select 2424 MHz as <i>frequency</i> Set the <i>RSSI limit</i> to -70 dBm



Step	Descrip	tion								
8	Memory	Functions								
		SPI write 1 ✓ Write enable Test name Write image in chunks of 3960 bytes ✓ Verify image ✓ Bootable image Start address 0x 00000000 Different image per DUT Image path binaries\prox_reporter_580.bin				Write 1	test	Check Write enab Check Verify imag Check Bootable ir Make sure prox_reporter_5 selected.	ge mage	
9	OTP Hea	ader								
	General							e all optio		
	BD address Disable all options									
GUI PL	-1									
10	Open GUI PLT.									
	File Edit	Run								
	Start BD address 00:00:00:00:00:01 DUT BD Address Code						Status		Result	
	Next B	D address	1	00:00:00:00:00:01						
		00:00:00:00:00:00) address	2	00:00:00:00:00:02						
		0:00:00:00:00:00	GU	COM Port	Code			Status		Result
	Statisti	cs Pass: 0		COM4						
	Fail: 0 Total: 0					BLE Tester	Temp	Voltmeter	r	
		Left: 0 Runs: 0								
	IC									
	СОМ	DA14580								
		UART								
						61	ΓAR	т		
		artbond				3	AR	1		
	C:\Release\params\params.xml Retest failed: Enabled Test Time: 00:00:000								me: 00:00:000	



p D	escrip	tion										
Pi	Press Space Bar to begin testing											
Tł	The following picture shows the UART channels (in red) for both DUTs for the entire PLT run. The green											
m	marks are the timings between each of the active tests.											
+1	s +	s <mark>⊤1</mark> +3js	+4 s +	5ٍs +6ٍs ⊤	2⊤37⁵	+§ s	+9 s	10s T4 ₊		s T2 +2s T6,7+3sT8	+4 s T9 +5 s T10+6 s	
D	UT1 TX											
D												
D												
D	UT2 RX											
D	UT1 w	ith the tim	ing marks		ogic ana	alyzer	capti			he test steps from arks are describ		
	time>	≺acti						<pass fa<="" td=""><td></td><td></td><td></td></pass>				
##	7:51:11	321 DUT U	DLL FW DOWNL	OAD INIT			ти Ти	STARTE	D [U]	DLL firmware downloa	d initialized. Firmwa	
			DLL_FW_DOWNL					STARIE	D 101	DEF IILUMALE GOMUIOS	d Started OK. Firmwa	
			DLL_FW_DOWNL DLL FW DOWNL					PASS PASS			ded OK. Firmware is=	
			DLL_FW_DOWNL		•••••		•••••			evice pdll COM port	<pre>ded OK. Firmware is= open initialized.</pre>	
			DLL COM PORT				T2	STARTE STARTE	D De	evice pdll COM port		
			DLL_COM_PORT					PASS		evice pdll COM port		
				ON_GET_START				STARTE			version get started.	
				ON GET OK				PASS	De	evice pdll Firmware	version get OK. PDLL	
			DLL_XTAL_TRI				T3	STARTE	D X	TAL trim operation i TAL trim operation s	nitialized.	
			DLL_XTAL_TRI				10					
			DLL_XTAL_TRI DLL_UART_RES					PASS STARTE		IAL trim operation e ART resync process i		
			DLL UART RES					STARTE		ART resync process s		
			DLL_UART_RES					PASS		ART resync process O		
			dll_xtal_tri					STARTE		TAL trim value read		
				M_READ_START				STARTE		TAL trim value read		
			DLL XTAL TRI					PASS	X		OK. Value is=[1428].	
			DLL_PKI_RX_S DLL_PKT_RX_S	TATS_START_I	NII		Τ4	STARTE STARTE	ם ואו ועו ח	F RX packet test wit F RX packet test wit	h statistics start in h statistics start	
				TATS STARTED	OK					-	h statistics started	
				TATS_STOP_IN				STARTE			h statistics stop in	
11	7:51:18	712 DUT_P	DLL_PKT_RX_S	TATS_STOP_ST	ART			STARTE		F RX packet test wit		
11	7:51:18	729 DUT_P	DLL_PKT_RX_S	TATS_STOPPED	_ok			PASS		-	h statistics stopped	
11	7.51:18	739 DUT P	DLL GU RF RX DLL FW DOWNL	TEST PASSED				PASS	IG D IT		ket test PASSED. Fre	
			DLL_FW_DOWNL DLL_FW_DOWNL				Т5	STARTE			d initialized. Firmw d started OK. Firmwa	
11	7:51:22	056 DUT U	DLL_FW_DOWNL	OAD_OK				PASS			ded OK. Firmware is=	
11	7:51:22	065 DUT_U	DLL FW DOWNL	OAD_OK OAD_OK ET_INIT				PASS	U	DLL firmware downloa	ded OK. Firmware is=	
11	7:51:22	072 DUT_U	DLL_FW_VER_G	ET_INIT			Τ6	STARTE			n get' operation ini	
11	7:51:22	092 [DUT_U	DLL_FW_VER_G	ET_STARTED				STARTE			n get' operation sta	
			DLL_FW_VER_G DLL_SPI_ERAS					PASS STARTE	וטן רפו ת	DLL 'firmware versio PI erase operation i	n get' operation end nitialized	
11	7:51:22	131 IDUT U	DLL SPI ERAS	E_INIT E_STARTED E OK			Т7	STARIE	D 151	PI erase operation a	tarted. Erase all SP	
11	7:51:22	318 DUT U	DLL SPI_ERAS	E OK								
11	7:51:22	335 DUT U	DLL_SPI_CHEC	K_EMPTY_INIT			то	STARTE	D ISI	PI check empty opera	tion initialized.	
11	7:51:22	360 DUT_U	DLL_SPI_CHEC	K_EMPTY_STAR	TED		١ð	STARTE	D ISI	PI check empty opera	tion started, all SP	
11	7:51:23	496 DUT_U	DLL SPI CHEC	K EMPTY OK				PASS	IS	PI check empty opera	nded OK. Erase all S tion initialized. tion started, all SP tion ended OK, all S	
11	/:51:25	200 1001_0	DPP_SEI_IWG	WK_INII			Т9	STARTE	U [S]	FI image write opera	tion ended OK, all S tion initialized. Im tion started. Image	
11	7:51:23	.524 [DU1_0. .663 [DU1_0	DLL_SPI_IMG_ DLL_SPI_IMG	WR_STARTED WR_OK				DIARLE	U [S]	ri image write opera PI image write opera	tion started. Image tion ended OK. Image	
	.,.J1:24		2110-21110	"""_ov			T10	FROD	121	i image write opera	sion ended or. image	
-		1 C.			=	<u></u>						
T				erified fror						e log file the test	lasted for about	
T2	2 F	LT begins	the operations the operations the operation of the operat	ation to ge	t the ve	rsion	of the	prod_t	test_	580.bin firmwar	e.	
	I	, , , , , , , , , , , , , , , , , , ,	•					· _				



Step	Desc	ription										
11 cont.	+0,7 s T0+0,2	70s 80s 40fs +0fs +0fs +0fs +0fs +0fs +0fs +0fs +										
		500 ms PULSE										
	Т3	T3 After the firmware version was acquired the XTAL Trim test begins. The 500 ms reference pulse in the DUT RX channel is shown with blue letters. This test lasted for 2.3 s including the UART resync.										
	T4	The RF RX RSSI test begins.										
	+0,7 sT6	130 s 130 s 140 s <td< th=""></td<>										
	Τ5	The firmware download (flash_programmer.bin) begins. Checking the log file the test lasted about 1.8 s. This can also be verified by looking the timing difference between T5-T4 at the first oscilloscope capture.										
	T6	PLT begins the operation to get the version of the flash_programmer.bin firmware.										
	Τ7	The SPI erase action begins. As with any SPI operation first a command to set the SPI bus pins is used and then the erase command. The blocks of data after the SPI erase and before the SPI check empty are SPI traffic on P0_5 which is the UART RX and the SPI MISO pin at the same time.										
	Т8	The SPI check empty action begins. As with any SPI operation first a command to set the SPI bus pins is used and then the check empty command. The blocks of data after the SPI check empty and before the SPI image write are SPI traffic on P0_5 which is the UART RX and the SPI MISO pin at the same time.										
	+0,1 s	15.0 s T9+0,2 s +0,3 s +0,4 s +0,5 s +0,6 s +0,7 s +0,8 s +0.9 s +0,1 s +0,2 s +0,3 s +0,4 s +0,5 s +0,6 s +0,7 s +0,81										
		SPI IMAGE WRITE SPI IMAGE VERIFY										



DA1458x/DA1468x Production Line Tool

Step	Descr	iption											
11 cont.	Т9	The SPI image write operation begins. First the image will be written, as shown in the picture above, and then the contents are read back for verification. The blocks of data after the SPI image write and before the SPI image verification are SPI traffic on P0_5 which is the UART R and the SPI MISO pin at the same time.											
	T10	The PLT run has finished.											
		Start BD address 00:00:55:00:00:01	DUT BD Address 1 00:00:55:00:00:01	Code	SPI IMAGE WRITE	ЕОК	Status	Result PASS					
		00:00:55:00:00:03	2 00:00:55:00:00:02 GU COM Port	151 Code	SPI IMAGE WRITE	ЕОК	Status	PASS					
		Statistics Pass: 2	COM119	26	RD TESTER INIT	ОК		ок					
		Fail: 0 Total: 0 Left 0 Runs: 1			BLE Tester NOT USED	Temp IOT USED	Voltmeter NOT USED						
		IC DA14580											
		COM Enum GU Check VBAT/UART											
		U VDAT/UART											
		Smartbond FINISHED											
		C\DA1458x_DA1468x_PLT_v_4.x\params\params.xmll Retest failed: Disabled Test Time: 00:14:965											
	After the tests have finished, the log and CSV files are fully updated. The GUI PLT test counter on the bottom right of the screen indicates that the test took approximately 15 s. This is verified from both the log files and the CSV file. Both files are shown below.												
	Soft	ware: DA1458		rodu		ine							

User Manual



Step	Description							
11	A	В	С	D	E		F T	G
cont.	1 Start time	End time	DUT B	D address	Overall s	tatus	COM port	FW download 1
	2 18:54:14	18:54:29	10	0:00:55:00:00:	01 PASS			PASS
	3 18:54:14	18:54:29	2 0	0:00:55:00:00:	02 PASS		26	PASS
	н Т	<mark>2 ı</mark>			Т3 к			<mark>4</mark> M
	FW path 1	FW versio	n get 1	FW version	1 XTAL trir	n test	XTAL trim	n GU RX test 1
	C:\Users\pd	PASS		v_5.0.4	PASS		142	6 PASS
	C:\Users\pd	PASS		v_5.0.4	PASS		134	6 PASS
	N	<mark>5</mark> 0		Р	16 Q			
	GU RX RSSI 1	FW downl	oad 2	FW path 2	FW version	get 2		
	-31.82	PASS		C:\Users\pd	PASS			
	-21.87	PASS		C:\Users\pd	PASS			
	R	1 7 s	T	3 т Т	<mark>9</mark> U		V	T10
	FW version	2 SPI era	se 1 S	PI empty 1	SPI burn 1	SPI ir	nage 1	
	v_3.0.11.554	PASS	P	ASS	PASS	bina	ries\prox_	reporter
	v_3.0.11.554	PASS	P	ASS	PASS	binar	ries\prox_	reporter



Appendix A Top-view of PLT PCB Version D

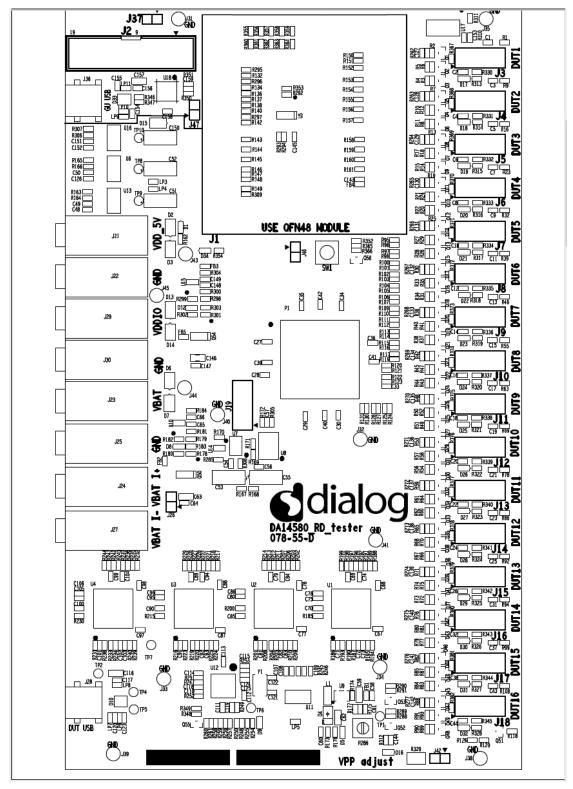


Figure 118: Top-view of PLT PCB Version D

Appendix B Electrical Schematics

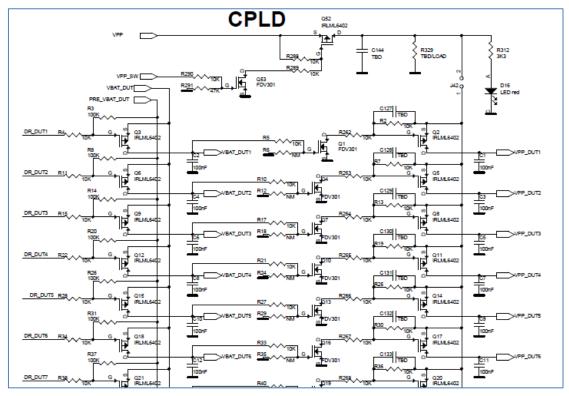
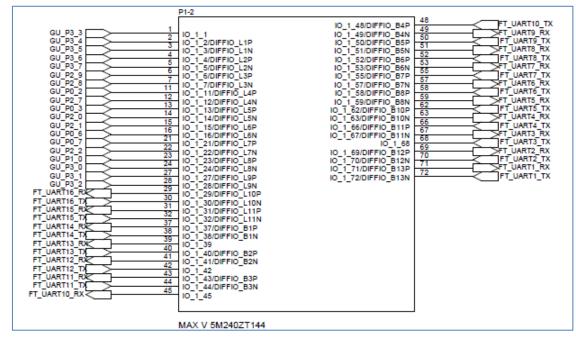


Figure 119: VBAT and VPP Control from CPLD

P0 5 DUT16 R131 73 P0 4 DUT16 R130 1K 74 DR DUT16 R130 1K 74 DR DUT16 R128 76 P0 5 DUT18 R127 100R 75 P0 5 DUT18 R127 100R 75 P0 4 DUT16 R123 77 DR DUT18 R124 100R 81 P0 5 DUT14 R123 84 P0 4 DUT13 R121 86 P0 5 DUT14 R123 84 P0 4 DUT13 R121 100R 83 P0 5 DUT14 R119 91 P0 5 DUT14 R119 91 P0 5 DUT14 R115 97 P0 4 DUT12 R114 100R 83 P0 5 DUT19 R114 100R 101 P0 5 DUT9 R114 100R 104 P0 5 DUT9 R1112 100R 104	P1-3 10 2 73/DIFFIO_R12N 10 2 73/DIFFIO_R12P 10 2 75/DIFFIO_R11N 10 2 75/DIFFIO_R11N 10 2 75/DIFFIO_R10N 10 2 75/DIFFIO_R10P 10 2 75/DIFFIO_R10P 10 2 75/DIFFIO_R10N 10 2 80/DIFFIO_R10N 10 2 80/DIFFIO_R1N 10 2 85/DIFFIO_R1N 10 2 85/DIFFIO_R2N 10 2 85/DIFFIO_R2N 10 2 85/DIFFIO_R2N 10 2 95/DIFFIO_R5N 10 2 95/DIFFIO_R5N 10 2 95/DIFFIO_R5N 10 2 95/DIFFIO_R3N 10 2 102/DIFFIO_R3N 10 2 102/DIFFIO_R3N 10 2 102/DIFFIO_R3N 10 2 102/DIFFIO_R3N 10 2 102/DIFFIO_R3N 10 2 102/DIFFIO_R1N 10 2 105/DIFFIO_R1N 10 2 105/DIF	IO_2_114/DIFFIO_T11N IO_2_117/DIFFIO_T11P IO_2_119/DIFFIO_T10P IO_2_120/DIFFIO_T00 IO_2_122/DIFFIO_T00 IO_2_122/DIFFIO_T00 IO_2_122/DIFFIO_T00 IO_2_122/DIFFIO_T00 IO_2_122/DIFFIO_T00 IO_2_122/DIFFIO_T00 IO_2_122/DIFFIO_T00 IO_2_122/DIFFIO_T00 IO_2_122/DIFFIO_T00 IO_2_122/DIFFIO_T00 IO_2_122/DIFFIO_T00 IO_2_122/DIFFIO_T00 IO_2_122/DIFFIO_T00 IO_2_122/DIFFIO_T00 IO_2_122/DIFFIO_T00 IO_2_122/DIFFIO_T00 IO_2_122/DIFFIO_T00 IO_2_132/DIFFIO_T00 IO_2_132/DIFFIO_T00 IO_2_133/DIFFIO_T00 IO_2_133/DIFFIO_T00 IO_2_133/DIFFIO_T00 IO_2_133/DIFFIO_T00 IO_2_133/DIFFIO_T00 IO_2_133/DIFFIO_T00 IO_2_133/DIFFIO_T00 IO_2_133/DIFFIO_T00 IO_2_133/DIFFIO_T00 IO_2_133/DIFFIO_T00 IO_2_133/DIFFIO_T00 IO_2_133/DIFFIO_T00 IO_2_133/DIFFIO_T00 IO_2_133/DIFFIO_T00 IO_2_133/DIFFIO_T00 IO_2_133/DIFFIO_T00 IO_2_133/DIFFIO_T00 IO_2_132/DIFFIO_T00 IO_2_142/DIFFIO_100 IO_2_142/DIFFIO_100 IO_2_142/DIFFIO_100 IO_2_142/DIFFIO_100
	MAX V 5M240ZT144	









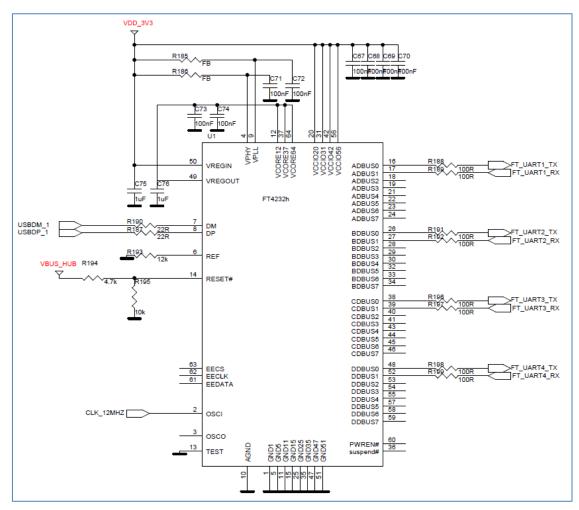


Figure 122: FTDI Chip for USB UART to DUTs 1, 2, 3 and 4

lleor	Manual	
USCI	Manuai	



USB HUB: provides 5 V input for the 3.3 V LDO and USB input-signals to the four Quad FTDI chips.

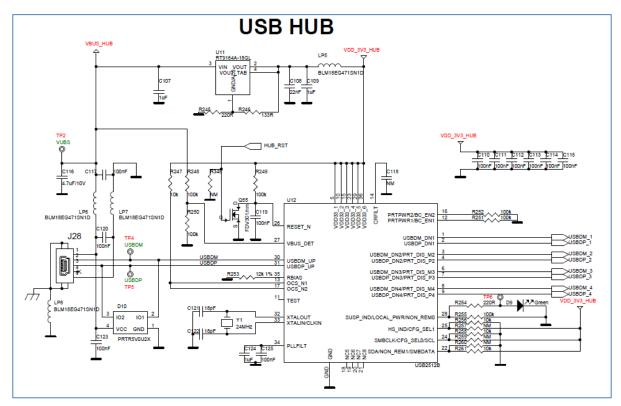


Figure 123: Quad USB HUB

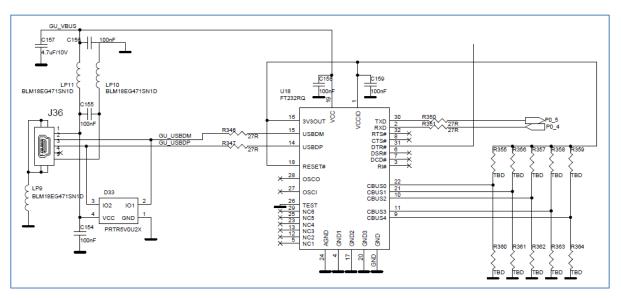


Figure 124: Golden Unit - Dedicated USB Port and FTDI Chip

U	ser	Μ	an	ual	
-	301		an	uui	

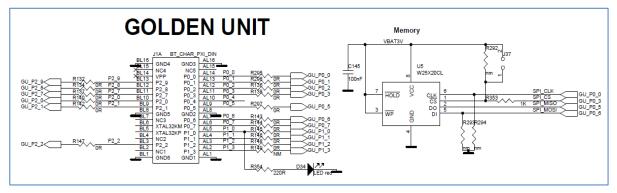


Figure 125: Golden Unit - GU LED and SPI Flash Memory

The Golden Unit SW ($prod_test_GU.bin$) is located in the SPI Flash memory mounted on the PLT hardware and is loaded into the GU's system RAM when powered on.

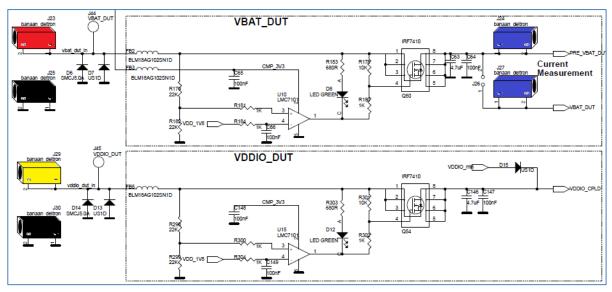
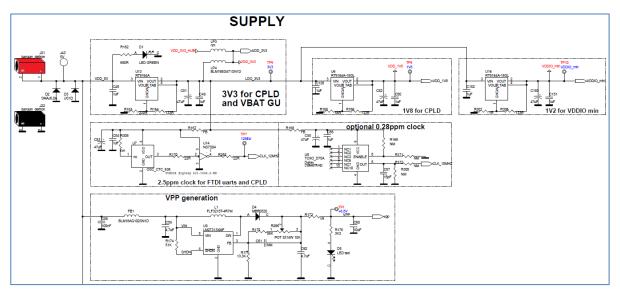


Figure 126: VBAT_DUT and VDDIO Supplies





Appendix C Hardware Modifications PLT Version D

In the PLT hardware Version D a small modification was made. Resistor R365 (10 k Ω) and jumper J47 were added in series to the GU reset circuit.



Figure 128: DA14580_RD_tester Version D



Figure 129: Jumper J47 Added Next to Golden Unit Socket







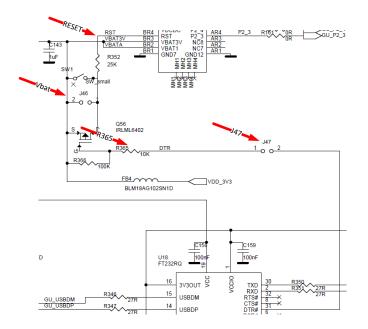


Figure 131: R365, J47 and RESET Shown in Electrical Schematic

User Manual

Appendix D Suggestions about Hardware and Cabling

When connecting the PLT to the DUTs special care should be taken with regard to the cabling.

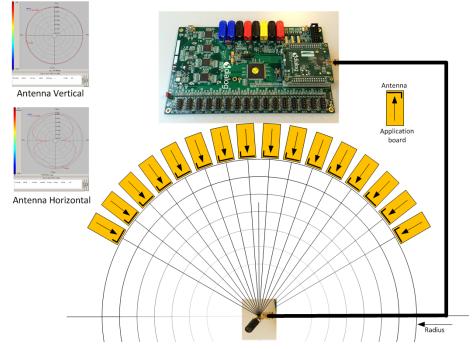


Figure 132: Possible Solution of Antenna on Cable and Fixed Radius of DUTs to Antenna

The user should realize that the PLT system is equipped with RF transmitters and receivers. These parts may induce noise on hardware and cables. The following aspects should be kept in mind:

- The direction of the GU antenna to the DUT antenna will influence the RSSI value.
- The distance of the DUT antenna to the GU antenna (radius) will influence the RSSI value.
- The control lines from the PLT to the DUTs must be kept as short as possible.
- A vertical GU antenna has different characteristics from a horizontal one. See Figure 132.

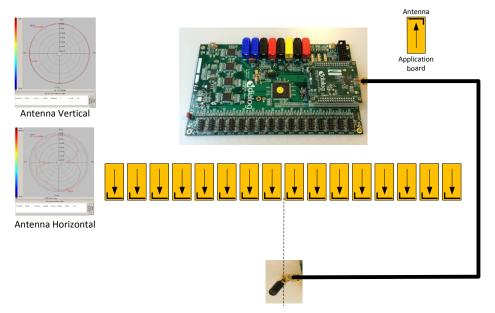


Figure 133: Possible Solution of Antenna on Cable and DUTs Put in Line

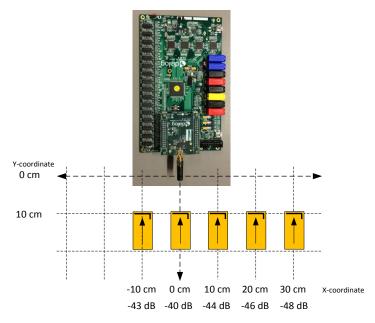




Figure 134 shows the measured values from Table 97.

Test	Distance (cm)	Offset (cm)	RSSI (dBm)	Description
1	10	0	-40	DUT and GU boards are inline.
2	10	-10	-43	DUT moved 10 cm to the left relative to the GU.
3	10	10	-44	DUT moved 10 cm to the right relative to the GU.
4	10	20	-46	DUT moved 20 cm to the right relative to the GU.
5	10	30	-48	DUT moved 30 cm to the right relative to the GU.
6	10	normal	-40	DUT and GU boards are inline, functioning normally.

Table 97: RF Test RSSI Results

User Manual

Revision 4.3

03-Feb-2022



Test	Distance (cm)	Offset (cm)	RSSI (dBm)	Description
7	10	defect 1	-60 ~ -70	Coupling capacitor not soldered well, missing or damaged.
8	10	defect 2	~ -60	Short circuited shunt matching inductor (e.g. solder bridge)
9 10 defect 3 < -100 16 MHz crystal oscillator not working well. Received packets ~ 0.				
Golden Unit output power = 0 dBm				

For more details on the RF setup refer to [12].

Appendix E Hex2Bin

This section gives a step-by-step example of using the hex2bin.exe utility, which converts Intel HEX files into binary format. See Figure 136.

- 1. Put the hex2bin.exe file in same directory as the HEX files to be converted.
- 2. Open a Command Line Interface (CLI) in the same directory, e.g. by using <Shift>+<Right Click> and selecting 'Open command window here'.
- 3. Enter "hex2bin -c blinky_1.hex".
- 4. The binary file (blinky_1.bin) will be produced in the same directory.

Figure 135 shows the directory and the files used in this example.

*	Name	Date modified	Туре	Size
	퉬 temp	1/14/2015 9:17 AM	File folder	
	blinky_1.bin	1/14/2015 9:18 AM	BIN File	2 KB
	blinky_1.hex	1/14/2015 8:52 AM	HEX File	4 KB
	blinky_2.bin	1/14/2015 9:19 AM	BIN File	2 KB
	blinky_2.hex	1/14/2015 8:57 AM	HEX File	4 KB
	💷 hex2bin.exe	10/21/2014 2:39 PM	Application	55 KB

Figure 135: Hex2Bin Example Directory with Files

UM-B-041



DA1458x/DA1468x Production Line Tool

🔤 C:\WINDOWS\system32\cmd.exe
usage: hex2bin [OPTIONS] filename
Options:
-s [address] Starting address in hex (default: 0) -1 [length] Maximal Length (Starting address + Length -1 is Max Address) File will be filled with Pattern until Max Address is reached Length must be a power of 2 in hexadecimal: Hex Decimal 1000 = 4096 (4ki) 2000 = 8192 (8ki) 4000 = 16384 (16ki)
$\begin{array}{rcl} 10000 & = & 10307 & (10017) \\ 8000 & = & 65536 & (64ki) \\ 20000 & = & 131072 & (128ki) \\ 40000 & = & 262144 & (256ki) \\ 80000 & = & 524288 & (512ki) \\ 100000 & = & 1048576 & (1Mi) \end{array}$
200000 = 2097152 (2Mi) 400000 = 4194304 (4Mi) 800000 = 8388608 (8Mi)
 -e [ext] Output filename extension (without the dot) -c Enable hex file checksum verification -p [value] Pad-byte value in hex (default: ff)
<pre>-k [0!1!2] Select checksum type</pre>
C:_hex2bin>hex2bin -c blinky_1.hex hex2bin v1.0.10, Copyright (C) 2012 Jacques Pelletier & contributors
Lowest address = 0000000 Highest address = 00000447 Pad Byte = FF 8-bit Checksum = 33
C:_hex2bin>hex2bin -c blinky_2.hex hex2bin v1.0.10, Copyright (C) 2012 Jacques Pelletier & contributors
Lowest address = 00000000 Highest address = 00000477 Pad Byte = FF 8-bit Checksum = D8
C:_hex2bin>cd _hex2bin_

Figure 136: Hex2Bin.exe Example

Appendix F Bin2Image

Figure 138 shows an example of using the bin2image.exe utility, which creates a bootable cached image for DA1468x devices.

The file bin2image.exe must be put in the same directory as the file to be converted. Figure 137 shows the directory and the files used in this example.

IDisk (C:) ▶ _Test ▶				
Share with 🔻 New folder				
Name	Date modified	Туре	Size	
퉬 temp	7/27/2016 8:54 PM	File folder		
💷 bin2image.exe	5/17/2016 9:53 PM	Application	44 KB	
pxp_reporter.bin	10/16/2015 5:19 PM	BIN File	57 KB	
pxp_reporter.bin.cached	7/27/2016 8:54 PM	CACHED File	57 KB	

Figure 137: Bin2Image Example Directory with Files

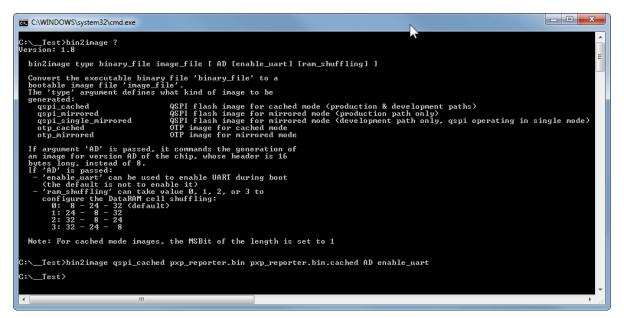


Figure 138: Bin2Image Example

Appendix G Automatic GU COM Port Find

For the GU COM port automatic recognition to operate a special serial number should exist in the GU FTDI IC. Usually this serial number is programmed during PLT PCB manufacturing, but it may not exist in some older versions.

If the 'GU COM port find' operation does not work, then the steps described in should be followed.

Table 98: FTDI "DialogSemi" Serial Number

Step	Description				
1	Download the FTDI FT_Prog tool from http://www.ftdichip.com/Support/Utilities.htm#FT_PROG.				
2	Put power on the PLT board.				
3	Remove any other USB FTDI connection to the PC.				
4	Connect the USB cable of the GU to the PC.				
5	Check the Device Manager that the GU COM port has been found.				
6	Run the FT_Prog.exe.				
	FT_Prog.exe				
7	Select 'Devices > Scan and Parse.				
	FTDI - FL Prog EEPROM FLE DEVICES HELP DeviceT Program Ctrl+P Property Value				
8	A single 'FT232' device should be found.				
	FTDI - FT Prog - Device: 0 [Loc ID:0x0] EEPPON ELASH ROM FLE DEVICES HLE DEVICES Device: 0 [Loc ID:0x0] FTDI - FT 222R' Vendor ID: 0x0403 Product ID: 0x06001 BerROM Type 93C56 EEPROM				
9	Select 'USB String Descriptors'.				
10	Uncheck the 'Auto Generate Serial No:'.				
11	Edit 'Serial Number' to "DialogSemi" as shown below.				





Step	Description
12	Press the 'Flash' button to program the change to the FTDI IC.
13	Program Devices Program Devices Product Data Product DD Device: 0 [Loc ID:0x0] Chip Type: TT232R Vendor ID: 0:0403 Product DD: 0:0403 Product Decolption: TT22R USB UART Sediet Al Deselect Al Only Program Bank Devices Vendor Fizzer USB UART Sediet Al Deselect Al Only Program Bank Devices Vendor Data
14	Press 'Close'.
15	Unplug and reconnect the GU USB cable to the PC.
16	Verify the Serial Number change by running FT_Prog.exe again and reading the Serial Number value.

Appendix H Improving Cabling between PLT and DUTs

The following recommendations can be used to improve the connections between PLT and DUTs:

- Keep the lengths of the cables as short as possible.
- When possible use twisted pair cables instead of separate cables for:
 - GND/VBAT
 - GND/TxD
 - GND/RxD
 - GND/VPP
- Use ferrite beads for noise reduction in cables.

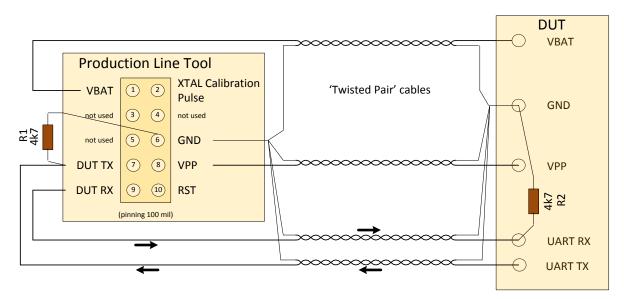


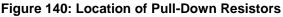
Figure 139: Example of Twisted Pair Cable with 4 Pairs and Ferrite

- Connect pull-down resistors at the end of the PLT TX signal lines. Use a 4.7 kΩ resistor at PLT DUT Connector Pin 7 (DUT TX) with the other end connected to ground. In total 16 resistors must be mounted, one for each PLT DUT connector.
- Connect a pull-down resistor as close as possible to the UART RX signal connector on the DUT. The value should be approximately 4.7 kΩ. Connect the other end of the resistor to ground.
- Use gold plated contacts in the connections between the PLT and the DUTs.
- Use extra drivers in the UART lines.
- Use series resistors of approximately 100 Ω in the UART lines, one mounted at the beginning and one at the end of the signal lines.

Note: Start with the simple solutions first by testing them one-by-one for stability.

Figure 140 and Figure 141 show examples of some of the above proposals.





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User Manual	Revision 4.3	03-Feb-	

-2022

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DA1458x/DA1468x Production Line Tool

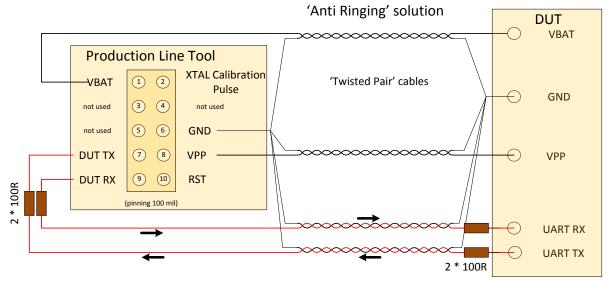


Figure 141: Anti-Ringing Solution

User Manual

Appendix I Settings for DA14583 Internal SPI Flash Memory

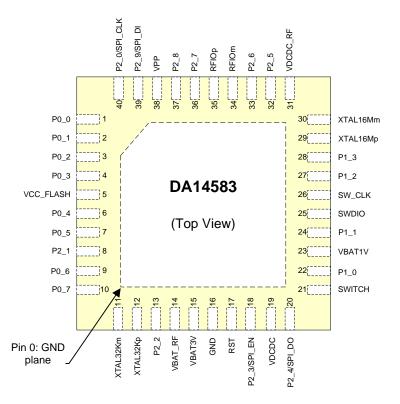
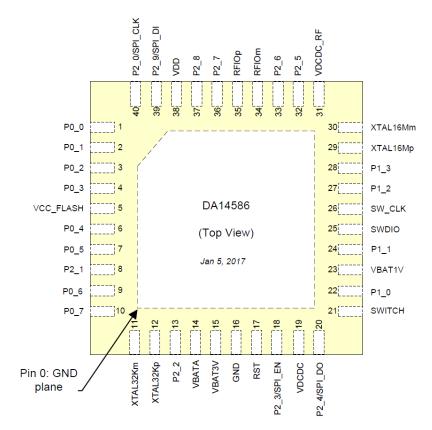




Table 99: DA14583	Internal SP	Flash Connections
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DA14583 Pin	SPI Function	Description
P2_0	SPI_CLK	SPI Clock
P2_9	SPI_DI	MOSI
P2_4	SPI_DO	MISO
P2_3	SPI_EN	SPI Chip Select



Appendix J Settings for DA14586 Internal SPI Flash Memory

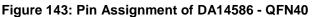


Table 100: DA14586 Internal SPI Flash Connections

DA14586 Pin	SPI Function	Description
P2_0	SPI_CLK	SPI Clock
P2_9	SPI_DI	MOSI
P2_4	SPI_DO	MISO
P2_3	SPI_EN	SPI Chip Select

Appendix K Honeywell Xenon 1900 Barcode Scanner Setup

In order to use the Honeywell Xenon 1900 then please follow the steps below to appropriate set it up for PLT usage:

- 1. Download Xenon-UG.pdf User Guide.
- 2. Scan Restore factory defaults at page 198 (Resetting the Factory Defaults)
- 3. Program the USB to Serial Interface. Scan code at Page 32 (TRMUSB130)
- 4. Download Xenon USB to Serial drivers HSM USB Serial Driver version 3.5.5.zip

Appendix L Program the Golden Unit SPI Flash Memory

The SPI Flash memory of the Golden Unit can be programmed as any DA14580 device, using the JTAG connector next to the Golden Unit and the Smart Snippets Toolbox application.

- 1. Connect the power supply to the Rd tester board as described in PLT Power Supply.
- 2. Connect the USB cable of the Golden Unit.
- 3. Connect the JTAG (J2) of the Golden Unit.
- 4. Open the Smart Snippets Toolbox and select the JTAG method and the DA14580 chip.
- 5. Under the "Layout" category, on the "Booter & Board Setup page", the GPIOs for the Flash memory should be the following: CLK: P0_0, CS: P0_3, MISO: P0_5, MOSI: P0_6.
- 6. Under the "Tools" category, on the "SPI Flash Programmer" tab, using the "Browse" button, select the "prod_test_GU.bin" binary which is under the DA1458x_DA1468x_PLT_v4.x/binaries/GU/ prod_test_GU.bin folder on the PLT software package.
- 7. After the binary is loaded on the Smart Snippets Toolbox, press "Connect" at the bottom. This will download a firmware on the Golden Unit and set the SPI Flash GPIOs to program the memory.
- 8. Select "Erase" to completely erase the Flash memory before burning the new firmware.
- 9. Select "Burn and Verify". On the pop-up message select to make the firmware bootable.
- 10. Remove the JTAG from the Rd tester board and then manually reset the Golden Unit using the reset button next to it. The Golden Unit has now booted with the new firmware.

Appendix M Connecting a Speaker to the Golden Unit for Audio Test

PLT is able to perform audio test for the DA1582, DA14585 and DA14586 devices. The audio test settings are described in Audio Test. A speaker can be connected to the Golden Unit using GPIOs P1_0 (AL4) and P1_1 (AL5) as shown in Figure 144 to generate the 4 kHz tone.



Figure 144: Speaker Connection for Audio Test.

Appendix N FTDI Driver Removal and Installation

In order to re-install the latest FTDI drivers, the previous should be uninstalled.

FTDI driver removal:

- 1. Download CDM uninstaller from http://www.ftdichip.com/Support/Utilities.htm#CDMUninstaller.
- 2. Plug both USB cables of the PLT HW and wait for Windows to identify the COM ports. Wait until Windows complete the driver installation (even with a failure).
- 3. Run CDMuninstallerGUI.exe
- The VID/PID of the PLT FTDIs are VID=0403/PID=6011 for the DUTs and VID=0403/PID=6001 for the GU.
 Enter these VIDs and PIDs in the CDM Uninstaller and press add for each one.
- 5. Then press Remove Devices to uninstall the FTDI drivers.
- 6. Un-plug both USB cables.

FTDI driver installation:

- 1. Download the latest drivers from http://www.ftdichip.com/Drivers/VCP.htm and install them using the executable.
- 2. After uninstalling the drivers, plug in both USB cables. Windows will automatically assign the new drivers. Do not remove the cables during driver installation. A driver installation error may occur and the removal-installation will have to be repeated.
- 3. Check in the Windows Device manager that now the driver version of the 17 PLT COM Ports->USB Serial Ports (COMx) is the latest.

FTDI driver versions v2.12.24, v2.12.26 and 2.12.28 have been tested.

Appendix O DA1458x DK PRO Motherboard Connection

Figure 145 shows the wiring to a Pro DK motherboard for the DA14580/1/2/3/5/6 DUTs.

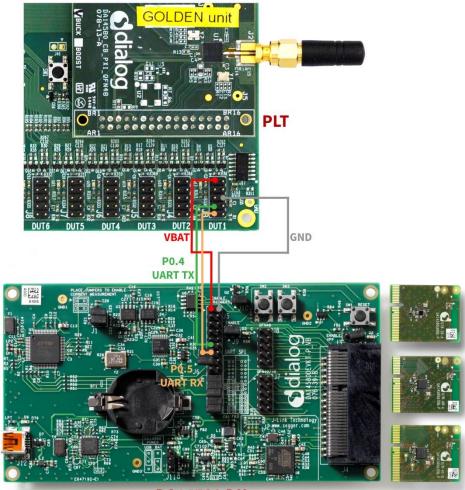
As described in DUT Connector the following connections are needed to connect a DUT to the PLT:

- 1. Ground. DUT connector pin6 <-> Pro DK J5 pin2.
- 2. VBAT. DUT connector pin1 <-> Pro DK J5 pin1.
- 3. UART Tx. DUT connector pin7 <-> Pro DK J5 pin11.
- 4. UART Rx. DUT connector pin9 <-> Pro DK J5 pin13.
- 5. Reset. DUT connector pin10 <-> Solder to Reset button (SW1) (Optional).

Note: If no power supply is provided through the USB cable (J12), the reset circuit will drive the reset pin of the DUT host board (connector J4) high, keeping the DUT at a reset state. To overcome this either the R84 resistor should be removed or the USB cable should be connected.

Note: J11jumper should be removed. Power supply will be provided from the PLT HW (VBAT line).

Note: To use the onboard SPI flash memory the J5 jumper configuration should be as shown on the silkscreen PCB print (left of J5). A triple jumper must be used to connect the P0_5 (J5 – pin13) with the SPI MISO (J6 – pin2) and the PLT UART-Rx pin (on DUT connector – pin9).



DA14580 DK

Figure 145: DA14580/5 Pro Motherboard DK Wiring.

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Appendix P DA1468x DK PRO Motherboard Connection

Figure 146 shows the wiring to a Pro DK motherboard for the DA14680/1/2/3 DUTs.

As described in DUT Connector the following connections are needed to connect a DUT to the PLT:

- 1. Ground. DUT connector pin6 <-> Pro DK J3 pin22.
- 2. VBAT. DUT connector pin1 <-> Pro DK J3 pin24.
- 3. UART Tx. DUT connector pin7 <-> Pro DK J4 pin8.
- 4. UART Rx. DUT connector pin9 <-> Pro DK J3 pin19.
- 5. Reset. DUT connector pin10 <-> Solder to Reset button (K2) (Optional).

Note: All jumpers must be removed. Power supply will be provided from the PLT HW (VBAT line).

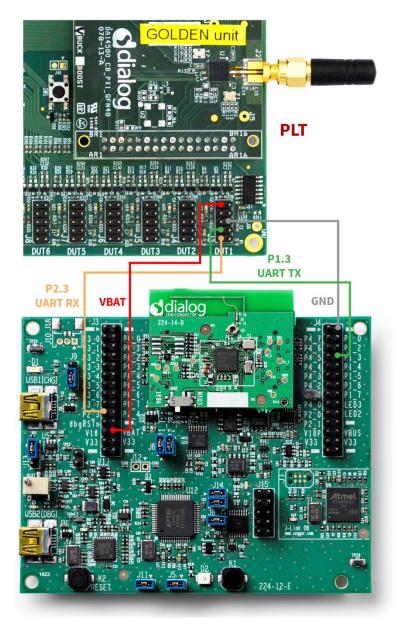


Figure 146: DA14680/1/2/3 Pro Motherboard DK Wiring.

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Appendix Q Connecting DUT with Battery Supply

Wiring connections to a battery powered DUT is described in DUT Connector and chapters DA1458x DK PRO Motherboard Connection and DA1468x DK PRO Motherboard Connection can be taken as an example but there are some limitations.

- 1. Four wires are mandatory for the connection:
 - Common Ground
 - UART Tx
 - UART Rx
 - Reset line

Note: In order to have the least possible wiring connections, UART Rx line can also be used as input GPIO for the pulse used during the XTAL Trim procedure as described in XTAL Trim and XTAL Trim.

- 2. VBAT as Reset mode is the only mode supporting battery powered DUTs since POR cannot be performed. In order for the PLT to perform a reset on the DUTs, the VBAT line of each DUT connector must be connected to the reset line of the DUT as described in VBAT as Reset mode.
- 3. Current measurement is not supported, since there is no way to measure the current of the DUTs.
- In order to program the OTP for the DA14580/1/2/3 DUTs an external VPP voltage must be supplied. VPP lines on the DUT connectors will not provide any voltage in VBAT as Reset mode so they cannot be used.

Appendix R DUT Status Codes

Table 101 contains all the possible status codes a DUT can have, followed by a brief description. The table categorizes the status based on the various states of the DUT during testing and programming.

Table 101: DUT Status Codes

Status	Description
Generic	
DUT_NOT_ACTIVE	Device is not active.
DUT_INTERNAL_SYSTEM_ERROR	Internal system error.
DUT_COM_PORT_IDENTIFY_STARTED	COM port identification started.
DUT_COM_PORT_IDENTIFY_OK	COM port identified successfully.
DUT_COM_PORT_IDENTIFY_FAILED	COM port identification failed.
DUT_GU_ERROR	Error occurred due to a Golden Unit failure. Check the Golden unit status for more information.
COM port enumeration	
DUT_PDLL_UART_LOOP_INIT	UART loop test initialized.
DUT_PDLL_UART_LOOP_START	UART loop test start.
DUT_PDLL_UART_LOOP_OK	UART loop test ended successfully.
DUT_PDLL_UART_LOOP_FAILED	UART loop test failed.
Temperature measurement	
DUT_TEMPERATURE_MEASUREMENT_INIT	Temperature measurement initialized.
DUT_TEMPERATURE_MEASUREMENT_OK	Temperature measurement finished successfully.
DUT_TEMPERATURE_MEASUREMENT_ERROR	Temperature measurement error.
Production test - Generic errors	
DUT_PDLL NO ERROR	PDLL returned success.
DUT_PDLL_PARAMS_ERROR	PDLL Device parameters contain errors.
DUT PDLL RX TIMEOUT	Device did not reply on a PDLL message request.
DUT_PDLL_TX_TIMEOUT	Sending a message to the device failed due to Tx timeout.
DUT_PDLL_UNEXPECTED_EVENT	Received an unexpected message from the device.
DUT_PDLL_CANNOT_ALLOCATE_MEMORY	PDLL cannot allocate memory.
DUT PDLL INTERNAL ERROR	PDLL internal system error.
DUT_PDLL_THREAD_CREATION_ERROR	PDLL thread creation error.
DUT_PDLL_INVALID_DBG_PARAMS	PDLL debug library (dbg_dll.dll) access error.
DUT PDLL DBG DLL ERROR	PDLL invalid debug library (dbg_dll.dll) parameters.
DUT PDLL HCI STANDARD ERROR	HCI error.
Production test - COM port	
DUT_PDLL_COM_PORT_INIT	PDLL Device COM port open initialized.
DUT_PDLL_COM_PORT_START	PDLL Device COM port open started.
DUT PDLL COM PORT OK	PDLL Device COM port opened successfully.

User Manual



Status	Description
DUT PDLL COM PORT FAILED	PDLL Device COM port failed.
Production test - UART resync	
DUT PDLL UART RESYNC INIT	UART resync process initialized.
DUT PDLL UART RESYNC START	UART resync process started.
DUT PDLL UART RESYNC OK	UART resync process completed successfully.
DUT PDLL UART RESYNC FAILED	UART resync process failed.
Production test - Firmware version	1
DUT PDLL FW VERSION GET START	PDLL Firmware version acquisition started.
DUT PDLL FW VERSION GET OK	PDLL Device Firmware version acquisition completed successfully.
DUT PDLL FW VERSION GET FAILED	PDLL Device Firmware version acquisition failed.
Production test - Current measurement test	
DUT SLEEP CURRENT MEASURE INIT	Current measurement test initialized.
DUT SLEEP CURRENT MEASURE START	Current measurement test start.
DUT SLEEP DEVICE SLEPT OK	Current measurement device mode set successfully.
DUT SLEEP CURRENT MEASURE ERROR	Current measurement test error.
DUT SLEEP CURRENT MEASURE PASSED	Current measurement test passed.
DUT SLEEP CURRENT MEASURE FAILED	Current measurement test failed.
Production test - XTAL trim	1
Xtal trim test	
DUT_PDLL_XTAL_TRIM_INIT	XTAL trim operation initialized.
DUT_PDLL_XTAL_TRIM_START	XTAL trim operation started.
DUT_PDLL_XTAL_TRIM_OK	XTAL trim operation ended successfully.
DUT_PDLL_XTAL_TRIM_OUT_OF_RANGE	XTAL trim failed. Input frequency is out of range.
DUT_PDLL_XTAL_TRIM_FREQ_CAL_NOT_CONNECTED	XTAL trim could not be performed. Could not detect external input frequency.
DUT_PDLL_XTAL_TRIM_OTP_WRITE_FAILED	XTAL trim failed. Could not write the calculated value to the OTP header.
DUT_PDLL_XTAL_TRIM_FAILED	XTAL trim failed.
Read value written in OTP	
DUT_PDLL_OTP_XTAL_TRIM_READ_INIT	OTP XTAL trim read operation initialized.
DUT_PDLL_OTP_XTAL_TRIM_READ_START	OTP XTAL trim read operation started.
DUT_PDLL_OTP_XTAL_TRIM_READ_OK	OTP XTAL trim read operation ended successfully.
DUT PDLL OTP XTAL TRIM READ FAILED	OTP XTAL trim read operation failed.
Read register value	
	XTAL trim value read initialized.
Read register value	XTAL trim value read initialized. XTAL trim value read started.
Read register value DUT_PDLL_XTAL_TRIM_READ_INIT	

User Manual





Status	Description
Production test - Golden Unit	I
Rf test	
DUT_PDLL_GU_RF_RX_TEST_PASSED	Golden Unit RF RX packet test passed.
DUT_PDLL_GU_RF_RX_TEST_FAILED	Golden Unit RF RX packet test failed.
DUT start packet Rx	I
DUT_PDLL_PKT_RX_STATS_START_INIT	RF RX packet test with statistics start initialized.
DUT_PDLL_PKT_RX_STATS_START	RF RX packet test with statistics start.
DUT_PDLL_PKT_RX_STATS_STARTED_OK	RF RX packet test with statistics started successfully.
DUT_PDLL_PKT_RX_STATS_START_FAILED	RF RX packet test with statistics started failed.
DUT stop packet Rx	
DUT_PDLL_PKT_RX_STATS_STOP_INIT	RF RX packet test with statistics stop initialized.
DUT_PDLL_PKT_RX_STATS_STOP_START	RF RX packet test with statistics stop.
DUT_PDLL_PKT_RX_STATS_STOPPED_OK	RF RX packet test with statistics stopped successfully.
DUT_PDLL_PKT_RX_STATS_STOP_FAILED	RF RX packet test with statistics stop failed.
Production test - BLE tester	
Tx power measurement	
DUT_BLE_TESTER_TX_PWR_PASSED	BLE tester TX power test passed.
DUT_BLE_TESTER_TX_PWR_FAILED	BLE tester TX power test failed.
Tx carrier offset measure	
DUT_BLE_TESTER_TX_OFFS_PASSED	BLE tester TX frequency offset test passed.
DUT_BLE_TESTER_TX_OFFS_FAILED	BLE tester TX frequency offset test failed.
Tx modulation index measure	
DUT_BLE_TESTER_TX_MOD_IDX_PASSED	BLE tester TX modulation index test passed.
DUT_BLE_TESTER_TX_MOD_IDX_FAILED	BLE tester TX modulation index test failed.
Rx sensitivity test	
DUT_BLE_TESTER_RX_TEST_PASSED	BLE tester RX sensitivity test passed.
DUT_BLE_TESTER_RX_TEST_FAILED	BLE tester RX sensitivity test failed.
DUT packet transaction	
DUT_PDLL_PKT_TX_START_INIT	RF packet TX initialized.
DUT_PDLL_PKT_TX_START	RF packet TX start.
DUT_PDLL_PKT_TX_STARTED_OK	RF packet TX started successfully.
DUT_PDLL_PKT_TX_STARTED_FAILED	RF packet TX failed to start.
DUT_PDLL_PKT_TX_ENDED_START	RF packet TX ended successfully.
DUT_PDLL_PKT_TX_ENDED_OK	RF packet TX end initiated.
DUT_PDLL_PKT_TX_ENDED_FAILED	RF packet TX failed to end.
Production test - GPIO/LED test	
DUT_PDLL_GPIO_TOGGLE_INIT	GPIO-LED test operation initialized.
DUT_PDLL_GPIO_TOGGLE_START	GPIO-LED test operation start.
DUT_PDLL_GPIO_TOGGLE_FINISHED_OK	GPIO-LED test operation completed successfully.

User Manual



Status	Description
DUT_PDLL_GPIO_TOGGLE_ERROR	GPIO-LED test operation error.
DUT_PDLL_GPIO_TOGGLE_FAILED	GPIO-LED test operation failed.
DUT_PDLL_GPIO_TOGGLE_PASSED	GPIO-LED test operation passed.
Production test - Audio test	
DUT_PDLL_AUDIO_TEST_START_INIT	Audio test start action initialized.
DUT_PDLL_AUDIO_TEST_START	Audio test action start.
DUT_PDLL_AUDIO_TEST_ALREADY_ACTIVE	Audio test is already active.
DUT_PDLL_AUDIO_TEST_STARTED_OK	Audio test action started successfully.
DUT_PDLL_AUDIO_TEST_START_FAILED	Audio test start action failed.
DUT_PDLL_AUDIO_TEST_STOP_INIT	Audio test stop action initialized.
DUT_PDLL_AUDIO_TEST_STOP	Audio test stop action started.
DUT_PDLL_AUDIO_TEST_STOPPED_OK	Audio test stop action completed successfully.
DUT_PDLL_AUDIO_TEST_STOP_FAILED	Audio test stop action failed.
DUT_PDLL_AUDIO_TEST_PASSED	Audio test passed.
DUT_PDLL_AUDIO_TEST_FAILED	Audio test failed.
DUT_PDLL_AUDIO_TEST_INVALID_COMMAND	Audio test invalid command.
Production test - Sensor test	·
DUT_PDLL_SENSOR_TEST_INIT	Sensor test action initialized.
DUT_PDLL_SENSOR_TEST_START	Sensor test action start.
DUT_PDLL_SENSOR_TEST_OK	Sensor test action ended successfully.
DUT_PDLL_SENSOR_TEST_FAILED	Sensor test action failed.
DUT_PDLL_SENSOR_TEST_DATA_MATCH_OK	Sensor test action data matched.
DUT_PDLL_SENSOR_TEST_DATA_MATCH_FAILED	Sensor test action data match failure.
Production test - Custom action test	·
DUT_PDLL_CUSTOM_ACTION_INIT	Custom test action initialized.
DUT_PDLL_CUSTOM_ACTION_START	Custom test action start.
DUT_PDLL_CUSTOM_ACTION_OK	Custom test action ended successfully.
DUT_PDLL_CUSTOM_ACTION_FAILED	Custom test action failed.
DUT_PDLL_CUSTOM_ACTION_DATA_MATCH_OK	Custom test action data matched.
DUT_PDLL_CUSTOM_ACTION_DATA_MATCH_FAILED	Custom test action data match failure.
Production test - ADC calibration test	·
DUT_PDLL_ADC_CALIB_INIT	ADC calibration process. Initializing process.
DUT_PDLL_ADC_CALIB_VBAT_RD_START	ADC calibration process. Start reading VBAT voltage using the external voltage meter instrument.
DUT_PDLL_ADC_CALIB_VBAT_RD_OK	ADC calibration process. VBAT voltage read ended successfully.
DUT_PDLL_ADC_CALIB_VBAT_RD_FAILED	ADC calibration process. VBAT voltage read failed.
DUT_PDLL_ADC_CALIB_DUT_RD_INIT	ADC calibration process. Initialize reading device ADC samples.
DUT_PDLL_ADC_CALIB_DUT_RD_START	ADC calibration process. Start reading device ADC samples.

User Manual



Status	Description
DUT_PDLL_ADC_CALIB_DUT_RD_OK	ADC calibration process. Device ADC samples read success.
DUT_PDLL_ADC_CALIB_DUT_RD_FAILED	ADC calibration process. Device ADC samples read failed.
DUT_PDLL_ADC_CALIB_OK	ADC calibration process ended successfully.
DUT_PDLL_ADC_CALIB_FAILED	ADC calibration process failed.
Production test - Scan test	
DUT_PDLL_BLE_SCAN_INIT	Scan operation initialized.
DUT_PDLL_BLE_SCAN_START	Scan operation start.
DUT_PDLL_BLE_SCAN_NOT_YET_FOUND	Scan operation. DUT has not been found yet.
DUT_PDLL_BLE_SCAN_FOUND	Scan operation completed successfully. DUT was found.
DUT_PDLL_BLE_SCAN_FAILED	Scan operation failed. DUT was not found.
Memory programming - Generic errors	·
DUT_UDLL_SUCCESS	UDLL returned success.
DUT_UDLL_ACTION_RESPONSE_ERROR	UDLL device responded with error.
DUT_UDLL_UART_RX_TIMEOUT_ERROR	UDLL UART RX timeout. Cannot communicate with the DUT or DUT is not present.
DUT_UDLL_NO_CRC_MATCH_ERROR	UDLL CRC match error.
DUT_UDLL_PROG_PARAMS_ERROR	UDLL programming parameter error.
DUT_UDLL_DEVICE_PARAMS_ERROR	UDLL device parameter error.
DUT_UDLL_UART_WRITE_ERROR	UDLL UART write returned error.
DUT_UDLL_UART_READ_ERROR	UDLL UART read returned error.
DUT_UDLL_INTERNAL_ERROR	UDLL internal error.
DUT_UDLL_COM_PORT_INIT_ERROR	UDLL COM port initialization error.
DUT_UDLL_COM_PORT_ERROR	UDLL COM port error.
DUT_UDLL_CANNOT_ALLOCATE_MEMORY	UDLL cannot allocate memory.
DUT_UDLL_READ_FILE_SIZE_ERROR	UDLL read file size error.
DUT_UDLL_CANNOT_OPEN_FW_FILE	UDLL cannot open firmware file.
DUT_UDLL_CANNOT_OPEN_IMAGE_FILE	UDLL cannot open image file.
DUT_UDLL_UART_PINS_PATCH_ERROR	UDLL cannot patch the UART pins into the firmware file.
DUT_UDLL_INVALID_DBG_PARAMS	UDLL invalid debug library (dbg_dll.dll) parameters.
DUT_UDLL_DBG_DLL_ERROR	UDLL debug library (dbg_dll.dll) access error.
Firmware download	
DUT_UDLL_FW_DOWNLOAD_INIT	UDLL firmware download initialized.
DUT_UDLL_FW_DOWNLOAD_STARTED	UDLL firmware download started successfully.
DUT_UDLL_FW_DOWNLOAD_RETRY	UDLL firmware download retry.
DUT_UDLL_FW_DOWNLOAD_OK	UDLL firmware downloaded successfully.
DUT_UDLL_FW_DOWNLOAD_FAILED	UDLL firmware download failed.

User Manual



Status	Description
Memory programming - OTP image write	
DUT_UDLL_OTP_IMG_WR_INIT	OTP image write operation initialized.
DUT_UDLL_OTP_IMG_WR_STARTED	OTP image write operation started.
DUT_UDLL_OTP_IMG_WR_OK	OTP image write operation ended successfully.
DUT_UDLL_OTP_IMG_WR_FAILED	OTP image write operation failed.
Memory programming - BD address write to OT	P memory
DUT_UDLL_OTP_BDA_WR_INIT	OTP BD address write operation initialized.
DUT_UDLL_OTP_BDA_WR_STARTED	OTP BD address write operation started.
DUT_UDLL_OTP_BDA_WR_OK	OTP BD address write operation ended successfully.
DUT_UDLL_OTP_BDA_WR_FAILED	OTP BD address write operation failed.
Memory programming - BD address read/comp	·
DUT_UDLL_OTP_BDA_RD_INIT	OTP BD address read operation initialized.
DUT_UDLL_OTP_BDA_RD_STARTED	OTP BD address read operation started.
DUT_UDLL_OTP_BDA_RD_OK	OTP BD address read operation ended successfully.
DUT_UDLL_OTP_BDA_RD_FAILED	OTP BD address read operation failed.
DUT_UDLL_OTP_BDA_CMP_OK	OTP BD address comparison success.
DUT_UDLL_OTP_BDA_CMP_FAILED	OTP BD address comparison failed. No match.
Memory programming - XTAL trim value write to	
DUT_UDLL_OTP_XTAL_TRIM_WR_INIT	OTP XTAL trim value write operation initialized.
DUT_UDLL_OTP_XTAL_TRIM_WR_STARTED	OTP XTAL trim value write operation started.
DUT_UDLL_OTP_XTAL_TRIM_WR_OK	OTP XTAL trim value write operation ended successfully.
DUT_UDLL_OTP_XTAL_TRIM_WR_FAILED	OTP XTAL trim value write operation failed.
Memory programming - ADC calibration value	
DUT_UDLL_OTP_ADC_CALIB_WR_INIT	OTP ADC calibration value write operation initialized.
DUT_UDLL_OTP_ADC_CALIB_WR_STARTED	OTP ADC calibration value write operation started.
DUT_UDLL_OTP_ADC_CALIB_WR_OK	OTP ADC calibration value write operation ended successfully.
DUT_UDLL_OTP_ADC_CALIB_WR_FAILED	OTP ADC calibration value write operation failed.
Memory programming - OTP header write	
DUT_UDLL_OTP_HDR_WR_INIT	OTP header write operation initialized.
DUT_UDLL_OTP_HDR_WR_STARTED	OTP header write operation started.
DUT_UDLL_OTP_HDR_WR_OK	OTP header write operation ended successfully.
DUT_UDLL_OTP_HDR_WR_FAILED	OTP header write operation failed.
Memory programming - OTP memory check-em	·
DUT_UDLL_OTP_CHECK_EMPTY_INIT	Operation to check whether the OTP field to burn is empty initialized.
DUT_UDLL_OTP_CHECK_EMPTY_STARTED	Operation to check whether the OTP field to burn is empty started.
DUT_UDLL_OTP_CHECK_EMPTY_OK	The OTP field to burn is empty.
DUT_UDLL_OTP_CHECK_SAME_DATA_OK	The OTP field contains the same data as the ones to

User Manual



UM-B-041

DA1458x/DA1468x Production Line Tool

Status	Description
	burn.
DUT_UDLL_OTP_CHECK_EMPTY_FAILED	The OTP field is already burned with data.
Memory programming - SPI memory erase	· ·
DUT_UDLL_SPI_ERASE_INIT	SPI erase operation initialized.
DUT_UDLL_SPI_ERASE_STARTED	SPI erase operation started.
DUT_UDLL_SPI_ERASE_OK	SPI erase operation ended successfully.
DUT_UDLL_SPI_ERASE_FAILED	SPI erase operation failed.
Memory programming - SPI memory check emp	oty
DUT_UDLL_SPI_CHECK_EMPTY_INIT	SPI check if empty operation initialized.
DUT_UDLL_SPI_CHECK_EMPTY_STARTED	SPI check if empty operation started,
DUT_UDLL_SPI_CHECK_EMPTY_OK	SPI check if empty operation ended successfully,
DUT_UDLL_SPI_CHECK_EMPTY_FAILED	SPI check if empty operation failed,
Memory programming - SPI image write	
DUT_UDLL_SPI_IMG_WR_INIT	SPI image write operation initialized.
DUT_UDLL_SPI_IMG_WR_STARTED	SPI image write operation started.
DUT_UDLL_SPI_IMG_WR_OK	SPI image write operation ended successfully.
DUT_UDLL_SPI_IMG_WR_FAILED	SPI image write operation failed.
Memory programming - EEPROM image write	
DUT_UDLL_EEPROM_IMG_WR_INIT	EEPROM image write operation initialized.
DUT UDLL EEPROM IMG WR STARTED	EEPROM image write operation started.
DUT_UDLL_EEPROM_IMG_WR_OK	EEPROM image write operation ended successfully.
DUT_UDLL_EEPROM_IMG_WR_FAILED	EEPROM image write operation failed.
Memory programming - QSPI memory erase	
DUT UDLL QSPI ERASE INIT	QSPI erase operation initialized.
DUT UDLL QSPI ERASE STARTED	QSPI erase operation started.
DUT UDLL QSPI ERASE OK	QSPI erase operation ended successfully.
DUT_UDLL_QSPI_ERASE_FAILED	QSPI erase operation failed.
Memory programming - QSPI memory check en	
DUT UDLL QSPI CHECK EMPTY INIT	QSPI check if empty operation initialized.
DUT UDLL QSPI CHECK EMPTY STARTED	QSPI check if empty operation started.
DUT UDLL QSPI CHECK EMPTY OK	QSPI check if empty operation ended successfully.
DUT_UDLL_QSPI_CHECK_EMPTY_FAILED	QSPI check if empty operation failed.
Memory programming - QSPI image write	
DUT UDLL QSPI IMG WR INIT	QSPI image write operation initialized.
DUT UDLL QSPI IMG WR STARTED	QSPI image write operation started.
DUT UDLL QSPI IMG WR OK	QSPI image write operation started.
DUT UDLL QSPI IMG WR FAILED	QSPI image write operation failed.
Memory programming - BD address write to QS	
DUT UDLL QSPI BDA WR INIT	-
	QSPI BD address write operation initialized.

User Manual



Status	Description
DUT_UDLL_QSPI_BDA_WR_STARTED	QSPI BD address write operation started.
DUT_UDLL_QSPI_BDA_WR_OK	QSPI BD address write operation ended successfully.
DUT_UDLL_QSPI_BDA_WR_FAILED	QSPI BD address write operation failed.
Memory programming - BD address read/compare	to QSPI memory
DUT_UDLL_QSPI_BDA_RD_INIT	QSPI BD address read operation initialized.
DUT_UDLL_QSPI_BDA_RD_STARTED	QSPI BD address read operation started.
DUT_UDLL_QSPI_BDA_RD_OK	QSPI BD address read operation ended successfully.
DUT_UDLL_QSPI_BDA_RD_FAILED	QSPI BD address read operation failed.
DUT_UDLL_QSPI_BDA_CMP_OK	QSPI BD address comparison success.
DUT_UDLL_QSPI_BDA_CMP_FAILED	QSPI BD address comparison failed. No match.
Memory programming - XTAL trim value write to Q	SPI memory
DUT_UDLL_QSPI_XTAL_TRIM_WR_INIT	QSPI XTAL trim value write operation initialized.
DUT_UDLL_QSPI_XTAL_TRIM_WR_STARTED	QSPI XTAL trim value write operation started.
DUT_UDLL_QSPI_XTAL_TRIM_WR_OK	QSPI XTAL trim value write operation ended successfully.
DUT_UDLL_QSPI_XTAL_TRIM_WR_FAILED	QSPI XTAL trim value write operation failed.
Memory programming - ADC calibration value writ	e to QSPI memory
DUT_UDLL_QSPI_ADC_CALIB_WR_INIT	QSPI ADC calibration value write operation initialized.
DUT_UDLL_QSPI_ADC_CALIB_WR_STARTED	QSPI ADC calibration value write operation started.
DUT_UDLL_QSPI_ADC_CALIB_WR_OK	QSPI ADC calibration value write operation ended successfully.
DUT_UDLL_QSPI_ADC_CALIB_WR_FAILED	QSPI ADC calibration value write operation failed.
Memory programming - Custom data memory write	e
DUT_UDLL_MEM_DATA_WR_INIT	Custom memory data burn operation initialized.
DUT_UDLL_MEM_DATA_WR_STARTED	Custom memory data burn operation started.
DUT_UDLL_MEM_DATA_WR_OK	Custom memory data burn operation ended successfully.
DUT_UDLL_MEM_DATA_WR_FAILED	Custom memory data burn operation failed.
Memory programming - memory read operation	
DUT_UDLL_MEM_RD_INIT	Memory read operation initialized.
DUT_UDLL_MEM_RD_STARTED	Memory read operation started.
DUT_UDLL_MEM_RD_OK	Memory read operation ended successfully.

User Manual

Appendix S Golden Unit Status Codes

Table 102 contains all the possible status codes the Golden Unit can have, followed by a brief description. The table categorizes the status based on the various states the Golden Unit may be during testing and programming the DUTs.

Table 102: Golden Unit Status Codes

Status	Description
Generic	
GU_NOT_ACTIVE	Golden Unit is not active.
GU_INTERNAL_SYSTEM_ERROR	Internal system error.
GU_COM_OPEN_OK	COM port opened successfully.
GU_COM_OPEN_FAILED	COM port failed to open
GU_PDLL_NO_ERROR	PDLL returned success.
GU_PDLL_PARAMS_ERROR	Golden Unit PDLL parameters have errors.
GU_PDLL_RX_TIMEOUT	Golden Unit did not reply on a PDLL message request. GU COM port may not be correct or it may need manual RESET.
GU_PDLL_TX_TIMEOUT	Golden Unit Tx timeout when sending a message to the device.
GU_PDLL_UNEXPECTED_EVENT	Received an unexpected message from the Golden Unit.
GU_PDLL_CANNOT_ALLOCATE_MEMORY	PDLL cannot allocate memory.
GU_PDLL_INTERNAL_ERROR	PDLL internal system error.
GU_PDLL_THREAD_CREATION_ERROR	PDLL thread creation error.
GU_PDLL_DBG_DLL_ERROR	PDLL debug library (dbg_dll.dll) access error.
GU_PDLL_INVALID_DBG_PARAMS	PDLL invalid debug library (dbg_dll.dll) parameters.
GU_PDLL_HCI_STANDARD_ERROR	Golden Unit HCI error.
Golden Unit reset operation	· · · ·
GU_RESET_START	Golden Unit HW reset started.
GU_RESET_OK	Golden Unit HW reset OK.
GU_RESET_FAILED	Golden Unit HW reset FAILED.
Golden Unit COM port handling	· · · ·
GU_PDLL_COM_PORT_INIT	Golden Unit COM port open initialized.
GU_PDLL_COM_PORT_START	Golden Unit COM port open started.
GU_PDLL_COM_PORT_OK	Golden Unit COM port opened OK.
GU_PDLL_COM_PORT_FAILED	Golden Unit COM port FAILED.
Golden Unit firmware version	· · · ·
GU_PDLL_FW_VERSION_GET_START	Golden Unit PDLL firmware version acquisition started.
GU_PDLL_FW_VERSION_GET_OK	Golden Unit PDLL firmware version acquisition OK.
GU_PDLL_FW_VERSION_GET_FAILED	Golden Unit PDLL firmware version acquisition FAILED.
GU_PDLL_FW_VERSION_VALID	The Golden Unit firmware version is valid.
GU_PDLL_FW_VERSION_NOT_VALID	The Golden Unit firmware version is not valid. An upgrade may be needed.

User Manual

Status	Description
Golden Unit CPLD control	
GU_PDLL_RDTESTER_INIT	PLT HW tester initializing.
GU_PDLL_RDTESTER_INIT_START	PLT HW tester initialize started.
GU_PDLL_RDTESTER_INIT_OK	PLT HW tester initialized successful.
GU_PDLL_RDTESTER_INIT_FAILED	PLT HW tester initialization failed.
GU_PDLL_RDTESTER_UART_CONNECT_INIT	PLT HW tester UART connection initialized.
GU_PDLL_RDTESTER_UART_CONNECT_START	PLT HW tester UART connection started.
GU_PDLL_RDTESTER_UART_CONNECT_OK	PLT HW tester UART connected successfully.
GU_PDLL_RDTESTER_UART_CONNECT_FAILED	PLT HW tester UART connection failed.
GU_PDLL_RDTESTER_UART_LOOPBACK_INIT	PLT HW tester UART loopback process initialized.
GU_PDLL_RDTESTER_UART_LOOPBACK_START	PLT HW tester UART loopback process started.
GU_PDLL_RDTESTER_UART_LOOPBACK_OK	PLT HW tester UART loopback process success.
GU_PDLL_RDTESTER_UART_LOOPBACK_FAILED	PLT HW tester UART loopback process failed.
GU_PDLL_RDTESTER_VBAT_UART_CNTRL_INIT	PLT HW tester VBAT/UART control initialized.
GU_PDLL_RDTESTER_VBAT_UART_CNTRL_START	PLT HW tester VBAT/UART control started.
GU_PDLL_RDTESTER_VBAT_UART_CNTRL_OK	PLT HW tester VBAT/UART control success.
GU_PDLL_RDTESTER_VBAT_UART_CNTRL_FAILED	PLT HW tester VBAT/UART control failed.
GU_PDLL_RDTESTER_VPP_CNTRL_INIT	PLT HW tester VPP control initialized.
GU_PDLL_RDTESTER_VPP_CNTRL_START	PLT HW tester VPP control started.
GU_PDLL_RDTESTER_VPP_CNTRL_OK	PLT HW tester VPP control success.
GU_PDLL_RDTESTER_VPP_CNTRL_FAILED	PLT HW tester VPP control failed.
GU_PDLL_RDTESTER_RST_PULSE_INIT	PLT HW tester Reset pulse control initialized.
GU_PDLL_RDTESTER_RST_PULSE_START	PLT HW tester Reset pulse control started.
GU_PDLL_RDTESTER_RST_PULSE_OK	PLT HW tester Reset pulse control success.
GU_PDLL_RDTESTER_RST_PULSE_FAILED	PLT HW tester Reset pulse control failed.
GU_PDLL_RDTESTER_UART_PULSE_INIT	PLT HW tester XTAL trim pulse in UART TX pin initialized.
GU_PDLL_RDTESTER_UART_PULSE_START	PLT HW tester XTAL trim pulse in UART TX pin started.
GU_PDLL_RDTESTER_UART_PULSE_OK	PLT HW tester XTAL trim pulse in UART TX pin success.
GU_PDLL_RDTESTER_UART_PULSE_FAILED	PLT HW tester XTAL trim pulse in UART TX pin failed.
GU_PDLL_RDTESTER_XTAL_PULSE_INIT	PLT HW tester XTAL trim pulse in GATE pin initialized.
GU_PDLL_RDTESTER_XTAL_PULSE_START	PLT HW tester XTAL trim pulse in GATE pin started.
GU_PDLL_RDTESTER_XTAL_PULSE_OK	PLT HW tester XTAL trim pulse in GATE pin success.
GU_PDLL_RDTESTER_XTAL_PULSE_FAILED	PLT HW tester XTAL trim pulse in GATE pin failed.
GU_PDLL_RDTESTER_PULSE_WIDTH_INIT	PLT HW tester pulse width initialized.
GU_PDLL_RDTESTER_PULSE_WIDTH_START	PLT HW tester pulse width started.
GU_PDLL_RDTESTER_PULSE_WIDTH_OK	PLT HW tester pulse width success.
GU_PDLL_RDTESTER_PULSE_WIDTH_FAILED	PLT HW tester pulse width failed.
GU_PDLL_RDTESTER_VBAT_CNTRL_INIT	PLT HW tester VBAT control initialized.
GU_PDLL_RDTESTER_VBAT_CNTRL_START	PLT HW tester VBAT control started.

User Manual



Status	Description
GU_PDLL_RDTESTER_VBAT_CNTRL_OK	PLT HW tester VBAT control success.
GU_PDLL_RDTESTER_VBAT_CNTRL_FAILED	PLT HW tester VBAT control failed.
GU_PDLL_RDTESTER_INVALID_COMMAND	PLT HW tester unknown command.
Golden Unit RF packet transmission for DUT	RSSI RF test
GU_PDLL_PKT_TX_START_INIT	Golden Unit RF packet TX initialized.
GU_PDLL_PKT_TX_START	Golden Unit RF packet TX started.
GU_PDLL_PKT_TX_STARTED_OK	Golden Unit RF packet TX success.
GU_PDLL_PKT_TX_STARTED_FAILED	Golden Unit RF packet TX failed.
GU_PDLL_PKT_TX_ENDED_OK	Golden Unit RF packet TX ended successfully.
GU_PDLL_PKT_TX_STARTED_FAILED	Golden Unit RF packet TX ended failed.
Golden Unit audio tone generation for audio to	esting
GU_PDLL_AUDIO_TONE_START_INIT	Golden Unit audio tone start initialized.
GU_PDLL_AUDIO_TONE_START	Golden Unit audio tone start.
GU_PDLL_AUDIO_TONE_STARTED_OK	Golden Unit audio tone started successfully.
GU_PDLL_AUDIO_TONE_START_FAILED	Golden Unit audio tone start failed.
GU_PDLL_AUDIO_TONE_STOP_INIT	Golden Unit audio tone stop initialized.
GU_PDLL_AUDIO_TONE_STOP	Golden Unit audio tone stop.
GU_PDLL_AUDIO_TONE_STOPPED_OK	Golden Unit audio tone stopped successfully.
GU_PDLL_AUDIO_TONE_STOP_FAILED	Golden Unit audio tone stop failed.
Golden Unit GPIO toggling for sanity test	
GU_PDLL_GPIO_TOGGLE_INIT	Golden Unit GPIO toggle operation initialized.
GU_PDLL_GPIO_TOGGLE_START	Golden Unit GPIO toggle operation start.
GU_PDLL_GPIO_TOGGLE_FINISHED_OK	Golden Unit GPIO toggle operation completed successfully.
GU_PDLL_GPIO_TOGGLE_FAILED	Golden Unit GPIO toggle operation failed.
Golden Unit BLE advertising scan test	· ·
GU_PDLL_BLE_SCAN_INIT	Golden Unit scan operation initialized.
GU_PDLL_BLE_SCAN_START	Golden Unit scan operation started.
GU_PDLL_BLE_SCAN_OK	Golden Unit scan operation completed successfully.
GU_PDLL_BLE_SCAN_FAILED	Golden Unit scan operation failed.



Revision History

Revision	Date	Description
1.0	08-Jul-2015	Initial version.
1.1	18-Jan-2016	CLI part is added and Rev D. PLT Hardware
2.0	04-May-2016	Adding text and drawings
3.0	22-May-2016	Adding changes for the DA1468x
4.0	22-Dec-2016	Updated for DA1458x_DA1468x_PLT_v4.0 software release
4.1	06-Oct-2017	Updated for DA1458x_DA1468x_PLT_v4.1 software release
4.2	10-Oct-2017	Updated for DA1458x_DA1468x_PLT_v4.2 software release
4.3	03-Feb-2022	Updated logo, disclaimer, copyright.



Status Definitions

Status	Definition
DRAFT	The content of this document is under review and subject to formal approval, which may result in modifications or additions.
APPROVED or unmarked	The content of this document has been approved for publication.

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